



Serial ATA International Organization:
Serial ATA Interoperability Program Revision 1.3
Unified Test Document Version 1.1

15- October-2009

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Version History

Version	Date	Comments
1.00	06/12/2008	Initial Release to Public
1.0.95	12/18/2008	<ul style="list-style-type: none"> • GTR-01: Made consistent with ATA/6 correction e04127r0 • GTR-02: Made consistent with ATA/6 correction e04127r0 • GTR-03: Added range to be less than or equal to 128K • IPM-03: Partial and Slumber are required if supported • IPM-08: If any of the sequences fail, the result is fail • IPM-11: Partial and Slumber are required if supported; duplicated note from IPM-03 regarding MOI specific method to detect speed • SSP-06: Add both DMA modes are tested if supported • NCQ-02: Add pass/fail for Log Page 0 • Note added to PHY Section 2.16 • Update to MDI-01 to add uSATA tab test • MDI-01: Edited for consistency (note that device thickness was not added which keeps this section consistent for all form factors). • MDI-02: Edited for notational consistency • MDP-01: Edited for notational consistency • MHI-01: Edited for notational consistency
1.01RC1	01/05/2009	Second Release to Public
1.01RC2	09/02/2008	Editorial formatting changes to mechanical section
1.01RC3	09/10/2009	Fixed MDI-01 for 1.8" to match SATA Spec.
1.1	10/15/2009	Third Release To Public

Revision History

Rev 1.1

PHY/TSG/OOB

SATA 2.5 ECN 018 – Updated LBP

RX/TX

SATA 2.5 ECN 021 – Gen 1 Return Loss (RX-06 / TX-06) added

SATA 2.5 ECN 023 – Common mode return loss adjusted (RX-04 / TX-04 limits adjusted)

SATA 2.5 ECN 024 – NRZ/Idle state requirements (all RX / TX measurements adjusted)

System Interop – Added ATAPI drive support

Cable Mechanical – Insertion / removal and pull-out

PreTest - Added

Informative tests:

RSG and Host Digital

Rev 1.2

Product Electrical – RSG – 10/33/62 MHz – normative

Product Electrical – RX/TX – Removed 2ns option for RX-01 / TX-01

Device Digital –

Split Host and Digital IPM apart,

GTR-05 informative,

Added IPM 10 second time outs

Device Mechanical – Add Slimline

PreTest – Changed from 2 ALIGN to 4 ALIGN Framed COMP Pattern

Informative tests: Host Digital

Rev 1.3

Changed references from SATA 2.5 to 2.6

Product Electrical – PHY/TSG/OOB

SATA 2.6 ECN 008 – JTF Calibration impacted TSG-09 / -10 / -11 / -12

SATA 2.6 ECN 016 – Long Term Frequency stability & SSC – impacted PHY-02 / -04

SATA 2.6 ECN 017 – OOB – impacted OOB-02 / -03 / -04 / -05, -06 / -07

Product Electrical – RSG – Added 5 MHz Sj

SATA 2.6 ECN 009 – Framed COMP pattern use SATA 2.5 ECN 018 LBP pattern

Product Electrical – RX/TX – RX-02 / TX-02 obsolete

PreTest – Changed back to 2 ALIGN Framed COMP Pattern

Digital – Host – normative

Digital – Device – Documented minimum loop counts (IPM-03 / -04 / -11)

Informative tests:

- Cable - eSATA cable (electrical and mechanical)

- Product Mechanical - eSATA mechanical

- Digital - Port Multiplier

- Device Mechanical - uSATA

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1. Goals, Objectives, & Constraints

This document defines the test requirements specific to the SATA-IO Interoperability Program. Many of the test requirements are associated with a subset of requirements included in the Serial ATA (SATA) Revision 2.6 specification and these test requirements are based upon the requirements for the Serial ATA protocol and features, intended to verify a subset of the specification requirements and ensuring compatibility for Serial ATA. Not every feature or capability within the Serial ATA architecture may be included in the Integrator's List testing. The requirements are driven by the necessary capabilities of the specification that can be verified by functional testing. There are additional test requirements which are intended to verify general system interoperability which are not associated with any specification requirements.

Some of the goals and requirements for the Interoperability Program documentation include:

- Maintain adherence to Serial ATA specification(s) across all SATA products
- Maintain compatibility with older hosts & devices without compromising product adherence to the specification
- Deliver standard test requirements for Serial ATA products

1.1. References

This document is not a Serial ATA specification but includes requirements for testing adherence to a subset of the Serial ATA specification guidelines, in addition to system interoperability tests. This document makes reference to the following specifications and documents:

- Serial ATA Revision 2.6. Available for download at www.sata-io.org.
- AT Attachment with Packet Interface – 6 (ATA/ATAPI-6). Draft available at www.T13.org. Published ATA/ATAPI specifications available from ANSI at webstore.ansi.org or from Global Engineering.
- Serial ATA Interoperability Program Revision 1.3 Policy Document. Available for download at www.sata-io.org.
- Serial ATA Interoperability Program Revision 1.3 Description Document. Available for download at www.sata-io.org.

ECN #	Description	UTD Impact
001v0	Slimline Bump Correction	No impact
002v0	Latching Receptacle Bump Correction	No impact
003v1	State Name Corrections	No impact
004v2	Reserved SATA Log Page Numbers	No impact
006v1	Remove F(baud)/10 requirement	Impacted area already informative
008v1	Clarify JTF used for F(baud)/500 measurement	Included – Impacted TSG and RSG tests
009	LBP_COMP description	Included – Impacted RSG tests and System Interop
010v0	IPM Resume Speed	Already included
011v5	Valid data and CRC requirements	No impact
012v0	Correct bump tolerance overlap	No impact
013v2	Editorial correction, IDENTIFY PACKET DEVICE table.	No impact
014v0	PACKETstatenames	No impact
016	LongTermFreqAccuracy_and_SSC_Tests	Included – Impacted tests PHY-02 and PHY-04
017	OOB Burst/Gap Measurement	Included – added clarification to OOB section
018v0	Correct Slimline power connector dimensions	No impact

021	Correct internal height dimension for eSATA plug	Included in MXE-01a
022v1	Remove references to "KB"	No impact

1.1.1. Definitions

1.1.1.1. Product

General reference to any SATA product supportable by the Interop Program for testing.

1.1.1.2. Device

A product falling under the Device product class which is a storage peripheral. This includes hard disk drives, half-height, and slimline ATAPI devices.

1.1.1.3. Frame Information Structure (FIS)

The user payload of a frame, does not include the SOF, CRC, and EOF delimiters.

1.1.1.4. Frame

A frame is an indivisible unit of information exchanged between a host and device. A frame consists of a SOF primitive, a Frame Information Structure, a CRC calculated over the contents of the FIS, and an EOF primitive.

1.1.1.5. Framed Long COMP Pattern

The pattern utilized in the Receiver Tolerance testing outlined in section 2.16 will be constructed of the Long COMP contained within a valid frame including CRC calculated to the COMP itself. The Long COMP is defined in SATA 2.6 - ECN-09 which updated the Framed COMP Pattern with the redefined LBP with SATA 2.5 ECN #18.

1.1.1.6. Host

A Host or Host Bus Adapter (HBA) is a product that connects to the host system's expansion bus to provide connectivity for devices. Host Bus Adapters are also often referred to as controller cards or merely controllers

1.1.1.7. Lone Bit Pattern (LBP)

The Lone Bit Pattern (LBP) used for Interoperability Testing is that which is defined in SATA 2.6, which was previously updated by SATA Revision 2.5 - ECN 018.

1.1.2. Conventions

Lowercase is used for words having the normal English meaning. Certain words and terms used in this document have a specific meaning beyond the normal English meaning. These words and terms are defined either in clause 1.2.2.1 or in the text where they first appear.

The names of abbreviations, commands, fields, and acronyms used as signal names are in all uppercase (e.g., IDENTIFY DEVICE). Fields containing only one bit are usually referred to as the "name" bit instead of the "name" field.

Names of device registers begin with a capital letter (e.g., Cylinder Low register).

1.1.2.1. Keywords

Several keywords are used to differentiate between different levels of requirements and optionality.

1.1.2.1.1. informative

A test, test area, or product type which is currently optional and should become normative at a future time.

1.1.2.1.2. mandatory

A keyword indicating items to be implemented as defined by this document.

1.1.2.1.3. may

A keyword that indicates flexibility of choice with no implied preference.

1.1.2.1.4. normative

A test or test area which is required to an applicable product type. Unless otherwise stated, all tests, test areas are required for the applicable product types.

Only normative product types that have passed all the normative tests can be placed on the integrators list. Informative or obsolete test results shall have no bearing on a products approval status.

1.1.2.1.5. optional

A keyword that describes test requirements that are not required by this document. However, if any optional compliance point defined by the document is implemented, the feature shall be implemented in the way defined by the Serial ATA standard.

1.1.2.1.6. obsolete

A test or test area which is no longer valid and shall not become normative in the future and is left in for historical documentation purposes only

1.1.2.1.7. shall

A keyword indicating a mandatory requirement. Designers are required to implement all such mandatory requirements to ensure interoperability with other Serial ATA standard conformant products.

1.1.2.1.8. should

A keyword indicating flexibility of choice with a strongly preferred alternative. Equivalent to the phrase "it is recommended".

1.2. Product Classes

Due to the difference in architecture and design of Serial ATA products, the test requirements will be distinguishable between the following types of products:

- Device : hard disk drive, half-height ATAPI device, slimline ATAPI device, or eSATA device
- Cable (Standard internal or eSATA)
- Host : HBA, chipset, add-in controller, or eSATA
- Port Multiplier (internal or eSATA)

Each test associated with a specification requirement may have separately defined Expected Behavior for each of the above product classes. In each case, there may be different methodology for both testing the test requirement and determining the pass/fail criteria. Each test requirement will include the following: Expected Behavior, Measurement Requirements, and Pass/Fail Criteria. The general definition of these subjects is below.

1.2.1. Expected Behavior

All of the test requirements have expected behavior as defined in Serial ATA Revision 2.6. All of the expected behavior for each test requirement directly shall refer to the appropriate Serial ATA specification requirement(s) being tested.

1.2.2. Measurement Requirements

Each test requirement contains detailed information necessary for developing tests for verification of the referenced Serial ATA requirement. This information could include types of equipment, testing methodologies, test setup routines, and other helpful information.

1.2.3. Pass/Fail Criteria

The Pass/Fail criteria defined will be clear and concise, and include specific information necessary to determine passing or failing of a test. Actual results gathered during testing must be documented in addition to determination of pass vs. fail for a test.

1.3. Methods of Implementation

A Method of Implementation (MOI) is defined as documentation specifying test tool details and procedures for the specific use of verifying the different Interoperability test areas. In the future a template for development of a MOI for a specific test tool may be developed, but at this time a MOI, at a minimum, must simply include the following:

- Hardware equipment model number(s)
- Software revision number(s)
- Hardware dependencies (e.g. test fixtures)
- Product dependencies (e.g. BIST modes, patterns)
- Detailed procedures for using the equipment to verify the specific Interop test requirements
- Procedures for extraction of results
- Approximate execution time of specific Interop test requirements

There are different MOI classes which are specific to the different test areas included in this Unified Test Document. Any test tool approved for use in Interoperability Testing must fall under test execution within one of the following MOI classes:

- Digital/protocol (device/host or port multiplier only)
- Phy electrical (device/host only)
- Phy TX/RX requirements (device/host only)
- RSG requirements (device/host or eSATA only)
- Receiver Jitter Tolerance (device/host only)
- Mechanical (device/host or eSATA only)
- Cable mechanical (internal or eSATA cable only)
- Cable electrical (internal or eSATA cable only)
- System interoperability (device/host only)

It is feasible that separate MOIs are developed for each type of equipment used depending on the class of testing, or that a single MOI is used to cover an entire test class including the details for several pieces of test tool equipment. This will be determined by the appropriate test tool vendors with considerations from the SATA-IO.

1.4. Test Product Considerations

1.4.1. Common Host/Device/Port Multiplier BIST Considerations

For many of the Phy electrical tests, it is required that a product (Host/Device/Port Multiplier and eSATA versions of these) is able to transmit and/or loop back patterns which are identified within the SATA 2.6 specification or this document. There are standard ways of doing this through the BIST protocol per definition within the specification. If a product does not specifically support either BIST T, A, S, and/or BIST L capabilities then the vendor needs to bring all equipment to support vendor unique methods for completely emulating BIST “T,A,S” and BIST “L”. Note that this vendor unique process can have no substantial impact to the test during interoperability testing (e.g. significant growth in test execution time or complexity of equipment calibration/setup).

1.4.2. Device specific considerations

A device vendor is required to supply at least three samples. In some cases up to two samples will be run through testing in parallel at a given time. The third sample could be available for backup in case of unexpected errors or failures.

1.4.3. Cable Considerations

If a cable assembly product family consists of cables which differ only in their length (the connector design, cable construction, and assembly method is identical) and if the shortest and longest lengths pass the test requirements then all intermediate lengths are considered to be passing.

A cable vendor is required to supply at least two identical samples of each length tested.

1.4.4. Host Considerations

A host vendor is required to supply at least two samples. In some cases up to two samples will be run through testing in parallel at a given time. In most cases, the second or third sample shall not be secured within a chassis or platform case, as this sample may be used specifically for mechanical testing.

Prior to execution of any testing on a host, a “worst port” must be identified. The intent of identifying a worst port is not to validate each port to the specification, but to simply identify the worst port based on a single relative measurement across all ports within a host. The Interoperability Tests shall then, at a minimum, be executed on the worst port identified per the procedure below.

- Power-on host and ensure test ports are enabled & functional. Run the following on each individual port.
 - Connect device and complete OOB sequence
 - Execute and record results for the typical Total Jitter (TJ) measurement using LBP while the host is in NRZ idle following OOB
- The “worse port” is identified as that which has the highest TJ value recorded on the measurement above

Relative to the Interface Power Management tests (see section 2.5), it is expected that the host product manufacturer supply a facility (software, or hardware automation) which will initiate power management state requests in order to support host-initiated test execution – this is only required if the host product claims support for the host-initiated power management capability.

1.4.5. Port Multiplier Considerations

A port multiplier vendor is required to supply at least two samples. In some cases up to two samples will be run through testing at a given time. In most cases, the second or third sample shall not be secured within a chassis or platform case, as this sample may be used specifically for mechanical testing.

Prior to execution of any testing on a port multiplier, a “worst port” must be identified. The intent of identifying a worst port is not to validate each port to the specification, but to simply identify the worst port based on a single relative measurement across all ports within a port multiplier. The Interoperability Tests shall, at a minimum, then be executed on the worst port identified per the procedure below.

- Power-on port multiplier and ensure test ports are enabled & functional. Run the following on each individual port.
 - If it is a device port, connect a device and complete OOB sequence
 - If it is a host port, connect a host and complete OOB sequence
 - Execute and record results for the typical Total Jitter (TJ) measurement using LBP while the host is in NRZ idle following OOB
- The “worse port” is identified as that which has the highest TJ value recorded on the measurement above

Relative to the Interface Power Management tests (see section 2.18), it is expected that the host product manufacturer supply a facility (software, or hardware automation) which will initiate power management state requests in order to support host-initiated test execution – this is only required if the host product claims support for the host-initiated power management capability.

2. Interoperability Specification Test Summary

Table 1 outlines the test requirements for the different types of Serial ATA units under test.

Table 1 - Test Requirements by Product Class

Test GRP	Sec #	Test Req.	Area	Device/ uSATA HDD	Device ATAPI	Internal Cable Signal	Internal Cable Power	Host	Port Multiplier *	eSATA Cable*	eSATA host/device*
GTR	0	GTR-01	Digital	M	M	--	--	--	M	--	/
		GTR-02	Digital	F	F	--	--	--	F	--	/
		GTR-03	Digital	M	M	--	--	--	M	--	/
		GTR-04	Digital	M	M	--	--	--	M	--	/
		GTR-05	Digital	*	*	--	--	--	*	--	/

Test GRP	Sec #	Test Req.	Area	Device/ uSATA HDD	Device ATAPI	Internal Cable Signal	Internal Cable Power	Host	Port Multiplier *	eSATA Cable*	eSATA host/ device*
NCQ	2.2	NCQ-01	Digital	F	--	--	--	--	F	--	/
		NCQ-02	Digital	F	--	--	--	--	F	--	/
		NCQ-03	Digital	F	--	--	--	--	F	--	/
		NCQ-04	Digital	F	--	--	--	--	F	--	/
		NCQ-05	Digital	F	--	--	--	--	F	--	/
ASR	2.3	ASR-01	Digital	M	M	--	--	--	M	--	/
		ASR-02	Digital	F	F	--	--	--	F	--	/
		ASR-03	Digital	--	--	--	--	F	--	--	F/--
SSP	2.4	SSP-01	Digital	F	--	--	--	--	F	--	/
		SSP-02	Digital	F	--	--	--	--	F	--	/
		SSP-03	Digital	F	F	--	--	--	F	--	/
		SSP-04	Digital	F	--	--	--	--	F	--	/
		SSP-05	Digital	F	F	--	--	--	F	--	/
		SSP-06	Digital	F	F	--	--	--	F	--	/
		SSP-07	Digital	F	--	--	--	--	F	--	/
		SSP-08	Digital	F	F	--	--	--	F	--	/
		SSP-09	Digital	F	F	--	--	--	F	--	/
		SSP-10	Digital	F	F	--	--	--	F	--	/
		SSP-11	Digital	F	--	--	--	--	F	--	/
IPM	2.5	IPM-01	Digital	F	F	--	--	F	--	--	/
		IPM-02	Digital	F	F	--	--	F	--	--	/
		IPM-03	Digital	F	F	--	--	F	--	--	/
		IPM-04	Digital	F	F	--	--	F	--	--	/
		IPM-05	Digital	F	F	--	--	F	--	--	/
		IPM-06	Digital	F	F	--	--	F	--	--	/
		IPM-07	Digital	F	F	--	--	--	--	--	/
		IPM-08	Digital	F	F	--	--	--	--	--	/
		IPM-09	Digital	F	F	--	--	F	--	--	/
		IPM-10	Digital	F	F	--	--	F	--	--	/
		IPM-11	Digital	F	F	--	--	F	--	--	/
MCI	2.6	MCI-01	Cable	--	--	M	--	--	--	--	--
		MCI-02	Cable	--	--	M	--	--	--	--	--
		MCI-03	Cable	--	--	F	--	--	--	--	--
		MCI-04	Cable	--	--	F	--	--	--	--	--
MCX		MCX-05	Cable	--	--	M	--	--	--		--
MCE		MCE-01	Cable	--	--	--	--	--	--	M	--
SI	2.6.6	SI-01	Cable	--	--	M	--	--	--		--
		SI-02	Cable	--	--	M	--	--	--		--
		SI-03	Cable	--	--	M	--	--	--		--
		SI-04	Cable	--	--	M	--	--	--		--
		SI-05	Cable	--	--	M	--	--	--		--
		SI-06	Cable	--	--	M	--	--	--		--
		SI-07	Cable	--	--	M	--	--	--		--
		SI-08	Cable	--	--	M	--	--	--		--
		SI-09	Cable	--	--	M	--	--	--		--
MDI	2.8	MDI-01	Mech	M	M	--	--	--	--	--	--
		MDI-02	Mech	M	M	--	--	--	--	--	--
MDP	2.9	MDP-01	Mech	M	M	--	--	--	--	--	--
MHI	2.10	MHI-01	Mech	--	--	--	--	*	--	--	--/*
MXE *	2.11.1	MXE-01	Mech	--	--	--	--	--	--	--	M/M
PHY	2.12	PHY-01	Phy	M	M	--	--	M	F	--	/
		PHY-02	Phy	M	M	--	--	M	F	--	/
		PHY-03	Phy	F	F	--	--	F	F	--	/
		PHY-04	Phy	F	F	--	--	F	F	--	/

Test GRP	Sec #	Test Req.	Area	Device/ uSATA HDD	Device ATAPI	Internal Cable Signal	Internal Cable Power	Host	Port Multiplier *	eSATA Cable*	eSATA host/ device*
TX	2.13	TX-01	RX/TX	M	M	--	--	M	M	--	I
		TX-02	RX/TX	*	*	--	--	*	*	--	I
		TX-03	RX/TX	F	F	--	--	F	F-n	--	I-n
		TX-04	RX/TX	F	F	--	--	F	F	--	I
		TX-05	RX/TX	F	F	--	--	F	F-n	--	I-n
		TX-06	RX/TX	M	M	--	--	M	M	--	I
TSG	2.14	TSG-01	RX/TX	M	M	--	--	M	M	--	I
		TSG-02	Phy	M	M	--	--	M	M	--	I
		TSG-03	Phy	M	M	--	--	M	M	--	I
		TSG-04	Phy	F	F	--	--	F	F	--	I
		TSG-05	Phy	F	F	--	--	F	F	--	I
		TSG-06	Phy	F	F	--	--	F	F	--	I
		TSG-07	Phy	*	*	--	--	*	*	--	I
		TSG-08	Phy	*	*	--	--	*	*	--	I
		TSG-09	Phy	M	M	--	--	M	M	--	I
		TSG-10	Phy	M	M	--	--	M	M	--	I
		TSG-11	Phy	F	F	--	--	F	M	--	I
		TSG-12	Phy	F	F	--	--	F	M	--	I
RX	2.15	RX-01	RX/TX	M	M	--	--	M	M	--	I
		RX-02	RX/TX	*	*	--	--	*	*	--	I
		RX-03	RX/TX	F	F	--	--	F	F-n	--	I-n
		RX-04	RX/TX	F	F	--	--	F	F	--	I
		RX-05	RX/TX	F	F	--	--	F	F-n	--	I-n
		RX-06	RX/TX	M	M	--	--	M	M	--	I
RSG	2.16	RSG-01	RSG	M	M	--	--	M	M-n	--	I-n
		RSG-02	RSG	M	M	--	--	M	M-n	--	I-n
OOB	2.17	OOB-01	Phy	M	M	--	--	M		--	I
		OOB-02	Phy	M	M	--	--	M	M	--	I
		OOB-03	Phy	M	M	--	--	M	M	--	I
		OOB-04	Phy	M	M	--	--	M	M	--	I
		OOB-05	Phy	M	M	--	--	M	M	--	I
		OOB-06	Phy	M	M	--	--	M	M	--	I
		OOB-07	Phy	M	M	--	--	M	M	--	I
PM	2.18	PM-01	PM	--	--	--	--	--	M	--	F/F
		PM-02	PM	--	--	--	--	--	M	--	F/F
		PM-03	PM	--	--	--	--	--	M	--	F/F
		PM-04	PM	--	--	--	--	--	M	--	F/F
		PM-05	PM	--	--	--	--	--	M	--	F/F
		PM-06	PM	--	--	--	--	--	M	--	F/F
		PM-07	PM	--	--	--	--	--	M	--	F/F
		PM-08	PM	--	--	--	--	--	M	--	F/F
		PM-09	PM	--	--	--	--	--	M	--	F/F
		PM-10	PM	--	--	--	--	--	M	--	F/F
		PM-11	PM	--	--	--	--	--	M	--	F/F
		PM-12	PM	--	--	--	--	--	M	--	F/F
SYS	3.2.2	SYS-01	Sys Introp	M	M	--	--	--	M	F/F	M
SYT	3.3	SYT-01	SI Tool	F	F			--	M	F/F	F
		SYT-02	SI Tool	F	F			--	M	F/F	F
		SYT-03	SI Tool	F	F			--	M	F/F	F
		SYT-04	SI Tool	F	F			--	M	F/F	F

Test GRP	Sec #	Test Req.	Area	Device/ uSATA HDD	Device ATAPI	Internal Cable Signal	Internal Cable Power	Host	Port Multiplier *	eSATA Cable*	eSATA host/device*
		SYT-05	SI Tool	F	F			--	M	F/F	F
		SYT-06	SI Tool	F	F			--	M	F/F	F
		SYT-07	SI Tool	F	F			--	M	F/F	F
		SYT-08	SI Tool	F	F			--	M	F/F	F
		SYT-09	SI Tool	F	F			--	M	F/F	F
		SYT-10	SI Tool	F	F			--	M	F/F	F

Key:

M – Test or test area is mandatory for listed product type

F – Test or test area is feature dependent for list product type

-- – Test or test area is not valid for listed product type

* -- Test or test area is currently documented as informative

l – This denotes that this column has the same test as the corresponding internal column(s) to the left (host/device)

-n This is a suffix that denotes the test has changes from other columns (external changes to internal tests)

2.1. General Test Requirements

All Serial ATA products under test shall meet the test requirements listed within this section (where applicable) to confirm Serial ATA interoperability relevant to the specified Expected Behavior.

2.1.1. GTR-01 – Software Reset

2.1.1.1. Device Expected Behavior

See section 11.3 of Serial ATA Revision 2.6.

Once the initial Register device-to-host FIS has been received and successfully acknowledged with no errors, a Device shall successfully respond to the setting of the SRST bit in the Device Control register at any time and perform the software reset protocol.

Measurement Requirements

- Repeat the following 5 times
 - Issue SRST to device when no command is outstanding

Pass/Fail Criteria

- Verify Register FIS receipt (after reset sequence) from device with the appropriate signature contents in **Sector Count, LBA Low, LBA Mid and LBA High registers.** (see ATA/6 reference and correction e04127r0) within an allotted 31 second timeframe (these results shall be verified for all test instances)

2.1.2. GTR-02 -- 3Gb/s Backwards Compatibility

2.1.2.1. Device Expected Behavior

See section 7.4.21.1.2 of Serial ATA Revision 2.6.

If a device claims support for Serial ATA Gen-2 signaling speed (Word 76 bit 2 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), then it shall also support Serial ATA Gen-1 signaling speed (Word 76 bit 1 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

In addition to verifying the IDENTIFY DEVICE or IDENTIFY PACKET DEVICE contents, support shall be verified by ensuring compatibility and interoperability with both a Gen-1 host and Gen-2 host. Details on how this testing is done is not specified in this document.

Measurement Requirements

- Check Word 76 bit 2 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data (set to one)
- If the above are true, then run the following test when connected to a 3Gb/s host and 1.5Gb/s host
 - Check Word 76 bit 1 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data (set to one)
 - Complete OOB sequence at least 10 times

Pass/Fail Criteria

- Values below shall be confirmed when tested in connection with both 3Gb/s host and 1.5Gb/s host
 - Verify IDENTIFY DEVICE or IDENTIFY PACKET DEVICE contents including:
 - If Word 76 bit 2 set to one, then Word 76 bit 1 set to one
 - Verify Register FIS receipt (after each OOB sequence) from device with the appropriate signature contents in Sector Count, LBA Low, LBA Mid and LBA High registers. (see ATA/6 reference and correction e04127r0)

2.1.3. GTR-03 – DMA Protocol Support

2.1.3.1. Device Expected Behavior

See sections 13.2.1 and 13.2.2 of Serial ATA Revision 2.6.

DMA support can be verified through Word 49 bit 8 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data. This bit shall be set to one for all Serial ATA devices.

The type of DMA supported can be verified through the IDENTIFY DEVICE or IDENTIFY PACKET DEVICE command data: Word 63, bits 2:0 for Multiword DMA (MWDMA) and Word 88 bits 6:0 for Ultra DMA (UDMA). If both types of DMA are supported, the UDMA type shall be selected. If only one type of DMA is supported, then the supported type shall be selected. The highest supported transfer rate of the selected DMA type shall be selected.

Measurement Requirements

- Check Word 49 bit 8 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data (set to one)
- If the above are true, then run the appropriate tests below

For consistency, it is required that the COMP pattern as defined in the specification is used as the data set for the tests below. Note that in some cases dependent on transfer size that it may not be feasible to include complete iterations of the COMP pattern within the data set being used.

There are several test scenarios that are required when testing a HDD for this test requirement, all of which shall be tested 5 times each to verify passing of the test:

- Issue IDENTIFY DEVICE to device
- Issue and complete WRITE DMA command to device with transfer size of less than or equal to 8Kbytes, followed by issue and completion of READ DMA command to device to the same disk location that the previous write was completed. The test shall verify that the contents read have the same values that were previously written.
- Issue and complete WRITE DMA command to device with transfer size of greater than 8Kbytes but less than or equal to 128Kbytes, followed by issue and completion of READ DMA command to device to the same disk location that the previous write was completed. The test shall verify that the contents read have the same values that were written initially.

There are several test scenarios that are required when testing an ATAPI read-only device for this test requirement, all of which shall be tested 5 times each to verify passing of the test. The tests below are for ATAPI devices which only support reading from media (e.g. CDROM, DVDROM, etc...).

- Issue IDENTIFY PACKET DEVICE to device
- Issue and complete one tracks worth of read commands using the DMA protocol with transfer size of less than or equal to 8Kbytes, followed by issue and completion of another tracks worth of read commands using the DMA protocol to the same disk location that the previous reads were completed. The test shall verify that the contents read have the same values that were read initially.

- Issue and complete one tracks worth of read commands using the DMA protocol with transfer size of greater than 8Kbytes but less than or equal to 128Kbytes, followed by issue and completion of another tracks worth of read commands using the DMA protocol to the same disk location that the previous reads were completed. The test shall verify that the contents read have the same values that were read initially.

There are several test scenarios that are required when testing an ATAPI device for this test requirement, all of which shall be tested 5 times each to verify passing of the test. The tests below are for ATAPI devices which support writing to media.

- Issue IDENTIFY PACKET DEVICE to device
- Issue and complete one tracks worth of write commands using the DMA protocol with transfer size of less than or equal to 8Kbytes, followed by issue and completion of one tracks worth of read commands using the DMA protocol to the same disk locations where the previous writes were completed. The test shall verify that the contents read have the same values that were previously written.
- Issue and complete one tracks worth of write commands using the DMA protocol with transfer size of greater than 8Kbytes but less than or equal to 128Kbytes, followed by issue and completion of one tracks worth of read commands using the DMA protocol to the same disk locations where the previous writes were completed. The test shall verify that the contents read have the same values that were previously written.

Pass/Fail Criteria

- Verify Word 49 bit 8 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE
- Verify that data read is equal to data initially written (or read in case of ATAPI read-only device)
- If neither MWDMA or UDMA type is supported, then the result is fail

2.1.4. GTR-04 – General SATA Support

2.1.4.1. Device Expected Behavior

See sections 13.2.1 and 13.2.2 of Serial ATA Revision 2.6.

For all Serial ATA devices, the entire contents of Word 93 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data shall be cleared to zero.

For all Serial ATA devices, support for the 1.5Gb/s interface rate is required. This can be verified through Word 76 bit 1 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data. This bit shall be set to one for all Serial ATA devices.

Measurement Requirements

- Issue IDENTIFY DEVICE or IDENTIFY PACKET DEVICE to device

Pass/Fail Criteria

- Verify Word 93 is cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE
- Verify Word 76 bit 1 is set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE

2.1.5. GTR-05 : Unrecognized FIS receipt (Informative)

2.1.5.1. Device Expected Behavior

See section 10.3.1.1 of Serial ATA Revision 2.6.

The receiver of an “unrecognized FIS” shall follow the link layer state machine definitions in section 9.6 of the Serial ATA Revision 2.6 specification upon receipt of an “unrecognized FIS”. The expected response is status return with an R_ERR.

Note that determination of any FIS being ‘unrecognized’ is done by the recipient of the FIS. The contents of the “Unrecognized FIS” are not defined by this document, but shall be described in each applicable MOI.

Measurement Requirements

- Transmit undefined FIS to device

Pass/Fail Criteria

- Verify R_ERR response from device

2.2. Native Command Queuing

The Native Command Queuing (NCQ) test requirements are determined by the requirements of the feature as defined in Serial ATA Revision 2.6.

All of the test requirements listed in this section require that support for NCQ is claimed by the product for verification of the Expected Behavior. Support for NCQ can be verified by reading Word 76 bit 8 set to one in IDENTIFY DEVICE data.

2.2.1. NCQ-01 : Forced Unit Access

2.2.1.1. Device Expected Behavior

See sections 11.14 and 13.5.4 of Serial ATA Revision 2.6.

Devices that support the NCQ commands (READ FPDMA QUEUED and WRITE FPDMA QUEUED) shall support the Force Unit Access (FUA) bit.

For WRITE FPDMA QUEUED when the FUA bit is set to one, the data shall be written to the storage media before completing the command. Due to the limitations in testability of specific device functions, this test will be limited to verifying the compatibility of a device in receiving a command with the FUA bit set to one. This test will not completely verify whether data was written to non-volatile media.

Measurement Requirements

- Check Word 76 bit 8 in IDENTIFY DEVICE (set to one)
- If the above is true, then run the following test
 - Issue and complete WRITE FPDMA QUEUED with FUA bit set.
 - Issue and complete READ FPDMA QUEUED to the same disk location.

Pass/Fail Criteria

- Verify that data read is equal to data written.

2.2.2. NCQ-02 : Read Log Ext log page 10h support

2.2.2.1. Device Expected Behavior

See section 13.5.3.3.1 of Serial ATA Revision 2.6.

If a device claims support for Native Command Queuing (Word 76 bit 8 set to one in IDENTIFY DEVICE data), then it shall also support READ LOG EXT log page 10h and the General Purpose Logging feature set. Support for READ LOG EXT log page 10h is reflected in the General Purpose Log Directory page (log page 0) by having the value 1 at offset 20h and the value 0 at offset 21h of that log page to indicate existence of a log page at address 10h of 1-page in length.

A READ LOG EXT log page 10h command shall be issued and completed without error. No contents shall be validated.

Measurement Requirements

- Check Word 76 bit 8 in IDENTIFY DEVICE (set to one)
- Check Word 87 bit 5 in IDENTIFY DEVICE (set to one)
- If the above is true, then run the following test
 - Issue READ LOG EXT to log page 00h

- Issue READ LOG EXT to log page 10h

Pass/Fail Criteria

- [Verify successful completion & data transfer for log page 0h](#)
- Verify offset 20h of log page 00h contains value of 1
- Verify offset 21h of log page 00h contains value of 0
- Verify successful completion & data transfer for log page 10h, it is NOT necessary that the contents of the log page are verified for specific values

2.2.3. NCQ-03 : Intermix of Legacy and NCQ commands

2.2.3.1. Device Expected Behavior

See section 13.5.2 of Serial ATA Revision 2.6.

Upon receiving a legacy ATA command while a native queued command is outstanding, an error has occurred and the device shall perform necessary state cleanup to return to a state with no commands pending. Legacy ATA commands include all commands other than the READ FPDMA QUEUED and WRITE FPDMA QUEUED commands.

The device shall signal the error condition to the host by transmitting a Register FIS to the host with the ERR bit set to one and the BSY bit cleared to zero in the Status field, and the ABRT bit set to one in the Error field. Upon detecting an error when there are one or more NCQ commands outstanding, the device shall stop processing commands until a READ LOG EXT command with a specified log page of 10h or reset is issued. Upon receipt of the READ LOG EXT command, the device shall send a Set Device Bits FIS to discard all commands in the pending device queue, followed by data for the log page. The READ LOG EXT page shall reflect that the error condition was a result of a legacy ATA command having been issued by having the NQ bit set to one. The device shall not continue command processing for any of the outstanding commands following this error.

If no prior NCQ error has occurred and a device has received a READ LOG EXT command while there are NCQ commands outstanding, the device shall respond as described above as having received a legacy ATA command while one or more native queued commands are outstanding.

Measurement Requirements

- Check Word 76 bit 8 in IDENTIFY DEVICE (set to one)
- If the above is true, then run the following test
 - Check Word 75 bits 4:0 to verify maximum queue depth reported by device
 - Issue at least X random FPDMA QUEUED commands (read or write), where X is the maximum queue depth reported above
 - Issue a legacy ATA command using one of the following (NOTE that the test shall be run a total of three times to ensure each legacy ATA command listed below is used for the test):
 - IDENTIFY DEVICE
 - PIO write
 - DMA read
 - Verify Register FIS receipt with ERR bit set to 1, DRDY bit set to 1, DF bit cleared to 0, BSY bit cleared to zero and DRQ bit cleared to 0
 - Issue Read Log Ext to log page 10h

Pass/Fail Criteria

- Verify receipt of Register FIS with error
- Verify SDB receipt with ERR bit cleared to zero, DRDY set to 1, DF bit cleared to zero, BSY bit cleared to zero, DRQ bit cleared to zero, the 'I' bit cleared to zero, and the SActive field set to FFFFFFFFh.
- Verify that the NQ bit is set to one in the data within log page 10h
- NOTE – there is opportunity for a device to complete all outstanding commands prior to the host being able to send the legacy ATA command. In these cases, the device may not be failed for this particular test.

2.2.4. NCQ-04 : Device response to malformed NCQ command

2.2.4.1. Device Expected Behavior

See section 13.5.2.and 13.5.4.1 of Serial ATA Revision 2.6.

Malformed commands could include the following situations:

- Specified LBA is out of the device supported range
- Duplicate tag value for outstanding NCQ command
- TAG value is out of the device supported range, only in the case that the device reports support for less than 32 outstanding commands

In response to a malformed READ FPDMA QUEUED or WRITE FPDMA QUEUED command due to a duplicate tag or out of range tag, the device shall transmit a Register FIS to the host with the ERR bit set to one, and the BSY bit cleared to zero in the Status register. The 'I' bit shall be set to one. The ABRT bit shall be set in the Error field. The device shall stop processing commands until a READ LOG EXT command with a specified log page of 10h or reset is issued. Upon receipt of the READ LOG EXT command, the device shall send a Set Device Bits FIS to discard all commands in the pending device queue, followed by data for the log page. The READ LOG EXT page shall have the NQ bit cleared to zero. The TAG field within the log page shall contain the tag associated with the NCQ command which failed.

In response to a malformed READ FPDMA QUEUED or WRITE FPDMA QUEUED command due to an LBA out of range, the device may report the error in one of two ways:

- Transmit a Register FIS to the host with the ERR bit set to one, and the BSY bit cleared to zero in the Status register. The 'I' bit shall be set to one. Either the ABRT bit or IDNF bit shall be set to one in the Error field. The device shall stop processing commands until a READ LOG EXT command with a specified log page of 10h or reset is issued. Upon receipt of the READ LOG EXT command, the device shall send a Set Device Bits FIS to discard all commands in the pending device queue, followed by data for the log page. The READ LOG EXT page shall have the NQ bit cleared to zero. The TAG field within the log page shall contain the tag associated with the NCQ command which failed.
- If the device accepts the command, then the device shall report the error within a subsequent Set Device Bits FIS. A Set Device Bits FIS shall be transferred with the ERR bit set to one, and the BSY bit cleared to zero in the Status register. The 'I' bit shall set to one. Either the ABRT bit or IDNF bit shall be set to one in the Error field. The device shall stop processing commands until a READ LOG EXT command with a specified log page of 10h or reset is issued. Upon receipt of the READ LOG EXT command, the device shall send a Set Device Bits FIS to discard all commands in the pending device queue, followed by data for the log page. The READ LOG EXT page shall have the NQ bit cleared to zero. The TAG field within the log page shall contain the tag associated with the NCQ command which failed.

Measurement Requirements

- Check Word 76 bit 8 in IDENTIFY DEVICE (set to one)
- If the above is true, then run the following test
 - Issue an FPDMA command with one of the following (NOTE that the test shall be run a total of three times to ensure each type of command listed below is used for the test):
 - LBA out of range (refer to Words 61:60 in IDENTIFY DEVICE data)
 - Duplicate tag for another outstanding NCQ command (will require other outstanding NCQ commands)
 - Tag value out of device supported range (refer to Word 75 bits 4:0 in IDENTIFY DEVICE data)
- Verify Register FIS receipt with Error
 - Issue Read Log Ext to log page 10h
- If a Register FIS is not received with Error, then an SDB FIS receipt posting the error should be expected
 - Issue Read Log Ext to log page 10h

Pass/Fail Criteria

- In the case of a duplicate tag or tag out of range, verify the following:
 - Verify receipt of Register FIS with error, followed by
 - Verify SDB receipt with ERR bit cleared to zero, DRDY bit set to 1, DF bit cleared to 0, and 'I' bit cleared to zero. The SActive field shall be set to FFFFFFFFh.
 - Verify that the TAG field includes the tag associated with the failed NCQ command in the data within log page 10h
- In the case of LBA out of range, verify one of the following:
 - 1) Verify receipt of Register FIS with error, followed by
 - Verify SDB receipt with ERR bit cleared to zero, DRDY bit set to 1, DF bit cleared to 0, the 'I' bit cleared to zero, and the SActive field set to FFFFFFFFh.
 - Verify that the TAG field includes the tag associated with the failed NCQ command in the data within log page 10h
 - 2) Verify receipt of SDB FIS with error, followed by
 - Verify SDB receipt with ERR bit cleared to zero, DRDY bit set to 1, DF bit cleared to 0, the 'I' bit cleared to zero, and the SActive field set to FFFFFFFFh.
 - Verify that the TAG field includes the tag associated with the failed NCQ command in the data within log page 10h

2.2.5. NCQ-05 : DMA Setup Auto-Activate

2.2.5.1. Device Expected Behavior

See section 10.3.8 of Serial ATA Revision 2.6.

To test for this test requirement, the device shall claim support for DMA Setup Auto-Activate (IDENTIFY DEVICE data, Word 78 bit 2 set to one) and have the feature enabled using the SET FEATURES command (IDENTIFY DEVICE data, Word 79 bit 2 set to one).

A device shall not transmit a DMA Activate FIS to trigger transmission of the first Data FIS from the host, if it had previously sent a DMA Setup FIS with the Auto-Activate bit ('A') set to one.

Measurement Requirements

- Check Word 76 bit 8 in IDENTIFY DEVICE (set to one)
- If the above is true, then run the following test
 - Check Word 78 bit 2 in IDENTIFY DEVICE
 - Issue SET FEATURES with Features value of 10h and Sector Count value of 02h
 - Check Word 79 bit 2 in IDENTIFY DEVICE
 - Issue WRITE FPDMA QUEUED with Auto-Activate bit set

Pass/Fail Criteria

- Verify Word 78 bit 2 of IDENTIFY DEVICE is set to one
- Verify Word 79 bit 2 of IDENTIFY DEVICE is set to one (following SET FEATURES)
- Verify that initial DMA Activate FIS is indeed missing prior to first transmitted Data FIS
- Verify command completion (data transferred and Register FIS received)

2.3. Asynchronous Signal Recovery

The Serial ATA Asynchronous Signal Recovery (ASR) test requirements are determined by the requirements of the feature as defined in Serial ATA Revision 2.6.

2.3.1. ASR-01 : COMINIT response interval

2.3.1.1. Device Expected Behavior

See section 15.2.2.2 of Serial ATA Revision 2.6.

In a case where the device is in an interface quiescent state in response to receipt of a COMRESET signal from the host, the device shall respond with a COMINIT signal within 10 ms of de-qualification of a received COMRESET signal.

Measurement Requirements

- Power on host & device
- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Initiate COMRESET sequence
 - This requirement must be verified on 5 total sequences within the trace.

Pass/Fail Criteria

- Confirm OOB sequence completion and COMINIT timing of being within 10ms of COMRESET receipt from host (use trace to analyze timings). Since a single result is reported, the worst-case result out of all 5 cases must be reported (i.e. largest value).
- NOTE : the time to be compared to this requirement is from the end of the COMRESET burst (detectable point) to the start of COMINIT burst from the device. Some subtraction or modification to a result displayed by a bus analyzer may be necessary to extract the appropriate value for comparison.

2.3.2. ASR-02 : COMINIT OOB Interval

2.3.2.1. Device Expected Behavior

See section 8.2 of Serial ATA Revision 2.6.

When Phy communication is not established, the device shall not initiate a new OOB (COMINIT) to the host faster than every 10 ms.

Measurement Requirements

- Power on host & device
- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Power off host, keeping device powered on
 - This requirement must be verified on 10 total sequences within the trace.

Pass/Fail Criteria

- Verify that once host is powered off, that device sends COMINIT repeatably and no faster than every 10ms (use trace to verify behavior and timings). Since a single result is reported, the worst-case result out of all 10 cases must be reported (i.e. smallest value).
- NOTE : the time to be compared to this requirement is from the start of the first COMINIT burst (detectable point) to the start of a subsequent COMINIT burst from the device. Some subtraction or modification to a result displayed by a bus analyzer may be necessary to extract the appropriate value for comparison.

2.3.3. ASR-03 : COMRESET OOB Interval

2.3.3.1. Host Expected Behavior

See section 8.3 of Serial ATA Revision 2.6.

When Phy communication is not established, the host shall not initiate a new OOB (COMRESET) to the device faster than every 10 ms.

Measurement Requirements

- Power on host & device
- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Power off device, keeping host powered on
 - This requirement must be verified on 10 total sequences within the trace.

Pass/Fail Criteria

- Verify that once device is powered off, that host sends COMRESET repeatably and no faster than every 10ms (use trace to verify behavior and timings). Since a single result is reported, the worst-case result out of all 10 cases must be reported (i.e. smallest value).
- NOTE : the time to be compared to this requirement is from the start of the first COMRESET burst (detectable point) to the start of a subsequent COMRESET burst from the host. Some subtraction or modification to a result displayed by a bus analyzer may be necessary to extract the appropriate value for comparison.

2.4. Software Settings Preservation

The Serial ATA software settings preservation (SSP) test requirements are determined by the requirements of the feature as defined in Serial ATA Revision 2.6.

All of the test requirements listed in this section require that support for Software Settings Preservation is claimed by the product for verification of the Expected Behavior. Support for Software Settings Preservation can be verified by reading Word 78 bit 6 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data.

See section 13.4 of Serial ATA Revision 2.6 for details on Software Settings Preservation.

2.4.1. SSP-01 : Initialize Device Parameters

2.4.1.1. Device Expected Behavior

This test is not applicable to ATAPI devices.

NOTE - To test the following requirement, a device must claim that the value contained in Words 58:54 are valid (Word 53 bit 0 set to one in IDENTIFY DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the device settings established by the INITIALIZE DEVICE PARAMETERS command. Specifically, the values contained within Words 58:54 in IDENTIFY DEVICE data shall be maintained after a COMRESET. The value contained within Word 53 bit 0 in IDENTIFY DEVICE data shall also be maintained after a COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE (set to one)
- Check Word 53 bit 0 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of device settings (Words 58:54)
 - Issue COMRESET and complete OOB sequence
 - Check value of device settings (Words 58:54)

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE Words 58:54 contain the same values following COMRESET

2.4.2. SSP-02 : Read/Write Stream Error Log

2.4.2.1. Device Expected Behavior

This test is not applicable to ATAPI devices.

NOTE - To test the following requirement, a device must claim support for Streaming (Word 84 bit 4 set to one in IDENTIFY DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the Read Stream Error Log and Write Stream Error Log contents. Specifically, the values contained within log addresses 22:21 shall be maintained after a COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE (set to one)
- Check Word 84 bit 4 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of log pages 22:21
 - Complete an ATA specification compliant activity to change the values represented in log pages 22:21 such that they do not represent the default values. The state of the new values must be known for comparison in pass/fail criteria.
 - Verify the new value of log pages 22:21
 - Issue COMRESET and complete OOB sequence
 - Check value of log pages 22:21

Pass/Fail Criteria

- Verify that log pages 22:21 contain the same values following COMRESET

2.4.3. SSP-03 : Security Mode State

2.4.3.1. Device Expected Behavior

NOTE - To test the following requirement, a device must claim support for Security Mode (Word 82 bit 1 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of Security Mode. Specifically, if Security Mode is enabled (Word 85 bit 1 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the mode value (Word 128 bits 3:1 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) shall be maintained after a COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 82 bit 1 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 85 bit 1 (set to one)
 - If the above is not true, then the Security Mode feature set must be enabled to continue
 - Check value of Word 128 bits 3:1
 - Complete an ATA specification compliant activity to change the values represented in Word 128 bits 3:1 such that they do not represent the default values. The state of the new values must be known for comparison in pass/fail criteria.
 - Verify the new value of Word 128 bits 3:1
 - Issue COMRESET and complete OOB sequence
 - Check value of Word 85 bit 1 (set to one)
 - Check value of Word 128 bits 3:1

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 85 bit 1 contains the same value following COMRESET
- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 128 bits 3:1 contain the same value following COMRESET

2.4.4. SSP-04 : Set Address Max

2.4.4.1. Device Expected Behavior

This test is not applicable to ATAPI devices.

NOTE - To test the following requirement, a device must claim support for Host Protected Area (Word 82 bit 10 set to one in IDENTIFY DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the max address established by the SET MAX ADDRESS or SET MAX ADDRESS EXT command. Specifically, the value contained within Words 61:60 in IDENTIFY DEVICE data shall be maintained after a COMRESET.

If 48-bit support is enabled by the device (Word 83 bit 10 set to one in IDENTIFY DEVICE data), then the values contained within Words 103:100 in IDENTIFY DEVICE data shall also be maintained after a COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE (set to one)
- Check Word 82 bit 10 in IDENTIFY DEVICE (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Issue READ NATIVE MAX ADDRESS (or READ NATIVE MAX ADDRESS EXT) to get max user accessible address.
 - Issue SET MAX ADDRESS (or SET MAX ADDRESS EXT) with new valid max accessible address
 - Check value of Word 83 bit 10
 - Check value of Words 61:60
 - If Word 83 bit 10 is set to one, also check value of Words 103:100
 - Verify correct address is set due to SET MAX ADDRESS (EXT) command
 - Issue COMRESET and complete OOB sequence
 - Check value of Words 61:60
 - If Word 83 bit 10 is set to one, also check value of Words 103:100

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE Words 61:60 contain the same values following COMRESET, additionally if Word 83 bit 10 is set to one verify that Words 103:100 contain the same values following COMRESET

2.4.5. SSP-05 : Set Features – Write Cache Enable/Disable

2.4.5.1. Device Expected Behavior

NOTE - To test the following requirement, a device must claim support for Write Cache (Word 82 bit 5 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of write cache enable/disable. Specifically, if write cache is enabled (Word 85 bit 5 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be enabled after the COMRESET. If write cache is disabled (Word 85 bit 5 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be disabled after the COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check value of Word 82 bit 5 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 85 bit 5
 - Issue SET FEATURES to alter setting for Write Cache enable/disable
 - Issue COMRESET and complete OOB sequence
 - Check value of Word 85 bit 5

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 85 bit 5 contains the same value following COMRESET

2.4.6. SSP-06 : Set Features – Set Transfer Mode

2.4.6.1. Device Expected Behavior

Upon receipt of a COMRESET, a device shall maintain the Multiword DMA and Ultra DMA mode settings. Specifically, the values contained within Word 63 bits 10:8 (MWDMA) and Word 88 bits 14:8 (UDMA) in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data shall be maintained after a COMRESET.

The bits in Word 88 are only valid if Word 53 bit 2 is set to one.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 63 bits 10:8 for Multiword DMA support
 - Check value of Word 88 bits 14:8 for Ultra DMA support
 - Complete an ATA specification compliant activity to change the values represented in Word 63 bits 10:8 and Word 88 bits 14:8 such that they do not represent the default values. The state of the new values must be known for comparison in pass/fail criteria.
 - Verify the new value of Word 63 bits 10:8 and Word 88 bits 14:8
 - Issue COMRESET and complete OOB sequence
 - Note that you may need to appropriately handle the reset condition for ATAPI devices (i.e. handling of request sense)
 - Check value of Word 63 bits 10:8
 - Check value of Word 88 bits 14:8
 - Issue a read to any valid random location on the device (using Multiword DMA transfer, if supported)
 - Issue a read to any valid random location on the device (using Ultra DMA transfer, if supported)

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 63 bits 10:8 contain the same values following COMRESET
- Verify that Word 88 bits 14:8 contain the same values following COMRESET
- Verify that the read Multiword DMA command completed successfully, if supported
- Verify that the read Ultra DMA command completed successfully, if supported

2.4.7. SSP-07 : Set Features – Advanced Power Management Enable/Disable

2.4.7.1. Device Expected Behavior

This test is not applicable to ATAPI devices.

NOTE - To test the following requirement, a device must claim support for Advanced Power Management (Word 83 bit 3 set to one in IDENTIFY DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of Advanced Power Management (APM) enable/disable and the advanced power management level. Specifically, if APM is enabled (Word 86 bit 3 set to one in IDENTIFY DEVICE data) upon receipt of a COMRESET then the feature shall be enabled after the COMRESET, and Word 91 bits 7:0 in IDENTIFY DEVICE data shall contain the value present prior to the COMRESET. If APM is disabled (Word 86 bit 3 cleared to zero in IDENTIFY DEVICE data) upon receipt of a COMRESET then the feature shall be disabled after the COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE (set to one)
- Check Word 83 bit 3 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test

- Check Word 86 bit 3 (set to one)
- Issue SET FEATURES to alter setting for APM enable/disable
- If Word 86 bit 3 is set to one,
 - Check value of Word 91 bits 7:0
- Issue COMRESET and complete OOB sequence
- Check Word 83 bit 3,
- If Word 86 bit 3 is set to one,
 - Check value of Word 91 bits 7:0

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE Word 86 bit 3 contains the same value following COMRESET
 - If Word 86 bit 3 was set to one, verify that IDENTIFY DEVICE 91 bits 7:0 contains the same value following COMRESET

2.4.8. SSP-08 : Set Features – Read Look-Ahead

2.4.8.1. Device Expected Behavior

NOTE - To test the following requirement, a device must claim support for look-ahead (Word 82 bit 6 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of look-ahead enable/disable. Specifically, if support for look-ahead is enabled (Word 85 bit 6 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be enabled after the COMRESET. If support for look-ahead is disabled (Word 85 bit 6 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be disabled after the COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 82 bit 6 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 85 bit 6
 - Issue SET FEATURES to alter setting for read look-ahead enable/disable
 - Issue COMRESET and complete OOB sequence
 - Check value of Word 85 bit 6

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 85 bit 6 contains the same value following COMRESET

2.4.9. SSP-09 : Set Features – Release Interrupt

2.4.9.1. Device Expected Behavior

NOTE - To test the following requirement, a device must claim support for release interrupt (Word 82 bit 7 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of release interrupt enable/disable. Specifically, if support for release interrupt is enabled (Word 85 bit 7 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be enabled after the COMRESET. If support for release interrupt is disabled (Word 85 bit 7 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be disabled after the COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 82 bit 7 (set to one)

- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 85 bit 7
 - Issue SET FEATURES to alter setting for release interrupt enable/disable
 - Issue COMRESET and complete OOB sequence
 - Check value of Word 85 bit 7

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 85 bit 7 contains the same value following COMRESET

2.4.10. SSP-10 : Set Features – Service Interrupt

2.4.10.1. Device Expected Behavior

NOTE - To test the following requirement, a device must claim support for service interrupt (Word 82 bit 8 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the value of service interrupt enable/disable. Specifically, if support for service interrupt is enabled (Word 85 bit 8 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be enabled after the COMRESET. If support for service interrupt is disabled (Word 85 bit 8 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) upon receipt of a COMRESET then the feature shall be disabled after the COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 82 bit 8 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test
 - Check value of Word 85 bit 8
 - Issue SET FEATURES to alter setting for service interrupt enable/disable
 - Issue COMRESET and complete OOB sequence
 - Check value of Word 85 bit 8

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE or IDENTIFY PACKET DEVICE Word 85 bit 8 contains the same value following COMRESET

2.4.11. SSP-11 : Set Multiple Mode

2.4.11.1. Device Expected Behavior

This test is not applicable to ATAPI devices.

NOTE - To test the following requirement, a device must claim that the multiple sector setting is valid (Word 59 bit 8 set to one in IDENTIFY DEVICE data).

Upon receipt of a COMRESET, a device shall maintain the block size established by the Set Multiple Mode command. Specifically, the value contained within Word 59 bits 8:0 in IDENTIFY DEVICE data shall be maintained after a COMRESET.

Measurement Requirements

- Check Word 78 bit 6 in IDENTIFY DEVICE (set to one)
- Check Word 59 bit 8 (set to one)
- If the above is false, then the test is not applicable
- Otherwise, run the following test

- Check for non-zero value of Word 47 bits 7:0
- Issue Set Multiple command to change the block size from the value reported in Word 47 bits 7:0
- Check value of Word 59 bits 8:0
- Verify correct block size is set due to Set Multiple command
- Issue COMRESET and complete OOB sequence
- Check value of Word 59 bits 8:0

Pass/Fail Criteria

- Verify that IDENTIFY DEVICE Word 59 bits 8:0 contains the same value following COMRESET

2.5. Interface Power Management

The Serial ATA Interface Power Management (IPM) test requirements are determined by the requirements of the feature as defined in Serial ATA Revision 2.6.

Some of the test requirements listed in this section require that support for device initiating interface power management and/or host initiating interface power management is claimed by the product for verification of the Expected Behavior. Support for device initiating interface power management can be verified by reading Word 78 bit 3 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data. Support for host initiating interface power management can be verified by reading Word 76 bit 9 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data. For each test requirement, there will be a note outlining whether support for device initiating interface power management and/or host initiating interface power management is a requirement for testing said test requirement.

A product may claim support for both device initiating interface power management (DIPM) requests and receipt of host initiating power management (HIPM) requests. It is not required to support both types of requests.

If a host intends to be validated for Interface Power Management (IPM) support through the Interoperability Tests, it must be pre-configured (BIOS, driver, utility) to automatically send SET FEATURES to enable DIPM requests following device detection and to configure the host in such a way that it may accept DIPM requests. This is because there are limitations to how hosts may be validated for a feature, and DIPM requests are a key requirement for any IPM validation on a host. If a host only supports HIPM, there is no way to validate this support and it will not be verified for Interop Testing.

2.5.1. IPM-01 : Partial State exit latency (host-initiated)

2.5.1.1. Device/Host Expected Behavior

See section 8.1 of Serial ATA Revision 2.6.

The device and host exit latency (i.e. COMWAKE response) from the partial state shall start within 10 microseconds of COMWAKE receipt from the initiator of the wake sequence.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (HIPM)
 - Issue PMREQ_P and receive device response
 - Issue COMWAKE and wait for complete wake of device
 - This requirement must be verified on 10 total sequences within the trace.

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Wait for a Partial IPM request from the host
 - NOTE – there is no guaranteed method for causing the host to send a request, some common ATA (or vendor specific) methods which may cause a request from the host are:
 - Leave the system idle (up to 10 seconds)

- NOTE – ensure there is no conflict with a device initiated request
- NOTE – a host vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
- Issue COMWAKE and wait for complete wake of host
- This requirement must be verified on 10 total sequences within the trace.

Pass/Fail Criteria

- Device : Confirm Partial wake sequence completion and COMWAKE timing of being within 10us of COMWAKE receipt from host (use trace to analyze timings)
- Host : Confirm Partial wake sequence completion and ALIGN timing of being within 10us of COMWAKE receipt from device/emulator/tool (use trace to analyze timings)
 - NOTE : In the case that no host initiated request was completed, the pass/fail result will be N/A.
- Since a single result is reported, the worst-case result out of all 10 cases must be reported (i.e. largest value).

2.5.2. IPM-02 : Slumber State exit latency (host-initiated)

2.5.2.1. Device/Host Expected Behavior

See section 8.1 of Serial ATA Revision 2.6.

The product exit latency (i.e. COMWAKE response) from the slumber state shall start within 10 milliseconds of COMWAKE receipt from the initiator of the wake sequence.

A method for testing the exit latency of a device is for host software to initiate a COMWAKE on the interface. After initiating the request, the host would record the time until the W bit is set to one within the DIAG field of the SError register.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (HIPM)
 - Issue PMREQ_S and receive device response
 - Issue COMWAKE and wait for complete wake of device
- This requirement must be verified on 10 total sequences within the trace.

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Wait for a Slumber IPM request from the host
 - NOTE – there is no guaranteed method for causing the host to send a request, some common ATA (or vendor specific) methods which may cause a request from the host are:
 - Leave the system idle and monitor for an Slumber IPM request for 10 seconds
 - NOTE – ensure there is no conflict with a device initiated request
 - NOTE – a host vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
- Issue COMWAKE and wait for complete wake of host
- This requirement must be verified on 10 total sequences within the trace.

Pass/Fail Criteria

- Device : Confirm Slumber wake sequence completion and COMWAKE timing of being within 10ms of COMWAKE receipt from host (use trace to analyze timings)
- Host : Confirm Slumber wake sequence completion and ALIGN timing of being within 10ms of COMWAKE receipt from device/emulator/tool (use trace to analyze timings)
 - NOTE : In the case that no host initiated request was completed, the pass/fail result will be N/A.
- Since a single result is reported, the worst-case result out of all 10 cases must be reported (i.e. largest value).

2.5.3. IPM-03 : Speed matching upon resume (host-initiated)

2.5.3.1. Device/Host Expected Behavior

See section 8.3 of Serial ATA Revision 2.6.

The product signaling speed upon returning from a partial or slumber state shall match the speed prior to entering the partial or slumber state.

Measurement Requirements (Device)

- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (HIPM)
 - Note the current interface rate – determination of the current interface rate is MOI specific
 - Issue PMREQ_P or PMREQ_S and receive device response
 - Issue COMWAKE and wait for complete wake of device
 - Verify the current interface rate – determination of the current interface rate is MOI specific
- This requirement must be verified on 10 total sequences of **PMREQ_P if supported and 10 total sequences of PMREQ_S if supported.**

Measurement Requirements (Host)

- Note the current interface rate – determination of the current interface rate is MOI specific
- Wait for a PMREQ_P or PMREQ_S from the host
 - NOTE – there is no guaranteed method for causing the host to send a request, some common ATA (or vendor specific) methods which may cause a request from the host are:
 - Leave the system idle and monitor for an appropriate PMREQ for 10 seconds
 - NOTE – ensure there is no conflict with a device initiated request
 - NOTE – a host vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
- Issue COMWAKE and wait for complete wake of host
- Note the current interface rate – determination of the current interface rate is MOI specific
- This requirement must be verified on 10 total sequences of **PMREQ_P if supported and 10 total sequences of PMREQ_S if supported.**

Pass/Fail Criteria

- A sequence fails if there is no response (i.e. no PMACK or no PMNAK is returned) or if the interface rate changes from before to after the power management sequence.
- To report a single pass/fail result for all sequences, the following pass/fail rules apply:
 1. If 1 or more of the sequences fails, the result is Fail.
 2. If 1 or more of the sequences pass and none fail, the result is Pass.
 3. If all the sequences result with PMNAKs and no pass or fail sequences, the result is na.

2.5.4. IPM-04 : NAK of requests when support not indicated

2.5.4.1. Device/Host Expected Behavior

See section 9.6 of Serial ATA Revision 2.6.

If a device does not support host interface power management (Word 76 bit 9 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), upon receipt of a PMREQ_P or PMREQ_S the device should respond with a PMNAK.

If a host does not support device interface power management, upon receipt of a PMREQ_P or PMREQ_S the host should respond with a PMNAK.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing

- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (cleared to zero)
- If the above is true, then run the following test
 - Issue PMREQ_P or PMREQ_S and receive device response
- This requirement must be verified on 10 total sequences

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Issue PMREQ_P or PMREQ_S and receive host response
- This requirement must be verified on 10 total sequences of PMREQ_P and 10 total sequences of PMREQ_S

Pass/Fail Criteria

- If a PMACK is received, the result is fail, PMNAK or non-response is a pass.
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.5. IPM-05 : Response to PMREQ_P

2.5.5.1. Device/Host Expected Behavior

See section 9.6 of Serial ATA Revision 2.6.

If a device claims support for host interface power management (Word 76 bit 9 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), upon receipt of a PMREQ_P the following are valid device responses:

- respond with between 4 and 16 PMACK primitives and place the device Phy layer into the partial state
- respond with PMNAK until SYNC is received from the host, no device Phy layer power transition shall occur.

If a host claims support for device interface power management, upon receipt of a PMREQ_P the following are valid device responses:

- respond with between 4 and 16 PMACK primitives and place the host Phy layer into the partial state
- respond with PMNAK until SYNC is received from the device, no host Phy layer power transition shall occur.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- If the above is true, then run the following test
 - Issue PMREQ_P and receive device response
- This requirement must be verified on 10 total sequences

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Issue PMREQ_P and receive host response
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- Verify that PMNAK or between 4 and 16 total PMACKs are received (use trace to verify product response)
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.6. IPM-06 : Response to PMREQ_S

2.5.6.1. Device/Host Expected Behavior

See section 9.6 of Serial ATA Revision 2.6.

If a device claims support host interface power management (Word 76 bit 9 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), upon receipt of a PMREQ_S the following are valid device responses:

- respond with between 4 and 16 PMACK primitives and place the device Phy layer into the slumber state
- respond with PMNAK until SYNC is received from the host, no device Phy layer power transition shall occur.

If a host claims support for device interface power management, upon receipt of a PMREQ_S the following are valid device responses:

- respond with between 4 and 16 PMACK primitives and place the host Phy layer into the slumber state
- respond with PMNAK until SYNC is received from the device, no host Phy layer power transition shall occur.

The above responses relative to a host are also required if a host supports device initiated power management.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 76 bit 9 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- If the above is true, then run the following test
 - Issue PMREQ_S and receive device response
- This requirement must be verified on 10 total sequences

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Issue PMREQ_S and receive host response
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- Verify that PMNAK or between 4 and 16 total PMACKs are received (use trace to verify device response)
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.7. IPM-07 : Device default setting for device initiated requests

2.5.7.1. Device Expected Behavior

This test is not applicable to hosts.

See section 13.2.4.3 of Serial ATA Revision 2.6.

If a device claims support device interface power management (Word 78 bit 3 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), support for device power management shall be disabled (Word 79 bit 3 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) by default. A device shall not issue Partial/Slumber requests unless this feature has been enabled by the host as a result of a SET FEATURES command.

Measurement Requirements

- Power on device
- Check Word 78 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (cleared to zero)
- Issue SET FEATURES (Sector Count = 03h, Features = 10h) to enable device support for initiating power management
- Issue COMRESET and complete OOB sequence
- Check Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- Verify that Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE is cleared to zero in both instances above
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.8. IPM-08 : Device Initiated Power Management enable / disable

2.5.8.1. Device Expected Behavior

This test is not applicable to hosts.

See section 13.2.4.3 of Serial ATA Revision 2.6.

Support for device power management shall be disabled (Word 79 bit 3 cleared to zero in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data) by default. A device shall not issue Partial/Slumber requests unless this feature has been enabled by the host as a result of a SET FEATURES command.

Measurement Requirements

- Power on device
- Check Word 78 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Check Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (cleared to zero)
- Issue SET FEATURES (Sector Count = 03h, Features = 10h) to enable device support for initiating power management
- Verify Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
- Wait for a PMREQ_P or PMREQ_S from the device
 - NOTE – there is no guaranteed method for causing the device to send a request, the recommended method to cause a request is:
 - Leave the device idle and wait for an appropriate PMREQ for 10 seconds
 - If no PMREQ_P or PMREQ_S has been issued, issue a STANDBY IMMEDIATE command to device and wait for appropriate PMREQ for 10 seconds
 - NOTE – ensure there is no conflict with a host initiated request
 - (see NOTE in Pass/Fail criteria)
 - NOTE – a device vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
- Issue SET FEATURES (Sector Count = 03h, Features = 90h) to disable device support for initiating power management
- Check Word 79 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (cleared to zero)
- Verify either a PMREQ_S or PMREQ_P is NOT [generated using the following method](#)
 - [Leave the device idle and wait for an appropriate PMREQ for 10 seconds](#)
 - [If no PMREQ_P or no PMREQ_S has been issued, issue a STANDBY IMMEDIATE command to device and wait for appropriate PMREQ for 10 seconds](#)
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- All commands completed with out error
- All verifications [of all sequences](#) completed as indicated above.
 - NOTE : In the case that no device initiated request was completed for any of the test sequences when the feature is enabled, the pass/fail result will be N/A.

2.5.9. IPM-09 : Partial State exit latency (device-initiated)

2.5.9.1. Device/Host Expected Behavior

See section 8.1 of Serial ATA Revision 2.6.

The device and host exit latency (i.e. COMWAKE response) from the partial state shall start within 10 microseconds of COMWAKE receipt from the host.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 78 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (DIPM)
 - Wait for a Partial IPM request from the device
 - NOTE – there is no guaranteed method for causing the device to send a request, the recommended method to cause a request is:
 - Leave the device idle and wait up to 10 seconds for a Slumber IPM request
 - If no Partial IPM request is generated, issue a STANDBY IMMEDIATE command to device and wait up to 10 seconds
 - NOTE – a device vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
 - Issue COMWAKE and wait for complete wake of device
- This requirement must be verified on 10 total sequences

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Issue PMREQ_P to host
- Issue COMWAKE and wait for complete wake of host
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- Device : Confirm Partial wake sequence completion and COMWAKE timing of being within 10us of COMWAKE receipt from host (use trace to analyze timings)
 - NOTE : In the case that no device initiated request was completed for any of the test sequences, the pass/fail result will be N/A.
- Host : Confirm Partial wake sequence completion and ALIGN timing of being within 10us of COMWAKE receipt from device/emulator/tool (use trace to analyze timings)
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.10. IPM-10 : Slumber State exit latency (device-initiated)

2.5.10.1. Device/Host Expected Behavior

See section 8.1 of Serial ATA Revision 2.6.

The product exit latency (i.e. COMWAKE response) from the slumber state shall start within 10 milliseconds of COMWAKE receipt from the host.

A method for testing the exit latency of a device is for host software to initiate a COMWAKE on the interface. After initiating the request, the host would record the time until the W bit is set to one within the DIAG field of the SError register.

Measurement Requirements (Device)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Check Word 78 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (DIPM)
 - Wait for a Slumber IPM request from the device
 - NOTE – there is no guaranteed method for causing the device to send a request, the recommended method to cause a request is:
 - Leave the device idle and wait up to 10 seconds for a Slumber IPM request

- If not Slumber IPM request has been generated by the device, issue a STANDBY IMMEDIATE command to device and wait up to 10 seconds
 - NOTE – a device vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
 - Issue COMWAKE and wait for complete wake of device
- This requirement must be verified on 10 total sequences

Measurement Requirements (Host)

- Setup bus analyzer (or scope) for tracing of bus activity & begin tracing
- Issue PMREQ_S to host
- Issue COMWAKE and wait for complete wake of host
- This requirement must be verified on 10 total sequences

Pass/Fail Criteria

- Device : Confirm Slumber wake sequence completion and COMWAKE timing of being within 10ms of COMWAKE receipt from host (use trace to analyze timings)
 - NOTE : In the case that no device initiated request was completed for any of the test sequences, the pass/fail result will be N/A.
- Host : Confirm Slumber wake sequence completion and ALIGN timing of being within 10ms of COMWAKE receipt from device/emulator/tool (use trace to analyze timings)
- Since a single pass/fail result is reported, it must be verified that all 10 test sequences were a pass for the final result to be a PASS for this test requirement.

2.5.11. IPM-11 : Speed matching upon resume (device-initiated)

2.5.11.1. Device/Host Expected Behavior

See section 8.4.3.1 of Serial ATA Revision 2.6.

The product signaling speed upon returning from a partial or slumber state shall match the speed prior to entering the partial or slumber state.

Measurement Requirements (Device)

- Check Word 78 bit 3 in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE (set to one)
 - If the above is true, then run the following test (DIPM)
 - Note the current interface rate – determination of the current interface rate is MOI specific
 - Wait for an IPM request from the device
 - NOTE – there is no guaranteed method for causing the device to send a request, the recommended method to cause a request is:
 - Leave the device idle and wait up to 10 seconds for a IPM request.
 - If no IPM request has been generated by the device, issue a STANDBY IMMEDIATE command to device and wait up to 10 seconds
 - NOTE – a device vendor may provide a vendor unique tool for initiating the power management requests as to ensure the test does complete as necessary.
 - Issue COMWAKE and wait for complete wake of device
 - Note the current interface rate – determination of the current interface rate is MOI specific
- This requirement must be verified on 10 total sequences of PMREQ_P if supported and 10 total sequences of PMREQ_S if supported.

Measurement Requirements (Host)

- Note the current interface rate – determination of the current interface rate is MOI specific
- Issue PMREQ_P or PMREQ_S and receive host response
- Issue COMWAKE and wait for complete wake of host
- Note the current interface rate – determination of the current interface rate is MOI specific

- This requirement must be verified on 10 total sequences of PMREQ_P, if supported and 10 total sequences of PMREQ_S, if supported.

Pass/Fail Criteria

- A sequence fails if there is no response (i.e. no PMACK or PMNAK is returned) or if the interface rate changes from before to after the power management sequence.
- To report a single pass/fail result for all sequences, the following pass/fail rules apply:
 1. If 1 or more of the sequences fails, the result is Fail.
 2. If 1 or more of the sequences pass and none fail, the result is Pass.
 3. If all the sequences result with PMNAKs and no pass or fail sequences, the result is NA.

2.6. Mechanical - Cable Assembly - Standard Internal and eSATA

If both ends of a cable have identical connector types, then the mechanical tests will only need to be verified on one end of the cable.

The tester shall ensure that the cable assemblies are clearly labeled so that each line in a cable assembly can be uniquely identified. For a standard internal cable assembly, a suggested labeling method is:

- Each of the cables is labeled
- The two ends of the cable are also labeled, e.g. Recept_A, Recept_B
- The signal lines use the pin names provided in the specification. For standard internal connectors table 2 and Figure 29 of section 6.1.3.2, in the Serial ATA Revision 2.6 specification labels the individual signal lines as S1, S2, S3, ...S6, S7. It also defines Pair A as being the combination of signal lines S2 and S3, while Pair B is defined as the combination of signal lines S5 and S6.

If a family of cables is being tested, all tests shall be performed on only one of the cables (longest or shortest).

To ensure that tests are executed in an order to minimize impact between results gathered for the different tests, the following considerations are necessary for executing the mechanical cable tests.

- All SI (electrical tests) must be completed on a cable sample prior to any mechanical tests
- For internal SATA cables the cable sample used to verify MCI-02, MCI-03, MCI-04 shall be a different physical sample from which is used to verify MCI-01 and MCX-05
- For eSATA cables the samples used for MCE-01 and MCX-05 should the same sample.

2.6.1. MCI-01 : Visual and Dimensional Inspections

2.6.1.1. Cable Assembly Expected Behavior

See section 6.1.10.2, Table 5 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.1.10.2, Table 6 and section 6.1.4, Figures 30 and 31 of the Serial ATA Revision 2.6 specification.

This test is only applicable to standard internal (latching and non-latching) SATA cables.

Pass/Fail Criteria

- NOTE : all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.
- The height of the slot (for the device plug tongue) shall be 1.40 +/- 0.08 mm (Figure 30, section A-A).
- The width of the slot (for the device plug tongue) shall be 10.57 +/- 0.08 mm (Figure 30).
- The height of the slot for the device plug key shall be 2.40 +/- 0.08 mm (Figure 30).
- The width of the slot for the device plug key shall be 1.31 +/- 0.05 mm (Figure 30).
- For a non-latching cable the width of the cable retention feature (bump) shall be 1.50 +/- 0.20 mm (Figure 30).
- For a latching cable there shall be no cable retention feature (bump), as shown in Figure 31.
- For a latching cable the distance from the slot to the top surface of the receptacle shall be 1.45 +/- 0.05 mm (Figure 31).

- For a latching cable the latch engagement feature shall be able to deflect below 1.50 mm (Figure 31).

2.6.2. MCI-02 : Insertion Force (Latching and Non-Latching)

2.6.2.1. Cable Assembly Expected Behavior

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

This test is only applicable to standard internal (latching and non-latching) SATA cables.

For Serial ATA Interoperability Program testing a total of 20 insertion/removal force cycles shall be used for this measurement.

Pass/Fail Criteria

- 45 N Max.

2.6.3. MCI-03 : Removal Force (Non-Latching)

2.6.3.1. Cable Assembly Expected Behavior

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

This test is only applicable to standard non-latching internal SATA cables.

For Serial ATA Interoperability Program testing a total of 20 insertion/removal force cycles shall be used for this measurement.

Pass/Fail Criteria

- 10 N Min. through 20 cycles

2.6.4. MCI-04 : Removal Force (Latching)

2.6.4.1. Cable Assembly Expected Behavior

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

This test is only applicable to standard latching internal SATA cables.

For Serial ATA Interoperability Program testing a total of 20 insertion/removal force cycles shall be used for this measurement.

Pass/Fail Criteria

- No damage and no disconnect with 25N static load applied after 20 mating cycles

2.6.5. MCX-05 : Cable Pull-out - internal (normative) and eSATA (informative) cables

2.6.5.1. Cable Assembly Expected Behavior

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

This test is applicable to standard internal (latching and non-latching) SATA and eSATA cables.

A before and after test resistance measurement shall be made and the difference will be the change in resistance.

Pass/Fail Criteria

- NOTE : all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.
- No physical damage visible with 40N static load applied for at least 1 minute
- The change in resistance shall not be greater than 1.0 ohm

2.6.6. MCE-01 : Visual and Dimension Inspection for eSATA cables (informative)

2.6.6.1. Expected Behavior

See overview and references to Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.4.1, Figure 80 of the Serial ATA Revision 2.6 specification.

Inspect cable receptacle connector dimensions listed in the Pass/Fail Criteria section.

Notes on Insertion and Removal forces qualitative check only:

Insertion of cable receptacle connector into the device/host plug connector should be with ease. If excessive, check insertion force (40N maximum). See section 6.4.1.3 of the Serial ATA Revision 2.6 specification.

Removal of cable receptacle connector from the device/host plug connector should have no evidence of weakness (10N minimum for reference). As alternate to force test, verify the true positions of the retention features (rectangular holes x4) per Pass/Fail criteria. These holes shall mate properly with the retention spring x4 of the plug connector.

Pass/Fail Criteria

All applicable parts must pass for the test to pass:

- a) The height of the slot (for plug tongue) shall be 1.40 +/- 0.05 (Figure 80).
- b) The thickness of the left key shall be 1.30 +/- 0.08 (Figure 80).
- c) The thickness of the right key shall be 1.30 +/- 0.08 (Figure 80).
- d) The height of receptacle shall be 3.80 +/- 0.1 (Figure 80).
- e) The distance between outermost latching springs shall be 4.30 +/- 0.1 (Figure 80).
- f) The width of the slot (for plug tongue) shall be 10.15 +/- 0.05 (Figure 80).
- g) The width of the top wall shall be 9.50 +/- 0.10 (Figure 80).
- h) The width of the bottom wall shall be 12.70 +/- 0.05 (Figure 80).
- i) The distance between the outermost key sides shall be 14.80 +/- 0.10 (Figure 80).
- j) *Informative - The optional feature – dimple height should be 0.25 +/- 0.05 (Figure 80).*
- k) The retention features (1.7by 1.5 areas x4) shall be within 4.25 +/- 0.10 to datum (Y) (Figure 80).
- l) The retention features (1.7by 1.5 areas x4) shall be bilaterally located within 6.8 +/- 0.1 to the connector center axis. (Figure 80).
- m) *Informative - The distance of all spring contact points (with the blades of plug connector) should be 2.90 +/- 0.15 from datum plane Y (Figure 80).*

2.7. Electrical - Cable Assembly – Standard Internal and eSATA

The Serial ATA specification currently specifies a 20-80% rise time for the test pulse. However, test equipment rise time filters are usually programmed with 10-90% values. Thus, some conversion is needed. An example conversion for a 70ps 20-80% would be to set up the rise time filter for a 105ps 10-90% rise time.

The tester shall ensure that the cable assemblies are clearly labeled so that each line in a cable assembly can be uniquely identified. For a standard internal cable assembly, a suggested labeling method is:

- Each of the cables is labeled
- The two ends of the cable are also labeled, e.g. Recept_A, Recept_B
- The signal lines use the pin names provided in the specification. For standard internal connectors table 2 and Figure 29 of section 6.1.3.2, in the Serial ATA Revision 2.6 specification labels the individual signal lines as S1, S2, S3, ...S6, S7. It also defines Pair A as being the combination of signal lines S2 and S3, while Pair B is defined as the combination of signal lines S5 and S6.

If a family of cables is being tested, all tests shall be performed on both the longest and shortest lengths unless otherwise noted in a specific test.

Tester must save all the calibration data (i.e. screen shot) that is done daily at a minimum, if not every cable evaluation. Valid calibration data must be available per product for review, even if the same calibration data (i.e. daily) is used for multiple products. It is required that calibration be completed for this area of testing to ensure consistent measurements and environment impacts.

2.7.1. SI-01 : Mated Connector Impedance

2.7.1.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed on both ends of the cable assembly, for each differential pair of the assembly.

Measurement Requirements

- See section 6.5.2.4, Table 21, Procedure P1 of the Serial ATA Revision 2.6 specification.
- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - After completing the common procedures (and before doing the measurement) the instrument rise time shall be set or the results filtered for a minimum of 55 ps to a maximum of 70 ps (20-80%) system rise time. The system rise time shall be set as close to 70 ps (20-80%) as practical.

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Mated Connector Differential Impedance 100 Ohms \pm 15%

2.7.2. SI-02 : Cable Absolute Impedance

2.7.2.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed on one end of the cable assembly, for each differential pair of the assembly.

Measurement Requirements

- See section 6.5.2.4, Table 21, Procedure P2 of the Serial ATA Revision 2.6 specification.
- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - After completing the common procedures (and before doing the measurement) the instrument rise time shall be set or the results filtered for a minimum of 55 ps to a maximum of 70 ps (20-80%) system rise time. The system rise time shall be set as close to 70 ps (20-80%) as practical.

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Cable Absolute Differential Impedance 100 Ohms \pm 10%

2.7.3. SI-03 : Cable Pair Matching

2.7.3.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed on one end of the cable assembly, for each differential pair of the assembly.

Measurement Requirements

- See section 6.5.2.4, Table 21, Procedure P3 of the Serial ATA Revision 2.6 specification.
- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - After completing the common procedures (and before doing the measurement) the instrument rise time shall be set or the results filtered for a minimum of 55 ps to a maximum of 70 ps (20-80%) system rise time. The system rise time shall be set as close to 70 ps (20-80%) as practical.

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Cable Pair Matching Impedance \pm 5 Ohms

2.7.4. SI-04 : Common Mode Impedance

2.7.4.1. Cable Assembly Expected Behavior

See section 6.3.5.1, Table 16 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - See section 6.5.2.4, Table 21, Procedure P4 of the Serial ATA Revision 2.6 specification.

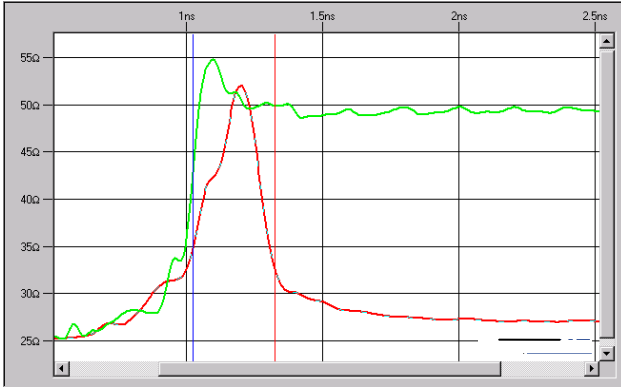


Figure – 1 Example result showing the last vestige of the connector response (at 1.8 ns)

The test shall be performed on one end of the cable assembly, for each differential pair of the assembly.

After completing the common procedures (and before doing the measurement) the instrument rise time shall be set or the results filtered for a minimum of 55 ps to a maximum of 70 ps (20-80%) system rise time. The system rise time shall be set as close to 70 ps (20-80%) as practical.

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Common Mode Impedance 25 - 40 ohms

2.7.5. SI-05 : Differential Rise Time

2.7.5.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

Measurement Requirements

- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - See section 6.5.2.4, Table 21, Procedure P8 of the Serial ATA Revision 2.6 specification.
 - The test shall be performed in one direction on the cable assembly, for each differential pair of the assembly.

Pass/Fail Criteria

For an internal SATA cable:

- Maximum Rise Time 85 ps (20-80%)

For an eSATA cable:

- Maximum Rise Time 150 ps (20-80%)

2.7.6. SI-06 : Intra-Pair Skew

2.7.6.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed in one direction on the cable assembly, for each differential pair of the assembly.

Measurement Requirements

- See section 6.5.2.4, Table 14, Procedure P10 of the Serial ATA Revision 2.6 specification.
- This test is normative for internal SATA cables and informative for eSATA cables.
- All cables and all adapters must be de-skewed just prior to performing the measurement. Note that the inclusion of the adapters in calibrations for other tests may not be correct.

Pass/Fail Criteria

For an internal SATA cable

- Maximum Intra-Pair Skew 10 ps

For an eSATA cable

- Maximum Intra-Pair Skew 20 ps

2.7.7. SI-07 : Insertion Loss

2.7.7.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 10 of the Serial ATA Revision 2.6 specification.

The test shall be performed in one direction on the cable assembly, for each differential pair of the assembly.

If a family of cables is being tested, only the longest length is tested for this requirement.

Measurement Requirements

- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - See section 6.5.2.4, Table 14, Procedure P5 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

For an internal SATA cable:

- Maximum Insertion Loss of Cable (10-4500 MHz) 6 dB

For an eSATA cable:

- Maximum Insertion Loss of Cable (10-4500 MHz) 8 dB

2.7.8. SI-08 : Differential to Differential Crosstalk: NEXT

2.7.8.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed on both ends of the cable assembly, but only needs to be measured in one direction on each end (for example, with the Tx pair as the aggressor, and the Rx pair as the receiver).

Measurement Requirements

- This test is normative for internal SATA cables and informative for eSATA cables.

- For an internal SATA and eSATA cable:
 - See section 6.5.2.4, Table 21, Procedure P6 of the Serial ATA Revision 2.6 specification.
 - If a time-based test equipment is used to measure the NEXT, it must use a acquisition window that is at least 4 times the propagation delay of the cable (electrical length).
 - For test adapters comprising of 2 plugs to SMA and 1 receptacle to SMA adapters, each combination of plug / receptacle shall have a NEXT performance better than -36dB (10-4500 MHz). The performance measurement of this adapter combination must be made and saved on a daily basis, or each time the setup is restored. In the event of a product failure, re-confirm that the adapter performance meets this requirement. For this measurement, the tester must continue to follow the same procedure for making a NEXT measurement on a product (see Procedure P6).

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Maximum Crosstalk: NEXT (10-4500 MHz) -26 dB

2.7.9. SI-09 : Inter-Symbol Interference

2.7.9.1. Cable Assembly Expected Behavior

See section 6.5.1.1, Table 16 of the Serial ATA Revision 2.6 specification.

The test shall be performed in one direction on the cable assembly, for each differential pair of the assembly.

If a family of cables is being tested, only the longest length is tested for this requirement.

Measurement Requirements

- This test is normative for internal SATA cables and informative for eSATA cables.
- For an internal SATA and eSATA cable:
 - See section 6.5.2.4, Table 21, Procedure P9 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

For an internal SATA and eSATA cable:

- Maximum Inter-Symbol Interference 50 ps

2.8. Mechanical – Device - Standard Internal Connector

2.8.1. MDI-01 : Connector Location

2.8.1.1. Device Expected Behavior

See section 6.1.2 of the Serial ATA Revision 2.6 specification.

See section 6.3 of the Serial ATA Revision 2.6 specification for Slimline ATAPI device requirements.

See section 6.2.3 of Serial ATA Revision 2.6 specification for uSATA device requirements.

Measurement Requirements

- For a 12.7mm Slimline optical device see section 6.3.3, Figure 60 of the Serial ATA Revision 2.6 specification.
- For a 9.5 mm Slimline optical device see section 6.3.3, Figure 59 of the Serial ATA Revision 2.6 specification.
- For a 5.25” optical device see section 6.1.2, Figure 18 of the Serial ATA Revision 2.6 specification.

- For a 5.25" non-optical device see either section 6.1.2, Figure 18 or section 6.1.2, Figure 19 of the Serial ATA Revision 2.6 specification.
- For a 3.5" side mounted device see section 6.1.2, Figure 20 of the Serial ATA Revision 2.6 specification.
- For a 3.5" bottom mounted device see section 6.1.2, Figure 21 of the Serial ATA Revision 2.6 specification.
- For a 2.5" side mounted device see section 6.1.2, Figure 22 of the Serial ATA Revision 2.6 specification.
- For a 2.5" bottom mounted device see section 6.1.2, Figure 23 of the Serial ATA Revision 2.6 specification.
- For a 1.8" uSATA see section 6.2.3, Figure 52 and Figure 53 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

- NOTE : all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.
- For a 12.7 mm Slimline optical device:
 - a) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 6.20 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.40 mm.
 - c) From the edge of the drive to the centerline of the SATA plug shall be 21.25 +/- 0.38 mm.
 - d) From the back surface of the drive (i.e. the "end of the device factor") to the base of the tongue of the SATA plug shall be 5.20 +/- 0.3 mm.
- For a 9.5 mm Slimline optical device:
 - a) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 6.00 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.40 mm.
 - c) From the edge of the drive to the centerline of the SATA plug shall be 21.25 +/- 0.38 mm.
 - d) From the back surface of the drive (i.e. the "end of the device factor") to the base of the tongue of the SATA plug shall be 5.20 +/- 0.3 mm.
- For a 5.25" optical device:
 - a) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 10.00 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.40 mm.
 - c) From the centerline of the drive to the centerline of the SATA plug shall be 25.00 +/- 0.38 mm.
 - d) From the back surface of the drive (i.e. the "end of the device factor") to the base of the tongue of the SATA plug shall be 4.90 +/- 0.50 mm.
- For a 5.25" non-optical device: If the device follows section 6.1.2, Figure 18 then use the Pass/Fail criteria for a "5.25" optical drive". If the device does not follow section 6.1.2, Figure 18 then:
 - a) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 3.50 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.40 mm.
 - c) From the centerline of the drive to the centerline of the SATA plug shall be 42.90 +/- 0.38 mm.
 - d) From the back surface of the drive (i.e. the "end of the device factor") to the base of the tongue of the SATA plug shall be 4.90 +/- 0.50 mm.
- For a 3.5" device:
 - a1) From the centerline of the side mounting holes to the top of the tongue of the SATA plug shall be 2.85 +/- 0.38 mm.
 - a2) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 3.50 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.25 mm.
 - c) From the centerline of the drive to the centerline of the SATA plug shall be 20.68 +/- 0.38 mm.
 - d1) From the centerline of the side mounting holes to the base of the tongue of the SATA plug shall be 23.60 +/- 0.50 mm.

- d2) From the centerline of the bottom mounting holes to the base of the tongue of the SATA plug shall be 36.38 +/- 0.50 mm.
- For a 2.5" device:
 - a1) From the centerline of the side mounting holes to the top of the tongue of the SATA plug shall be 0.50 +/- 0.38 mm.
 - a2) From the bottom surface of the drive to the top of the tongue of the SATA plug shall be 3.50 +/- 0.38 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the bottom surface of the drive shall be 0.25 mm.
 - c) From the centerline of the drive to the centerline of the SATA plug shall be 4.80 +/- 0.38 mm.
 - d1) From the centerline of the side mounting holes to the base of the tongue of the SATA plug shall be 9.40 +/- 0.50 mm.
 - d2) From the centerline of the bottom mounting holes to the base of the tongue of the SATA plug shall be 9.40 +/- 0.50 mm.
- For a 1.8" uSATA device (5.0 mm and 8.0 mm):
 - a) From the bottom surface of the drive to the top of the tongue shall be 78.5 +/- 0.3 mm.
 - b) Parallelism of the top of the tongue of the SATA plug vs. the top surface of the drive shall be 0.40 mm maximum.
 - c) From the centerline of the drive to the centerline of the SATA plug shall be 0.0 +/- 0.20 mm.
 - d) From the back surface of the drive (i.e. the "end of the device factor") to the base of the tongue of the SATA plug shall be 4.9 mm +/- 0.08 mm.
 - e) The Thickness of both sides of the drive shall be 3.30 +/- 0.2 mm.

2.8.2. MDI-02 : Visual and Dimensional Inspections

2.8.2.1. Device Expected Behavior

See section 6.1.10.2, Table 5 of the Serial ATA Revision 2.6 Specification.

See section 6.3 of the Serial ATA Revision 2.6 specification for Slimline ATAPI device requirements.

See section 6.2.4 of the Serial ATA Revision 2.6 specification for 1.8" uSATA device requirements.

Measurement Requirements

- For Slimline optical device see section 6.3.4.1, Figures 61 and 62 of the Serial ATA Revision 2.6 Specification.
- For 1.8" uSATA see section 6.2.4, Figure 54 of the Serial ATA Revision 2.6 specification.
- For all other devices, see section 6.1.10.2, Table 5; section 6.1.2, Figure 26; and section 6.1.3.1, Figures 27 and 28 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

- NOTE: all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.

For Slimline devices

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.
- b) If the "Optional Wall" of Figure 62 is present then the distance from the device plug tongue to the wall shall be 1.58 +/- 0.08 mm.
- c) If the "Optional Wall" of Figure 62 is not present then there shall be a minimum of a 1.50 mm keep out zone from Datum A of Figure 62 to the nearest obstruction.
- d) The combined width of the power and signal segments shall be 20.4 +/- 0.08 mm.
- e) The separation between the power and signal segments shall be 2.34 +/- 0.05 mm.

For 1.8" uSATA devices:

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.
- b) The combined width of the power and signal segments shall be 27.04 +/- 0.06 mm.
- c) The separation between the power and signal segments shall be 2.41 +/- 0.05 mm.

For all other devices:

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.

- b) If the “Optional Wall” of Figure 28 is present then the distance from the device plug tongue to the wall shall be 1.58 +/- 0.08 mm.
- c) If the “Optional Wall” of Figure 28 is not present then there shall be a minimum of a 1.5 mm keep out zone from Datum A of Figure 26 to the nearest obstruction.
- d) The combined width of the power and signal segments shall be 33.39 +/- 0.08 mm.
- e) The separation between the power and signal segments shall be 2.41 +/- 0.05 mm.

2.9. Mechanical – Device - Power Connector

2.9.1. MDP-01 : Visual and Dimensional Inspections

2.9.1.1. Device Expected Behavior

See section 6.1.10.2, Table 6 of the Serial ATA Revision 2.6 specification.

See section 6.3 of the Serial ATA Revision 2.6 specification for slimline ATAPI device requirements.

See section 6.2.4 of the Serial ATA Revision 2.6 specification for uSATA device requirements.

Measurement Requirements

- For a Slimline optical device see section 6.3.4.1, Figure 61 and 62 of the Serial ATA Revision 2.6 specification.
- For 1.8” uSATA devices see section 6.2.4, Figure 54 of the Serial ATA Revision 2.6 specification.
- For all other devices, see section 6.1.10.2, Table 6; section 6.1.2, Figure 26; and section 6.1.3.1, Figures 27 and 28 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

- NOTE : all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.

For Slimline devices:

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.
- b) If the “Optional Wall” of Figure 62 is present then the distance from the device plug tongue to the wall shall be 1.58 +/- 0.08 mm.
- c) If the “Optional Wall” of Figure 62 is not present then there shall be a minimum of a 1.5 mm keep out zone from Datum A of Figure 62 to the nearest obstruction.

For 1.8” uSATA devices:

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.

For all other devices except:

- a) The thickness of the device plug tongue shall be 1.23 +/- 0.05 mm.
- b) If the “Optional Wall” of Figure 28 is present then the distance from the device plug tongue to the wall shall be 1.58 +/- 0.08 mm.
- c) If the “Optional Wall” of Figure 28 is not present then there shall be a minimum of a 1.5 mm keep out zone from Datum A of Figure 26 to the nearest obstruction.

2.10. Mechanical – Host - Standard Internal Connector

2.10.1. MHI-01 : Visual and Dimensional Inspections (Informative)

2.10.1.1. Cable Assembly Expected Behavior

See section 6.1.5 of the Serial ATA Revision 2.6 specification.

See section 6.3 of the Serial ATA Revision 2.6 specification for slimline ATAPI device requirements.

Measurement Requirements

- For a Slimline host, see section 6.3.4.2, Figure 72 of the Serial ATA Revision 2.6 specification.
- For all other hosts, see section 6.1.5, Figure 32 of the Serial ATA Revision 2.6 specification.

Pass/Fail Criteria

- NOTE : all applicable measurements within this test must be verified as a pass for the overall result of this test requirement to be reported as a PASS.

For Slimline hosts:

- a) (TBD – next major revision)

For all other hosts:

- a) Gap between tongue to edge of blind mate key shall be 1.65 +/- 0.15 mm
- b) Gap between tongue to blind mate key shall be 2.65 +/- 0.08 mm
- c) Gap between tongue and 2nd wall shall be a minimum of 1.10 mm
- d) Width of tongue shall be 10.41 +/- 0.08 mm
- e) Width of short leg of "L" shall be 1.15 +/- 0.05 mm
- f) Depth of tongue (from tip to base) shall be 5.40 +/- 0.08 mm
- g) Inside width of the blind mate key shall be 2.20 +/- 0.15 mm
- h) Thickness of tongue shall be 1.23 +/- 0.05 mm
- i) Gap between tongue and keep out or optional latching wall shall be 1.58 +/- 0.08 mm

2.11. Mechanical – Drive/Host – eSATA Connector (informative)

2.11.1. MXE-01 : Visual and Dimension Inspection

2.11.1.1. Expected Behavior

See overview and references to Serial ATA Revision 2.6 specification.

Measurement Requirements

See section 6.4.1, Figure 81 – 85 of the Serial ATA Revision 2.6 specification.

Figure 81 through 85 specified mechanical dimensions of external RA SMT plug, RA SMT plug- reversed pin out, RA through-hole plug, vertical SMT plug and vertical through-hole plug respectively. The following Pass/Fail criteria uses RA SMT plug (Figure 81) as an example. Other types of plugs (Figure 82 – 85) should follow the same criteria accordingly.

Pass/Fail Criteria

All applicable parts must pass for the test to pass:

- a) The height of the slot in RA SMT plug shall be 4.10 +/- 0.1 (Figure 81-85)
- b) The height of the slot (for receptacle key) shall be 1.50 +/- 0.08 (Figure 81-85)
- c) The thickness of the plug tongue shall be 1.20 +/- 0.05 (Figure 81-85)
- d) The width of the plug tongue shall be 10.00 +/- 0.05 (Figure 81-85)
- e) The width of the slot (for receptacle key) shall be 15.00 +/- 0.05 (Figure 81-85)
- f) The width of the bottom slot (for receptacle wall) shall be 13.00 +/- 0.05 (Figure 81-85)
- g) The width of the top slot (for receptacle) shall be 10.00 +/- 0.05 (Figure 81-85)
- h) The retention springs (x4) of the plug connector shall have the spring tip aligned with the datum (Y) within 4.10 +/- 0.1 (Figure 81-85)
- i) *Informative - The retention springs (x4) of the plug connector should have width 1.50 +/- 0.1 (Figure 81-85)*
- j) *Informative - The retention springs (x4) of the plug connector should be bilaterally located with the centerline within 6.80 +/- 0.1 (Figure 81-85)*
- k) *Informative - The length of the contact blades should be 4.25 +/- 0.1 for 4 ea signal pins and 4.75 +/- 0.1 for 3 ea ground pins as measured from datum plane Y (Figure 81-85).*

2.12. Phy General Requirements

2.12.1. PHY-01 : Unit Interval

2.12.1.1. Device/Host Expected Behavior

See section 7.2.2.1.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.11 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement must be tested at both interface rates (1.5Gb/s and 3Gb/s).

Pass/Fail Criteria

- PHY-01a - Mean Unit Interval measured between 666.4333ps (min) to 670.2333ps (max) (for products running at 1.5Gb/s)
- PHY-01b - Mean Unit Interval measured between 333.2167ps (min) to 335.1167ps (max) (for products running at 3Gb/s)
- The values above shall be based on at least 100,000 UIs (covers at least one SSC profile)

2.12.2. PHY-02 : Frequency Long Term Stability

2.12.2.1. Device/Host Expected Behavior

This test is not applicable to products that support SSC.

See section 7.2.2.1.4 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.6 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).
- The execution of this test must include use of the low pass filter defined within section 7.4.11 of Serial ATA Revision 2.6.

Pass/Fail Criteria

- f_{tol} measured between -350ppm and 350ppm

2.12.3. PHY-03 : Spread-Spectrum Modulation Frequency

2.12.3.1. Device/Host Expected Behavior

See sections 7.2.2.1.5 and 7.3.3 of Serial ATA Revision 2.6.

This test requires support for Spread Spectrum Clocking (SSC), which is optional.

Measurement Requirements

- See section 7.4.11 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).

Pass/Fail Criteria

- f_{SSC} measured between 30kHz and 33kHz
- The value above shall be based on a mean of at least 10 complete SSC cycles

2.12.4. PHY-04 : Spread-Spectrum Modulation Deviation

2.12.4.1. Device/Host Expected Behavior

See sections 7.2.2.1.6 and 7.3.3 of Serial ATA Revision 2.6.

This test requires support for Spread Spectrum Clocking (SSC), which is optional.

Measurement Requirements

- See section 7.4.11 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).
- The value reported as the result must be the single total range value relative to nominal of the SSC modulation deviation, using the equations below, where “Min” is the mean of 10 recorded values of the minimum peaks and “Max: is the mean of 10 recorded values of the maximum peaks.
- Calculate max deviation = (Measured Max – Nominal)/Nominal * 1e6 ppm
- Calculate min deviation = (Measured Min – Nominal)/Nominal * 1e6 ppm

Pass/Fail Criteria

- a) Max SSC_{tol} measured (using mean of 10 recorded values) less than +350ppm.
- b) Min SSC_{tol} measured (using mean of 10 recorded values) greater than -5350ppm.

2.13. Phy Transmitter Requirements

During the testing execution for all TX test requirements, it is essential that the product under test be able to complete an initial OOB sequence through the device COMWAKE. This is to allow product calibration to occur prior to and/or during the initial power on and detect sequences.

2.13.1. TX-01 : Pair Differential Impedance

2.13.1.1. Device/Host Expected Behavior

See section 7.2.2.2.1 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.22 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- Verify that both the minimum [TX-01a] and maximum [TX-01b] results for the pair differential impedance measured between 85 ohms and 115 ohms (for products running at 1.5Gb/s)
- NOTE : The verification of this result may not be required. If a product which supports 1.5Gb/s product passes TX-06, then it is not required that this test be verified. This result must be verified for a 1.5Gb/s product if it fails TX-06.

2.13.2. TX-02 : Single-Ended Impedance (Obsolete)

2.13.2.1. Device/Host Expected Behavior

See section 7.2.2.2.2 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.23 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- Z_{s-eTX} measured to be at least 40 ohms (for products running at 1.5Gb/s)
- Both the minimum [TX-02a] and the maximum [TX-02b] results shall be captured

2.13.3. TX-03 : Gen2 (3Gb/s) Differential Mode Return Loss

2.13.3.1. Device/Host Expected Behavior

See section 7.2.2.2.3 of Serial ATA Revision 2.6+.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- Calibrate to the end of the SMA cables, but do NOT include (de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DD11,TX}$ measured per the values in Table 2 (for products running at 3Gb/s)

Table 2 - TX Differential Mode Return Loss for 3Gb/s

Test name	Frequency	Minimum (dB)
TX-03a	150MHz-300MHz	14
TX-03b	300MHz-600MHz	8
TX-03c	600MHz-1.2GHz	6
TX-03d	1.2GHz-2.4GHz	6
TX-03e	2.4GHz-3.0GHz	3 (N/A for Gen1m)
TX-03f	3.0GHz-5.0GHz	1 (N/A for Gen1m or Gen2m)

2.13.4. TX-04 : Gen2 (3Gb/s) Common Mode Return Loss

2.13.4.1. Device/Host Expected Behavior

See section 7.2.2.2.4 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.

- Calibrate to the end of the SMA cables, but do NOT include (de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{CC11,TX}$ measured per the values in Table 3 (for products running at 3Gb/s)

Table 3 - TX Common Mode Return Loss for 3Gb/s

Test name	Frequency	Minimum (dB)
TX-04a	150MHz-300MHz	8
TX-04b	300MHz-600MHz	5
TX-04c	600MHz-1.2GHz	2
TX-04d	1.2GHz-2.4GHz	1
TX-04e	2.4GHz-3.0GHz	1
TX-04f	3.0GHz-5.0GHz	1

2.13.5. TX-05 : Gen2 (3Gb/s) Impedance Balance

2.13.5.1. Device/Host Expected Behavior

See section 7.2.2.2.5 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DC11,TX}$ measured per the values in Table 4 (for products running at 3Gb/s)

Table 4 - TX Impedance Balance

Test name	Frequency	Minimum (dB)
TX-05a	150MHz-300MHz	30
TX-05b	300MHz-600MHz	20
TX-05c	600MHz-1.2GHz	10
TX-05d	1.2GHz-2.4GHz	10
TX-05e	2.4GHz-3.0GHz	4
TX-05f	3.0GHz-5.0GHz	4 (N/A for test Gen2m)

2.13.6. TX-06 : Gen1 (1.5Gb/s) Differential Mode Return Loss

2.13.6.1. Device/Host Expected Behavior

See section 7.2.2.2.3 of Serial ATA Revision 2.6..

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- Calibrate to the end of the SMA cables, but do NOT include (de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during transmission of the Mid Frequency Test Pattern (MFTP), The amplitude of a TDR pulse or excitation applied to an active transmitter shall not exceed 139mVpp (-13.2dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DD11,TX}$ measured per the values in Table 5 (for products running at 1.5Gb/s)

Table 5 - TX Differential Mode Return Loss for 1.5Gb/s

Test name	Frequency	Minimum (dB)
TX-06a	75MHz-150MHz	14
TX-06b	150MHz-300MHz	8
TX-06c	300MHz-600MHz	6
TX-06d	600MHz-1.2GHz	6
TX-06e	1.2GHz-2.4GHz	3 (N/A for test Gen1m)
TX-06f	2.4GHz-3.0GHz	1 (N/A for Gen1m or Gen2m)

2.14. Phy Transmit Signal Requirements

During the testing execution for all TSG test requirements, it is essential that the product under test be able to complete an initial OOB sequence through the device COMWAKE prior to transmission of a BIST FIS or initiation of the BIST mode sequence. This is to allow product calibration to occur prior to and/or during the initial power on and detect sequences.

Tester must save all the calibration data (i.e. screen shot) that is done daily at a minimum, if not every device evaluation. Valid calibration data must be available per product for review, even if the same calibration data (i.e. daily) is used for multiple products. It is required that calibration be completed for this area of testing to ensure consistent measurements and environment impacts.

2.14.1. TSG-01 : Differential Output Voltage

2.14.1.1. Device/Host Expected Behavior

See section 7.2.2.3.1 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.4 and section 7.4.2.1 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement must be tested at both interface rates (1.5Gb/s and 3Gb/s).
- For the interests of the Interoperability Program, the measurements will only be taken to verify this requirement at the minimum limit. Within the specification, there are two options for measuring the minimum:
 - $V_{test} = \min(DH, DM, V_{testLBP}) - 1.5Gb/s$ [TSG-01a], 3 Gb/s [TSG-01g]

- $V_{test} = \min(DH, DM, V_{testAPP}) - 1.5\text{Gb/s [TSG-01b]}, 3\text{ Gb/s [TSG-01h]}$
- Note that gathering a minimum result from either of the options above is acceptable. It is not required to report a result for both.
- Note that the pu/pl measurements outlined in the specification are to be taken, but the results are informative. There is not verification of maximum limit values for this measurement.

Table 5 – Diff Output voltage pu/pl test name matrix

Pattern	Interface Rate	
	1.5 Gb/s	3 Gb/s
MFTP – pu	TSG-01c	TSG-01i
MFTP – pl	TSG-01d	TSG-01j
LFTP – pu	TSG-01e	TSG-01k
LFTP - pl	TSG-01f	TSG-01l

Pass/Fail Criteria

- $V_{diffTX}(\text{min})$ measured to be (for products running at 1.5Gb/s and 3Gb/s):
 - Minimum : V_{Test} at least 400 mVppd

2.14.2. TSG-02 : Rise/Fall Time

2.14.2.1. Device/Host Expected Behavior

See section 7.2.2.3.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.3 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement must be tested at both interface rates (1.5Gb/s and 3Gb/s).
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the High Frequency Test Pattern (HFTP) as defined in the SATA Revision 2.6 specification.

Table 6 – TX Rise/Fall Test Name matrix

Pattern	Interface Rate	
	1.5 Gb/s	3 Gb/s
HFTP rise	TSG-02a	TSG-02c
HFTP fall	TSG-02b	TSG-02d

Pass/Fail Criteria

- $t_{20-80TX}$ measured per the Max values in Table 6
- Note: Failures at minimum rate have not been shown to affect interoperability and will not be included in determining pass/fail for Interop testing

Table 7 - TX Rise/Fall Time

Limit	Time @ 1.5Gb/s (ps (UI))	Time @ 3Gb/s (ps (UI))
Min 20-80%	100 (0.15)	67 (0.20)
Max 20-80%	273 (0.41)	136 (0.41)

2.14.3. TSG-03 : Differential Skew

2.14.3.1. Device/Host Expected Behavior

See section 7.2.2.3.4 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.12 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).
- DC blocks or software/hardware equivalent shall be used.
- Please note that this requires measuring the mean skew of TX+ rise mid-point to the TX- fall mid-point and the mean skew of TX+ fall mid-point to TX- rise mid-point, as stated in 7.2.2.3.4, and then computing the Differential Skew = average of the magnitude (absolute value) of the two mean skews. This removes the effect of rise-fall imbalance from the skew measurement.

Pass/Fail Criteria

- t_{skewTX} measured at a maximum of 20 ps
- The value above shall be based on at least 10,000 UIs

2.14.4. TSG-04 : AC Common Mode Voltage

2.14.4.1. Device/Host Expected Behavior

See section 7.2.2.3.5 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.17 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.

Pass/Fail Criteria

- $V_{cm,acTX}$ measured at a maximum of 50 mVp-p (for products running at 3Gb/s)

2.14.5. TSG-05 : Rise/Fall Imbalance

2.14.5.1. Device/Host Expected Behavior

See section 7.2.2.3.9 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.16 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.

Table 8 – Rise / Fall Imbalance test name matrix

From edge	To edge	Test Name	
		HFTP	MFTP

TX+ rise	TX- fall	TSG-05a	TSG-05c
TX+ fall	TX- rise	TSG-05b	TSG-05d

Pass/Fail Criteria

- Mean R/F_{bal} measured at a maximum of 20% (for products running at 3Gb/s)
- The value above shall be based on at least 10,000 UIs

2.14.6. TSG-06 : Amplitude Imbalance

2.14.6.1. Device/Host Expected Behavior

See section 7.2.2.3.10 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.15 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.
- Due to characteristics of the MFTP, it is required the measurement points be taken at 0.5UI of the 2nd bit within the pattern. All amplitude values for this measurement shall be the statistical mode measured at 0.5 UI nominal over a minimum of 10,000 UI.
- The amplitude imbalance (Amp_{bal}) for each UI shall be computed using the following formula (directly from Sec 7.4.15 of Serial ATA Revision 2.6):
 - $ABS(TX+ \text{ amplitude} - TX- \text{ amplitude}) / ((TX+ \text{ amplitude} + TX- \text{ amplitude})/2)$
- Results for HFTP [TSG-06a] and MFTP [TSG-06b] shall be captured.

Pass/Fail Criteria

- The Amp_{bal} shall not exceed a maximum of 10% (for products running at 3Gb/s)

2.14.7. TSG-07 : Gen1 (1.5Gb/s) TJ at Connector, Clock to Data, f_{BAUD}/10 (Obsolete)

2.14.7.1. Device/Host Expected Behavior

See sections 7.2.2.3.11 and 7.3 of Serial ATA Revision 2.6.

This test is informative for all products.

Measurement Requirements

- See section 7.4.8 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement would be tested at 1.5Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-07a], and Lone Bit Pattern (LBP) [TSG-07b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-07c] as a third pattern.
- For this test, the methodology of obtaining the result must follow the Clock-to-Data Transmit Jitter method outlined in section 7.2.2.3.12 in SATA Revision 2.6, similar to that for obtaining 3Gb/s results for TSG-11 and

TSG-12. In the past, a Data-to-Data Transmit Jitter (see section 7.2.2.3.11 in SATA Revision 2.6) method was used but is no longer preferred for the use of the interoperability testing.

Pass/Fail Criteria

- TJ measured at a maximum of 0.30 UI when measured at $f_{\text{BAUD}}/10$ (for products running at 1.5Gb/s)

2.14.8. TSG-08 : Gen1 (1.5Gb/s) DJ at Connector, Clock to Data, $f_{\text{BAUD}}/10$ (Obsolete)

2.14.8.1. Device/Host Expected Behavior

See sections 7.2.2.3.11 and 7.3 of Serial ATA Revision 2.6.

This test is informative for all products.

Measurement Requirements

- See section 7.4.8 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement would be tested at 1.5Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-08a], and Lone Bit Pattern (LBP) [TSG-08b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-08c] as a third pattern.
- For this test, the methodology of obtaining the result must follow the Clock-to-Data Transmit Jitter method outlined in section 7.2.2.3.12 in SATA Revision 2.6, similar to that for obtaining 3Gb/s results for TSG-11 and TSG-12. In the past, a Data-to-Data Transmit Jitter (see section 7.2.2.3.11 in SATA Revision 2.6) method was used but is no longer preferred for the use of the interoperability testing.

Pass/Fail Criteria

- DJ measured at a maximum of 0.17 UI when measured at $f_{\text{BAUD}}/10$ (for products running at 1.5Gb/s)

2.14.9. TSG-09 : Gen1 (1.5Gb/s) TJ at Connector, Clock to Data, $f_{\text{BAUD}}/500$

2.14.9.1. Device/Host Expected Behavior

See sections 7.2.2.3.11 and 7.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.8 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement must be tested at 1.5Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-09a], and Lone Bit Pattern (LBP) [TSG-09b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-09c] as a third pattern.
- For this test, the methodology of obtaining the result must follow the Clock-to-Data Transmit Jitter method outlined in section 7.2.2.3.12 in SATA Revision 2.6, similar to that for obtaining 3Gb/s results for TSG-11 and

TSG-12. In the past, a Data-to-Data Transmit Jitter (see section 7.2.2.3.11 in SATA Revision 2.6) method was used but is no longer preferred for the use of the interoperability testing.

Pass/Fail Criteria

- TJ measured at a maximum of 0.37 UI when measured at $f_{\text{BAUD}}/500$ (for products running at 1.5Gb/s)
 - NOTE : Due to the nature of taking this measurement with the Clock-to-Data method, the specification requirement is aligned to that of the Clock-to-Data requirement of 3Gb/s products.

2.14.10. TSG-10 : Gen1 (1.5Gb/s) DJ at Connector, Clock to Data, $f_{\text{BAUD}}/500$

2.14.10.1. Device/Host Expected Behavior

See sections 7.2.2.3.11 and 7.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.8 of Serial ATA Revision 2.6.
- For products which support 3Gb/s, this requirement must be tested at 1.5Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-10a], and Lone Bit Pattern (LBP) [TSG-10b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-10c] as a third pattern.
- For this test, the methodology of obtaining the result must follow the Clock-to-Data Transmit Jitter method outlined in section 7.2.2.3.12 in SATA Revision 2.6, similar to that for obtaining 3Gb/s results for TSG-11 and TSG-12. In the past, a Data-to-Data Transmit Jitter (see section 7.2.2.3.11 in SATA Revision 2.6) method was used but is no longer preferred for the use of the interoperability testing.

Pass/Fail Criteria

- DJ measured at a maximum of 0.19 UI when DJ measured at $f_{\text{BAUD}}/500$ (for products running at 1.5Gb/s)
 - NOTE: Due to the nature of taking this measurement with the Clock-to-Data method, the specification requirement is aligned to that of the Clock-to-Data requirement of 3Gb/s products.

2.14.11. TSG-11 : Gen2 (3Gb/s) TJ at Connector, Clock to Data, $f_{\text{BAUD}}/500$

2.14.11.1. Device/Host Expected Behavior

See sections 7.2.2.3.12 and 7.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See sections 7.4.6 and 7.4.8 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-11a], and Lone Bit Pattern (LBP) [TSG-11b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-11c] as a third pattern.

Pass/Fail Criteria

- TJ measured at a maximum of 0.37 UI when measured at $f_{\text{BAUD}}/500$ (for products running at 3Gb/s)

2.14.12. TSG-12 : Gen2 (3Gb/s) DJ at Connector, Clock to Data, $f_{\text{BAUD}}/500$

2.14.12.1. Device/Host Expected Behavior

See sections 7.2.2.3.12 and 7.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See sections 7.4.6 and 7.4.8 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.
- The loop damping factor for the reference PLLs is required to be 0.707.
- There are several different patterns defined within the specification and are intended to be used to verify this requirement. In order to ensure efficient test time of products within the Interoperability Testing, testing of this requirement will be limited to the following patterns as defined in the SATA Revision 2.6 specification: High Frequency Test Pattern (HFTP) [TSG-12a], and Lone Bit Pattern (LBP) [TSG-12b]. It is optional to additionally test using the Simultaneous Switching Outputs Pattern (SSOP) [TSG-12c] as a third pattern.

Pass/Fail Criteria

- DJ measured at a maximum of 0.19 UI when measured at $f_{\text{BAUD}}/500$ (for products running at 3Gb/s)

2.15. Phy Receiver Requirements

During the testing execution for all RX test requirements, it is essential that the product under test be able to complete an initial OOB sequence through the device COMWAKE. This is to allow product calibration to occur prior to and/or during the initial power on and detect sequences.

2.15.1. RX-01 : Pair Differential Impedance

2.15.1.1. Device/Host Expected Behavior

See section 7.2.2.4.1 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.22 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- Verify that both the minimum [RX-01a] and maximum [RX-01b] results for the pair differential impedance measured between 85 ohms and 115 ohms (for products running at 1.5Gb/s)
- NOTE : The verification of this result may not be required. If a product which supports 1.5Gb/s product passes RX-06, then it is not required that this test be verified. This result must be verified for a 1.5Gb/s product if it fails RX-06.

2.15.2. RX-02 : Single-Ended Impedance (Obsolete)

2.15.2.1. Device/Host Expected Behavior

See section 7.2.2.4.2 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.23 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- Z_{s-eRX} measured to be at least 40 ohms (for products running at 1.5Gb/s)
- Both the minimum [RX-02a] and the maximum [RX-02b] results shall be captured

2.15.3. RX-03 : Gen2 (3Gb/s) Differential Mode Return Loss

2.15.3.1. Device/Host Expected Behavior

See section 7.2.2.4.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- Calibrate to the end of the SMA cables, but do NOT include (i.e. de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DD11,RX}$ measured per the values in Table 9 – RX Differential Mode Return Loss (for products running at 3Gb/s)

Table 9 – RX Differential Mode Return Loss

Test name	Frequency	Minimum (dB)
RX-03a	150MHz-300MHz	18
RX-03b	300MHz-600MHz	14
RX-03c	600MHz-1.2GHz	10
RX-03d	1.2GHz-2.4GHz	8
RX-03e	2.4GHz-3.0GHz	3
RX-03f	3.0GHz-5.0GHz	1

2.15.4. RX-04 : Gen2 (3Gb/s) Common Mode Return Loss

2.15.4.1. Device/Host Expected Behavior

See section 7.2.2.4.4 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- Calibrate to the end of the SMA cables, but do NOT include (de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{CC11,RX}$ measured per the values in Table 10 - RX Common Mode Return Loss (for products running at 3Gb/s)

Table 10 - RX Common Mode Return Loss

Test name	Frequency	Minimum (dB)
RX-04a	150MHz-300MHz	5
RX-04b	300MHz-600MHz	5
RX-04c	600MHz-1.2GHz	2
RX-04d	1.2GHz-2.4GHz	1
RX-04e	2.4GHz-3.0GHz	1
RX-04f	3.0GHz-5.0GHz	1

2.15.5. RX-05 : Gen2 (3Gb/s) Impedance Balance

2.15.5.1. Device/Host Expected Behavior

See section 7.2.2.4.5 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- This test requirement is only applicable to products running at 3Gb/s.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DC11,RX}$ measured per the values in Table 11 - RX Impedance Balance (for products running at 3Gb/s)

Table 11 - RX Impedance Balance

Test name	Frequency	Minimum (dB)
RX-05a	150MHz-300MHz	30
RX-05b	300MHz-600MHz	30
RX-05c	600MHz-1.2GHz	20

RX-05d	1.2GHz-2.4GHz	10
RX-05e	2.4GHz-3.0GHz	4
RX-05f	3.0GHz-5.0GHz	4 (N/A for test Gen2m)

2.15.6. RX-06 : Gen1 (1.5Gb/s) Differential Mode Return Loss

2.15.6.1. Device/Host Expected Behavior

See section 7.2.2.2.3 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.10 of Serial ATA Revision 2.6.
- Calibrate to the end of the SMA cables, but do NOT include (de-embed) the SMA to SATA PCB and the SATA connector, so the board and the SATA connector are INCLUDED with the product measurement.
- This test requirement is only applicable to products running at 1.5Gb/s. For products which support 3Gb/s, this test is not required.
- Testing of this requirement must be completed during a PHYRDY Interface Power State (see section 8.1. of SATA Revision 2.6). The amplitude of a TDR pulse or excitation applied to a receiver shall not exceed 300mVpp (-6.48dBm 50 ohms) single ended.

Pass/Fail Criteria

- $RL_{DD11,RX}$ measured per the values in Table 12 - RX Differential Mode Return Loss for 1.5Gb/s (for products running at 1.5Gb/s)

Table 12 - RX Differential Mode Return Loss for 1.5Gb/s

Test name	Frequency	Minimum (dB)
RX-06a	75MHz-150MHz	18
RX-06b	150MHz-300MHz	14
RX-06c	300MHz-600MHz	10
RX-06d	600MHz-1.2GHz	8
RX-06e	1.2GHz-2.4GHz	3
RX-06f	2.4GHz-3.0GHz	1

2.16. Phy Receive Signal Requirements

During the testing execution for all RSG test requirements, it is essential that the product under test be able to complete an initial OOB sequence through the device COMWAKE prior to transmission of a BIST FIS or initiation of the BIST mode sequence. This is to allow product calibration to occur prior to and/or during the initial power on and detect sequences.

Note: The intent of the receiver test is to stress test the PUT's receiver and integrated components, to validate that the system can tolerate the prescribed impaired signals inline with table 31 and section 7.2.2.1.2 of the SATA 2.6 Specification.

Tester must save all the calibration data (i.e. screen shot) that is done daily at a minimum, if not every device evaluation. Valid calibration data must be available per product for review, even if the same calibration data (i.e. daily) is used for multiple products. It is required that calibration be completed for this area of testing to ensure consistent measurements and environment impacts.

The reference plane is the end of the 50 ohm SMA cables that will be connected to the SATA-SMA test fixture.

The following parameters are to be used for creating the appropriate input source involved in the RSG tests (see Table 31 in SATA Revision 2.6 for specification requirements):

- No SSC
- Pre-emphasis : 0dB
- No CDR (Clock Data Recover unit) to be used for the jitter calibration. Real time scopes use a dataset derived clock, and BERTs use a 1.5 or 3 GHz square wave direct from the jitter source dependent on data rate. More details available in MOIs.
- Rise/Fall Time : 100 ps (20/80%)

2.16.1. RSG-01 : Gen1 (1.5Gb/s) Receiver Jitter Tolerance Test

2.16.1.1. Device/Host Expected Behavior

See sections 7.2.2.6.7 and 7.3 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.9 of Serial ATA Revision 2.6. See parameter detail at beginning of RSG section.

This test requirement is only applicable to products running at 1.5Gb/s.

For this test, the methodology of obtaining the appropriate configuration must follow the Clock-to-Data Transmit Jitter method outlined in section 7.2.2.3.12 in SATA Revision 2.6.

The following high level procedure is used to implement the defined Receiver Tolerance test:

- Calibrate a Random Jitter (RJ) source using Mid Frequency Test Pattern (MFTP) to 0.18 UI total
 - NOTE: Gen1 : 8.57 ps RMS (1 sigma for a 7 sigma 0.18 UI projection)
 - The source amplitude must be calibrated to approximately the appropriate minimum signal level outlined by Table 28 (Receiver Tolerance Testing).
 - **Gen1m 240mV**
 - Gen1i 325mV
- Add a Deterministic Jitter (DJ) source (of frequencies defined below) using a sinusoidal input on top of the existing RJ source using composite of minimum of 1 FRAMED COMP pattern until a Total Jitter (TJ) amount of 0.45 UI is reached for Gen1i / **Gen1m**.
 - For consistent transmission of the Framed Long COMP pattern, it is required that 2 ALIGNs are transmitted prior to SOF of the frame, and then subsequently every 256 Dwords.
 - The source amplitude must be re-calibrated to 325mV for Gen1i or 240mV for Gen1m using the LBP portion of the TSG-01 documented method on the COMP pattern (this must be done for each frequency step). Following this step, it is required to confirm that the maximum differential voltage does not exceed 600mV.

The above steps must be repeated and validated on the product under test for the frequencies listed below relative to the DJ input source.

- 10 MHz – RSG-01a
- 33 MHz – RSG-01b
- 62 MHz – RSG-01c
- 5 MHz – RSG-01d

The methods of implementation for test equipment must provide sufficient detail for implementing the above high level procedure using specific test equipment.

Pass/Fail Criteria

- Test is run for 20 minutes and verified to exhibit no more than zero frame errors for all four frequencies above (10 MHz, 33 MHz, 62 MHz, 5 MHz). In the case where at least 1000 errors are observed during test execution, the test iteration may stop (i.e. test time < 20 minutes for a specific frequency due to high number of errors).

2.16.2. RSG-02 : Gen2 (3Gb/s) Receiver Jitter Tolerance Test

2.16.2.1. Device/Host Expected Behavior

See sections 7.2.2.6.8 and 7.3 of Serial ATA Revision 2.6. See parameter detail at beginning of RSG section.

Measurement Requirements

See sections 7.4.7 and 7.4.9 of Serial ATA Revision 2.6.

This test requirement is only applicable to products running at 3Gb/s.

The following high level procedure is used to implement the defined Receiver Tolerance test:

- Calibrate a Random Jitter (RJ) source using Mid Frequency Test Pattern (MFTP) to 0.18 UI total
 - NOTE: Gen2 : 4.285 ps RMS (1 sigma for a 7 sigma 0.18 UI projection)
 - The source amplitude must be calibrated to the appropriate minimum signal level outlined by Table 28 (Receiver Tolerance Testing).
 - Gen2m 240mV
 - Gen2i 275mV
- Add a Deterministic Jitter (DJ) source (of frequencies defined below) using a sinusoidal input on top of the existing RJ source until a Total Jitter (TJ) amount of 0.45 UI is reached Gen2i / Gen2m.
 - For consistent transmission of the Framed Long COMP pattern, it is required that 2 ALIGNs are transmitted prior to SOF of the frame, and then subsequently every 256 Dwords.
 - The source amplitude must be re-calibrated to 275mV for Gen2i or 240mV for Gen2m using the LBP portion of the TSG-01 documented method on the COMP pattern (this must be done for each frequency step). Following this step, it is required to confirm that the maximum differential voltage does not exceed 750mV.

The above steps must be repeated and validated on the product under test for the frequencies listed below relative to the DJ input source.

- 10 MHz – RSG-02a
- 33 MHz – RSG-02b
- 62 MHz – RSG-02c
- 5 MHz – RSG-02d

The methods of implementation for test equipment must provide sufficient detail for implementing the above high level procedure using specific test equipment.

Pass/Fail Criteria

- Test is run for 20 minutes and verified to exhibit no more than zero frame errors all four frequencies above (10 MHz, 33 MHz, 62 MHz, 5 MHz). In the case where at least 1000 errors are observed during test execution, the test iteration may stop (i.e. test time < 20 minutes for a specific frequency due to high number of errors).

2.17. Phy OOB Requirements

Min and max pulse and gap widths shall consider both the +100mV and the -100mV edges for determining starting and ending times.

2.17.1. OOB-01 : OOB Signal Detection Threshold

2.17.1.1. Device/Host Expected Behavior

See section 7.2.2.7.1 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.20 of Serial ATA Revision 2.6.

For products which support 3Gb/s, this requirement must be tested at both interface rates (1.5Gb/s and 3Gb/s).

Note that the specification stipulates a Detection Threshold with value of V_{thresh} , where V_{thresh} is $50 \leq V_{\text{thresh}} \leq 200$ in millivolts (mV) for 1.5Gb/s devices, and where V_{thresh} is $75 \leq V_{\text{thresh}} \leq 200$ in millivolts (mV) for 3Gb/s devices. For the interests of the Interoperability Program, the measurements will only be taken to verify this requirement at the lower and upper limits. The signal amplitude level of the source generator shall be validated using a mode voltage measurement at 0.45 to 0.55 UI.

To execute this test on a device which supports 1.5Gb/s, a COMINIT/COMRESET burst is issued to the product at the following voltage threshold limits:

- OOB-01a - 40mV (at this limit, the product is expected to NOT detect the OOB signaling)
- OOB-01b - 210mV (at this limit, the product is expected to detect the OOB signaling)

To execute this test on a device which supports 3Gb/s, a COMINIT/COMRESET burst is issued to the product at the following voltage threshold limits:

- OOB-01c - 60mV (at this limit, the product is expected to NOT detect the OOB signaling)
 - NOTE : Tool resolution preference is even values, as opposed to 75mV
- OOB-01d - 210mV (at this limit, the product is expected to detect the OOB signaling)

NOTE: In a case where a device supports Asynchronous Signal Recovery, it is possible that a device may transmit COMINIT pro-actively and not in direct response to a COMRESET. In verification of this test requirement, it is essential that the tester be able to extract any COMINIT response which may be as a result of Asynchronous Signal Recovery, and simply verify COMINIT responses as a result of COMRESET receipt from the host.

Suggested test methodology requires sending the following test sequence continuously from a suitable generator:

6 x (COMINIT/COMRESET burst + 480UI_{OOB} gap) +
1 x (45,000UI_{OOB} gap)

- 1) Using a suitable instrument (e.g. real-time scope or equivalent) to observe a minimum continuous 2ms window, verify that the PUT consistently responds to each COMINIT/COMRESET burst.
- 2) Detection Tests: Changing the COMINIT/COMRESET burst amplitude values only, verify that the PUT continues to consistently respond to an COMINIT/COMRESET Burst amplitude value of 210mV.
- 3) No-Detection Tests: Changing the COMINIT/COMRESET burst amplitude values only, verify that the PUT consistently DOES NOT respond to an COMINIT/COMRESET burst amplitude value of 40mV for 1.5Gb/s products (60mV for 3Gb/s products), *with the exception of unsolicited COMINIT bursts due to ASR (see note above).*

Pass/Fail Criteria

- For products running at 1.5Gb/s:
 - OOB-01a - Verification of no product COMINIT/COMRESET detection at 40mV
 - OOB-01b - Verification of product COMINIT/COMRESET detection at 210mV
 - If any of the above cases fails, this is considered a failure by the product.
- For products running at 3Gb/s:
 - OOB-01c - Verification of no product COMINIT/COMRESET detection at 60mV
 - OOB-01d - Verification of product COMINIT/COMRESET detection at 210mV
 - If any of the above cases fails, this is considered a failure by the product.

2.17.2. OOB-02 : UI During OOB Signaling

2.17.2.1. Device/Host Expected Behavior

See section 7.2.2.7.2 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.11 of Serial ATA Revision 2.6.

This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).

Pass/Fail Criteria

- Mean UI_{OOB} measured to be between 646.67 ps and 686.67 ps over entire OOB burst

2.17.3. OOB-03 : COMINIT/RESET and COMWAKE Transmit Burst Length

2.17.3.1. Device/Host Expected Behavior

See section 7.2.2.7.3 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.21 of Serial ATA Revision 2.6.

This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).

Note that the requirement within the specification is called out in UI. For the interests of the Interoperability Program, the measured value (T) will be compared against the minimum and maximum values of a multiple of UI_{OOB} in nanoseconds, where $103.5 \leq T \leq 109.9$. The values above are obtained from the following formulas:

- $\text{Min (160)} = 646.67\text{ps (Min } UI_{OOB}) \times 160 = 103.5\text{ns}$
- $\text{Max (160)} = 686.67\text{ps (Max } UI_{OOB}) \times 160 = 109.9\text{ns}$

A minimum of 5 COMINIT/RESET and 5 COMWAKE bursts shall be captured and the mean of all captured values shall be report.

Pass/Fail Criteria

- Burst Length measured to be between minimum and maximum values of UI_{OOB} multiplied by 160 (in nanoseconds)

2.17.4. OOB-04 : COMINIT/RESET Transmit Gap Length

2.17.4.1. Device/Host Expected Behavior

See section 7.2.2.7.4 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.21 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).
- Note that the requirement within the specification is called out in UI. For the interests of the Interoperability Program, the measured value (T) will be compared against the minimum and maximum values of a multiple of UI_{OOB} in nanoseconds, where $310.4 \leq T \leq 329.6$. The values above are obtained from the following formulas:
 - $\text{Min (480)} = 646.67\text{ps (Min } UI_{OOB}) \times 480 = 310.4\text{ns}$
 - $\text{Max (480)} = 686.67\text{ps (Max } UI_{OOB}) \times 480 = 329.6\text{ns}$
- Per definition, devices will be validated against the COMINIT Transmit Gap Length and hosts will be verified against the COMRESET Transmit Gap Length. The requirement is the same in both cases.

Pass/Fail Criteria

- Gap Length measured to be between minimum and maximum values of UI_{OOB} multiplied by 480 (in nanoseconds)

2.17.5. OOB-05 : COMWAKE Transmit Gap Length

2.17.5.1. Device/Host Expected Behavior

See section 7.2.2.7.5 of Serial ATA Revision 2.6.

Measurement Requirements

- See section 7.4.21 of Serial ATA Revision 2.6.
- This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).
- Note that the requirement within the specification is called out in UI. For the interests of the Interoperability Program, the measured value (T) will be compared against the minimum and maximum values of a multiple of UI_{OOB} in nanoseconds, where $103.5 \leq T \leq 109.9$. The values above are obtained from the following formulas:
 - Min (160) = 646.67ps (Min UI_{OOB}) x 160 = 103.5ns
 - Max (160) = 686.67ps (Max UI_{OOB}) x 160 = 109.9ns

Pass/Fail Criteria

- Gap Length measured to be between minimum and maximum values of UI_{OOB} multiplied by 160 (in nanoseconds)

2.17.6. OOB-06 : COMWAKE Gap Detection Windows

2.17.6.1. Device/Host Expected Behavior

See section 7.2.2.7.6 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.21 of Serial ATA Revision 2.6.

This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).

Note that the specification stipulates a Detection Window with value of T, where T is $35 \leq T < 175$ in nanoseconds. For the interests of the Interoperability Program, the measurements will only be taken to verify this requirement at the lower and upper limits.

To execute this test, a COMWAKE is issued to the product at the following limits:

- $155UI_{OOB}$ (at this limit, the product is expected to respond with COMWAKE)
- $165UI_{OOB}$ (at this limit, the product is expected to respond with COMWAKE)
- $45UI_{OOB}$ (at this limit, the product is expected to NOT respond with COMWAKE)
- $266UI_{OOB}$ (at this limit, the product is expected to NOT respond with COMWAKE)

NOTE : There is no timing requirement for how soon following a host COMWAKE which the device must respond with a device COMWAKE, and vice versa. For test efficiency purposes, a tester is only required to wait for verification of device COMWAKE up to 100ms following de-qualification of host COMWAKE, and vice versa.

Suggested test methodology requires sending the following test sequence continuously from a suitable generator:

6 x (COMINIT/COMRESET burst + $480UI_{OOB}$ gap) +
1 x ($45,000UI_{OOB}$ gap) +
6 x (COMWAKE burst + $160UI_{OOB}$ gap) +
1 x ($130,000UI_{OOB}$ gap)

- 1) Using a suitable instrument (e.g. real-time scope or equivalent) to observe a minimum continuous 2ms window, verify that the PUT consistently responds to each OOB sequence by entering speed negotiation accordingly. Figure 2 below shows an example screen capture of typical PUT behavior for nominal COMINIT/COMRESET and COMWAKE gaps:

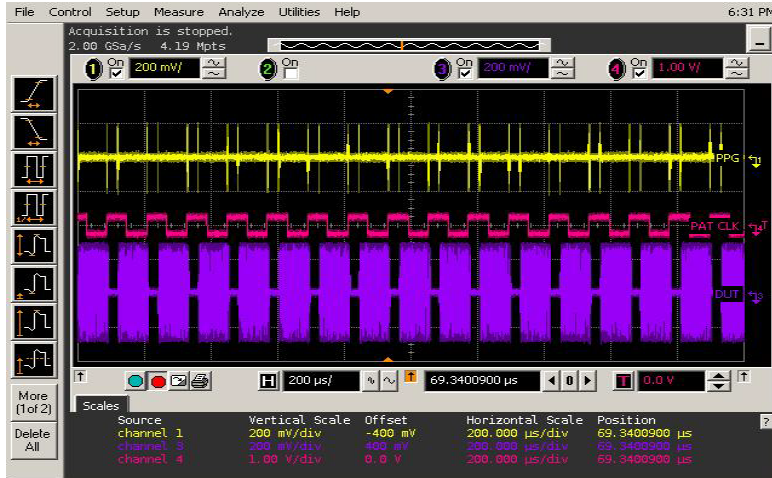


Figure - 2 Example OOB-06 test stimulus and PUT response, nominal COMINIT/COMRESET, COMWAKE (Test stimulus top, yellow. PUT response bottom, purple.)

- 2) Detection Tests: Changing the COMWAKE gap values only, verify that the PUT continues to consistently enter speed negotiation for gap values of 155 and 165UI_{OOB} (103.33 and 110ns, respectively)
- 3) No-Detection Tests: Changing the COMWAKE gap values only, verify that the PUT consistently DOES NOT enter speed negotiation for gap values of 45 and 266UI_{OOB} (30 and 177.33ns, respectively). An example screenshot of typical PUT behavior appears in Figure 3 below. (Note lack of speed negotiation sequence from PUT.)



Figure - 3 Example OOB-06 test stimulus and PUT response for out-of-range COMWAKE (Test stimulus top, yellow. PUT response bottom, purple.)

Pass/Fail Criteria

- OOB-06a - Verification of product COMWAKE response at 155U_{OOB}
- OOB-06b - Verification of product COMWAKE response at 165U_{OOB}
- OOB-06c - Verification of no product COMWAKE response at 45U_{OOB}
- OOB-06d - Verification of no product COMWAKE response at 266U_{OOB}
- If any of the above cases fails, this is considered a failure by the product.

2.17.7. OOB-07 : COMINIT/COMRESET Gap Detection Windows

2.17.7.1. Device/Host Expected Behavior

See section 7.2.2.7.7 of Serial ATA Revision 2.6.

Measurement Requirements

See section 7.4.21 of Serial ATA Revision 2.6.

This test is only run once at the maximum interface rate of the product (1.5Gb/s or 3Gb/s).

Note that the specification stipulates a Detection Window with value of T, where T is $175 \leq T < 525$ in nanoseconds. For the interests of the Interoperability Program, the measurements will only be taken to verify this requirement at the lower and upper limits.

To execute this test on a device, a COMRESET is issued to the device at the following limits:

- 459U_{OOB} (at this limit, the device is expected to respond with COMINIT)
- 501U_{OOB} (at this limit, the device is expected to respond with COMINIT)
- 259U_{OOB} (at this limit, the device is expected to NOT respond with COMINIT)
- 791U_{OOB} (at this limit, the device is expected to NOT respond with COMINIT)

NOTE : A device must respond by transmitting COMINIT within 10ms of de-qualification of a received COMRESET signal (see section 8.3.2 of Serial ATA Revision 2.6). With this in mind, a test only needs to wait up to 11ms following de-qualification of COMRESET to ensure that the device is responding. If no COMINIT is received in this timeframe, this is considered a failure by the device to this test.

NOTE : In a case where a device supports Asynchronous Signal Recovery, it is possible that a device may transmit COMINIT pro-actively and not in direct response to a COMRESET. In verification of this test requirement, it is essential that the tester be able to extract any COMINIT response which may be as a result of Asynchronous Signal Recovery, and simply verify COMINIT responses as a result of COMRESET receipt from the host.

To execute this test on a host, a COMINIT is issued to the host at the following limits:

- 459U_{OOB} (at this limit, the host is expected to respond with COMWAKE)
- 501U_{OOB} (at this limit, the host is expected to respond with COMWAKE)
- 259U_{OOB} (at this limit, the host is expected to NOT respond with COMWAKE)
- 791U_{OOB} (at this limit, the host is expected to NOT respond with COMWAKE)

Suggested test methodology requires sending the following test sequence continuously from a suitable generator:

6 x (COMINIT/COMRESET burst + 480U_{OOB} gap) +
1 x (45,000U_{OOB} gap)

- 1) Using a suitable instrument (e.g. real-time scope or equivalent) to observe a minimum continuous 2ms window, verify that the PUT consistently responds to each COMINIT/COMRESET. Figure 4 below shows a typical screen capture of proper PUT behavior for nominal COMINIT/COMRESET gaps:

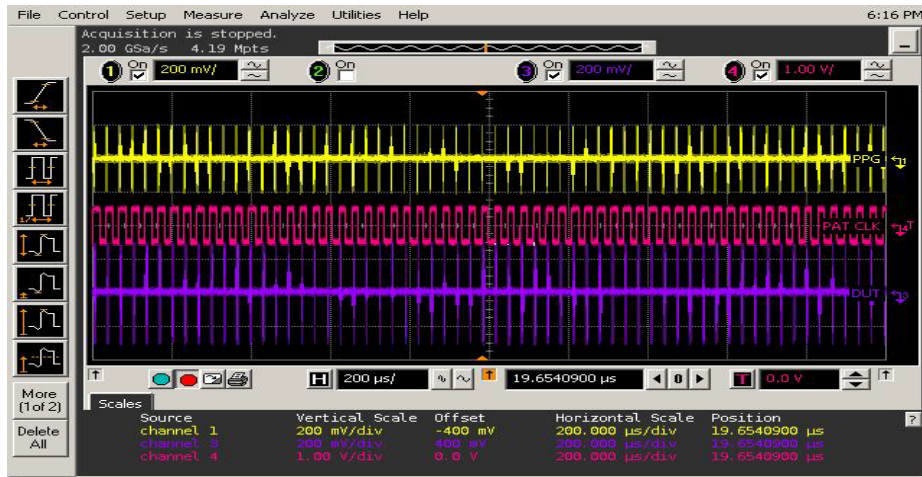


Figure - 4 Example OOB-07 test stimulus and PUT response, for nominal COMINIT/COMRESET gap (Test stimulus top, yellow. PUT response bottom, purple.)

- 2) Detection Tests: Changing the COMINIT/COMRESET gap values only, verify that the PUT continues to respond to gap values of $459U_{IOB}$ and $501U_{IOB}$ (306 and 334ns, respectively)
- 3) No-Detection Tests: Changing the COMINIT/COMRESET gap values only, verify that the PUT consistently DOES NOT respond to gap values of $259U_{IOB}$ and $791U_{IOB}$ (172.66 and 527.33ns, respectively), *with the exception of unsolicited COMINIT bursts due to ASR (see note above)*. An example screenshot of typical PUT behavior appears in Figure 5 below.

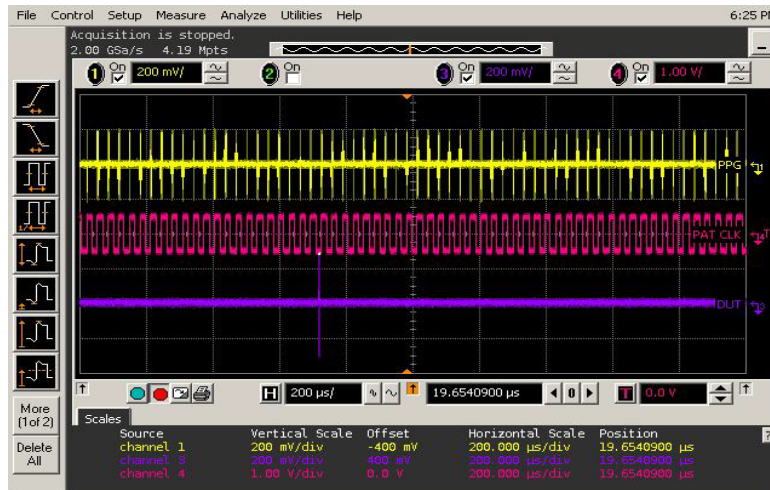


Figure - 5 Example OOB-07 test stimulus and PUT response for out-of-range COMINIT/COMRESET (Test stimulus top, yellow. PUT response bottom, purple.)

Pass/Fail Criteria

- Device:
 - OOB-07a - Verification of COMINIT response at $459U_{IOB}$
 - OOB-07b - Verification of COMINIT response at $501U_{IOB}$
 - OOB-07c - Verification of no COMINIT response at $259U_{IOB}$
 - OOB-07d - Verification of no COMINIT response at $791U_{IOB}$

- Host:
 - OOB-07a - Verification of COMWAKE response at 459UI_{OOB}
 - OOB-07b - Verification of COMWAKE response at 501UI_{OOB}
 - OOB-07c - Verification of no COMWAKE response at 259UI_{OOB}
 - OOB-07d - Verification of no COMWAKE response at 791UI_{OOB}
- If any of the above cases fails, this is considered a failure by the product.

2.18. Port Multiplier Requirements (informative)

Devices used for testing Port Multipliers shall be limited to HDD type devices.

All tests in this section are intended to be run in a configuration based on a Port Multiplier Aware Host. A Port Multiplier Aware Host is defined by the two following characteristics:

1. A hardware platform in which at least one HBA (resident in the motherboard chipset or on a separate PCB) is capable of using non-zero values in the PM Port field in the FIS's it sends and receives.
2. An OS and OS device driver which will discover and enumerate any attached port multipliers during system initialization.

2.18.1. PM-01 : Device Port 0 Enabled by Default

2.18.1.1. Expected Behavior:

See sections 16.2 and 16.3.3.3 of Serial ATA Revision 2.6.

SATA 2.6 requires that a host system that has no explicit support for Port Multipliers shall work with a device connected to PM device port 0. In this configuration the PM is transparent to both host and device, with the exception of time required for a transmission from one end device to the other.

More specifically, a host system should be able to issue Soft Reset and all the commands used during a boot sequence to a device attached to PM port 0, with results identical to those obtained when the same device is directly attached to a SATA HBA.

For UTD 1.3 we will execute a series of representative commands. We will not actually boot a system in this test. Port Multiplier testing will require a modification to the UTD 1.2 System Interop test. Booting a non-PM aware system from a Port Multiplier port 0 device will be a part of the modified test.

Measurement Requirements

Attach a SATA HDD to port 0 of the PM. Apply power to the PM, the drive, and the host system.

to emulate host system that has no explicit support for Port Multipliers, issue Soft Reset to Port 0 of the port multiplier before starting the test sequence.

Execute the following ATA commands as defined in ATA-8_ACS_r4b:

1. IDENTIFY DEVICE
2. SET FEATURES with Features Register = 02h (Enable Write Cache) or a similarly benign Feature Register value.
3. WRITE DMA with one sector of nonzero data to LBA 0.
4. READ DMA from LBA 0.

Pass/Fail Criteria

- A correct HDD Signature FIS (34h) is received following power on, before the soft reset is issued.
- A correct HDD Signature FIS (34h) is received in response to the soft reset.
- All commands complete without error. Data read from LBA 0 is compared to the data written with no miscompares.

2.18.2. PM-02 : General Status and Control Register (GSCR) Access

2.18.2.1. Expected Behavior

See sections 16.4.1 of Serial ATA Revision 2.6.

GSCRs are accessed using the READ PORT MULTIPLIER and WRITE PORT MULTIPLIER commands with the PortNum field in the FIS27h Device field set to 15. The full range of register numbers addressable through these commands is 0 – 65535, however most are Reserved and only a handful are Mandatory. We use the Mandatory registers to verify that the GSCRs can be accessed.

Table 13 - Mandatory GSCRs

Register	Definition	Testable Contents
GSCR[0]	Product Identifier	None (contents are vendor specific)
GSCR[1]	Revision Information	Bits [7:4, 31:16] reserved, must be zero Bits [3:1] spec support level, at least one bit must be set Bit [0] must be zero
GSCR[2]	Port Information	Bits [31:4] reserved, must be zero. Bits [3:0] number of exposed ports, must contain some value 1 – 15.
GSCR[32]	Error Information	Bits [31:15] reserved, must be zero
GSCR[33]	Error Information Bit Enable	Default value = 0400FFFFh All bits may be set or cleared by WRITE PORT MULTIPLIER
GSCR[64]	Features Supported	Bits [31:5] reserved, must be zero. Bits [4:0] indicate features supported, not predictable
GSCR[96]	Features Enabled	Bits [31:4] reserved, must be zero. Bits [3:0] indicate features enabled. After power on, bits 0 & 2 shall be the same as bits 0 & 2 in GSCR[64] After power on, bits 1 & 3 shall be set to zero.

Measurement Requirements

- For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.
- Read each 32-bit register in the table above. It is recommended, but not required, that the information in these registers be formatted and displayed on the test output device.
- Write all ones to GSCR[33], then read back and check the contents.
- Write all zeros to GSCR[33], then read back and check the contents. Restore the default contents of the register.

Pass/Fail Criteria

- Port Multiplier Signature FIS returned following the soft reset.
- All READ PORT MULTIPLIER and WRITE PORT MULTIPLIER commands complete without error.
- Verify the contents of each register according to the table above. Some fields are vendor specific or feature dependent and will not be verified by this test.
- Verify that all bits in GSCR[33] can be set to zero and one.

2.18.3. PM-03 : Port Status and Control Register (PSCR) Access

2.18.3.1. Expected Behavior

See sections 16.4.2 and 14.1 of Serial ATA Revision 2.6.

Each device port in a Port Multiplier has a set of PSCRs associated with it. PSCRs are accessed using the READ PORT MULTIPLIER and WRITE PORT MULTIPLIER commands with the PortNum field in the FIS27h Device field set to the number of the port (range 0 – 14). The full range of register numbers addressable through these commands is 0 – 65535, however most are Reserved and only three are Mandatory. We use the Mandatory registers to verify that the PSCRs can be accessed.

The mandatory registers are defined identically to SATA SCR[0], [1], and [2] in a SATA HBA.

Table 14 - Mandatory PSCRs

Register	Definition	Testable Contents
PSCR[0]	SStatus	Bits [31:12] reserved, must be zero. Bits [3:0] DET field, must contain the value 4h following a Port Multiplier reset, except for device port 0 on a non-PM aware host system.
PSCR[1]	SError	None in this test. Bits may be set as a consequence of device activity but the host cannot set bits, only clear them.
PSCR[2]	SControl	Bits [31:20] reserved, must be zero Bits [19:4] none in this test. Bits [3:0] DET field, must contain the value 4h following a Port Multiplier reset, except for device port 0 on a non-PM aware host system.

Caution:

Some port multipliers contain a SATA Enclosure Management Bridge (SEMB) or that may be included in the count of exposed device ports in GSCR[2], bits [3:0]. For example, a port multiplier with 4 SATA device ports and 1 SEMB function could claim 5 ports in GSCR[2], bits [3:0]. Ports 0-3 could be SATA device ports and port 4 could be the SEMB.

In order to accurately determine the port configuration of a PM, the test must detect an SEMB or. This can be done by checking SStatus and a signature generated by the device.. There are two possible signatures for an SEMB, depending on whether an SEP is connected to the SEMB. These signatures are defined in section 13.11.4.1 of the SATA 2.6 spec. If an SEMB port is identified, that port should not be selected for any of the PM tests defined in this document.

Measurement Requirements

- Power cycle the port multiplier.
- For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.
- Using bits [3:0] of GSCR(2), determine how many device ports the Port Multiplier under test contains. See note at end of this test description.
- Connect a SATA device to one of the implemented device ports with a port number >0. On the selected device port, write 0001b to the DET field (Bits [3:0]) of PSCR(2), then write 0000b to the same location. This sequence requests that the port perform an interface communication initialization sequence, then progress to a PhyRdy state if a working device is attached.

Pass/Fail Criteria

- All READ PORT MULTIPLIER and WRITE PORT MULTIPLIER commands complete without error.

- Verify that the reserved fields in each PSCR for all implemented ports except 0 contain all zero. Verify that PSCR(2) Bits [3:0] for all implemented ports except 0 contain 4h.
- On the port with the attached SATA device, check the DET field in PSCR(0) and confirm that it contains 3h. This confirms that communication has been established, and indirectly confirms that the two WRITE PORT MULTIPLIER were correctly executed. (Note: it may be necessary to reset the X bit in PSCR1 before a READ PORT MULTIPLIER to PSCR0 will succeed.)

2.18.4. PM-04 : 3Gb/s Backwards Compatibility

2.18.4.1. Expected Behavior

See section 7.4.21.1.2 of Serial ATA Revision 2.6.

If a device claims support for Serial ATA Gen-2 signaling speed, 3Gb/s, (Word 76 bit 2 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data), then it shall also support Serial ATA Gen-1 signaling speed, 1.5Gb/s, (Word 76 bit 1 set to one in IDENTIFY DEVICE or IDENTIFY PACKET DEVICE data).

1. If the HBA supports only 1.5Gb/s signaling then a 3Gb/s capable port multiplier must negotiate for 1.5Gb/s operation on the host port. A compliant HBA can be forced to operate at Gen1-only speed through the SPD field of the SControl register in the HBA.
2. If a device supports only 1.5Gb/s signaling then a 3Gb/s capable port multiplier must negotiate for 1.5Gb/s operation on the device port. There is not a standard way to force a Gen2 device to operate at Gen1-only speed. For this test it will be necessary to either use a Gen1-only device or use a vendor unique method for restricting a Gen2 device to Gen1 speed.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

Determine the native speed of the PM host interface by enabling the attached HBA port for Gen2 speed and observing the negotiated speed after a COMRESET sequence. If the PM is limited to Gen1 speed, then skip this test, as 3Gb/s backward compatibility does not apply.

1. Attach a port multiplier to a host SATA port that is restricted to 1.5Gb/s. Force a COMRESET sequence on the host SATA port.
2. Attach a Gen1-only device to a port multiplier device port enabled for 3 Gb/s operation. Force a COMRESET sequence on the device port.

Pass/Fail Criteria

- Observe in the HBA SStatus register that the interface is Active and the negotiated speed is 1.5Gb/s.
- Observe in the PSCR SStatus register for the device port under test that the interface is Active and the negotiated speed is 1.5Gb/s.

2.18.5. PM-05 : Interface Power Management, H – PM, Host Initiated

2.18.5.1. Expected Behavior

See sections 14.1 and 16.3.3.6 of Serial ATA Revision 2.6.

A port multiplier is required to respond to PMREQ_P and PMREQ_S on its host port with either PMACK or PMNAK. Actual support of the low power link states is optional.

If a port multiplier responds to PMREQ_P and PMREQ_S on its host port with PMACK , then it required to propagate the request to all active device ports.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

- a) Determine whether low power modes are supported by the port multiplier.

Issue COMRESET from the HBA port to the host port of the PM and allow time for the sequence to complete. Verify that the H-PM interface is in active state.

Issue PMREQ_P to the device using the SPM field of the HBA SPM register or through a vendor specific method. Ensure that the H-PM interface goes to partial state. Issue COMWAKE and ensure that the H-PM interface goes to active state. If either of these conditions is not met, put out a message, "Host – PM interface failed HIPM partial test.

Issue PMREQ_S to the device using the SPM field of the HBA SPM register or through a vendor specific method. Ensure that the PM-Dev interface goes to slumber state. Issue COMWAKE and ensure that the PM-Dev interface goes to active state. If either of these conditions is not met, put out a message, "Host – PM interface failed HIPM slumber test.

If the partial and slumber tests above are successful, proceed with testing. If they are not successful, issue the message, "Link low power states not supported by port multiplier" and end test PM-05..

A host emulator/analyzer can also be used for these tests. Procedures are not documented here.

- b) PM propagates PMREQ to all active device ports.

Attach an HDD supporting HIPM to a device port.

Issue COMRESET to the PM host port and allow time for the sequence to complete.

Initialize the interface to the attached HDD. Verify that the device port interface is active.

Issue PMREQ_P to the PM host port.

Read the IPM field in the SStatus register in the selected device port and record the state of the device port interface. (Sending a FIS27h with the READ PORT MULTIPLIER command should generate a COMWAKE on the H-PM interface to allow communicating with the PM, without awakening the PM-Dev interface.)

Repeat this step, starting with COMRESET, sending PMREQ_S instead of PMREQ_P.

- c) PM partial state exit latency

Connect a bus analyzer to the H-PM interface. Start the analyzer. An oscilloscope or logic analyzer can be used instead.

Place the H-PM interface into partial state as described in step A.

Issue the COMWAKE OOB signal as described in step B.

Stop the bus analyzer or other device recording interface activity.

Record the time between the end of the COMWAKE burst from the host to the end of the ALIGN burst following the COMWAKE burst from the PM.

- d) PM slumber state exit latency

Connect a bus analyzer to the H-PM interface. Start the analyzer. An oscilloscope or logic analyzer can be used instead.

Place the H-PM interface into partial state as described in step A.

Issue the COMWAKE OOB signal as described in step B.

Stop the bus analyzer or other device recording interface activity.

Record the time between the end of the COMWAKE burst from the host to the end of the ALIGN burst following the COMWAKE burst from the PM.

One execution of step a) is required for this test.

Ten iterations each of steps b) and c) above are required for this test.

Pass/Fail Criteria

- a) Determine whether low power modes are supported by the port multiplier.

Informative only, not subject to pass/fail evaluation. May cause the rest of PM-05 to be skipped.

- b) PM propagates PMREQ to all active device ports.

Verify that the PM-Dev interface is in partial state following the first pass through this step and in slumber state following the second pass through this step. If both states are as expected, the test result is PASS. If either state is incorrect, the test result is FAIL.

- c) PM partial state exit latency.

Verify that the times recorded for this step are all 10 usec or less. If any time exceeds 10 usec, then the result of this test step is FAIL.

- d) PM slumber state exit latency.

Verify that the times recorded for this step are all 10 msec or less. If any time exceeds 10 msec, then the result of this test step is FAIL.

2.18.6. PM-06 : Interface Power Management, H - PM, PM Initiated

2.18.6.1. Expected Behavior

See sections 14.1 and 16.3.3.6 of Serial ATA Revision 2.6.

A port multiplier may optionally support issuing power management requests to the host (PIPM) when all device ports are in a low power state or disabled. This capability, if supported, may be enabled or disabled by writing to bit 1 of GSCR(96). There is no standard way to control which form of PMREQ is generated by a port multiplier.

There are three scenarios that can result in a PIPM request.

1. The last Active device port on the PM transitions to Disabled state as a result of the host writing 0100b to the DET field of the SControl register for that port.
2. The last Active device port on the PM transitions to Slumber or Partial state as the result of a HIPM request directed to the device on that port.
3. A DIPM request from the device attached to the last Active device port on the PM.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

Attach and power up an HDD to a PM device port with a port number >0.

- a) Verify that the port multiplier supports issuing PMREQ to the host.

Issue COMRESET from the HBA port to the host port of the PM and allow time for the sequence to complete. Check PM GSCR[64] bit 1.

If bit 1 = 0, skip the rest of PM-06 and put out a message, "Port multiplier does not support issuing PMREQ to the host."

If bit 1 = 1, set PM GSCR[96] bit 1 = 1.

- b) Verify that the PM issues a PMREQ when one of the three scenarios described above occurs.

All device ports should have been disabled by the COMRESET. This meets the requirement of scenario #1 above.

Wait 10 seconds. Check the state of the H-PM interface by reading the IPM field of the HBA SStatus register. If the interface is in partial or slumber state, continue to step c.

If the H-PM interface is still in active state, then initialize the interface to the attached HDD. Issue PMREQ_S to the attached HDD. This can be done by writing first 0010b, then 0000b, to the SPM field of the device port SControl field.

Wait 10 seconds. Check the state of the H-PM interface by reading the IPM field of the HBA SStatus register. If the interface is in partial or slumber state, continue to step c.

If the H-PM interface is still in active state, check that the drive supports DIPM (IDENTIFY DEVICE Word 78 Bit 3), enable the DIPM feature in the drive using the SET FEATURES command, then issue a STANDBY IMMEDIATE command to the attached HDD.

Wait 10 seconds. Check the state of the H-PM interface by reading the IPM field of the HBA SStatus register.

If the drive does not support DIPM or if none of these three scenarios has resulted in the H-PM interface entering partial or slumber state, put out a message for this subtest saying "Unable to generate a port multiplier initiated partial or slumber state on the host – PM interface." This condition will be recorded as N/A, not FAIL.

Pass/Fail Criteria

Test b) should be repeated 10 times.

- a) Verify that the port multiplier supports issuing PMREQ to the host.

Informative only, not subject to pass/fail evaluation. May cause the rest of PM-06 to be skipped.

- b) Verify that the PM issues a PMREQ when one of the three scenarios described above occurs.

If the H-PM interface enters partial or slumber state at least once, then the test result is PASS.

If the H-PM interface does not enter partial or slumber state at least once, then the test result is N/A.

2.18.7. PM-07 : Interface Power Management, PM - Dev, PM Initiated

2.18.7.1. Expected Behavior

See sections 16.3.3.6 of Serial ATA Revision 2.6.

On this interface the port multiplier device port is seen as a host port by the attached device. The device should respond to IPM requests and to COMWAKE as if it were directly attached to an HBA.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

- a) Verify that the device supports HIPM.

Attach an HDD to the selected device port. Initialize the PM-Dev interface.
This can be done through the DET field of the SControl register of the device port.

Issue an IDENTIFY DEVICE command to the device and check IDENTIFY DEVICE word 76 bit 9. If bit 9 = 1, then the device supports host (PM) initiated interface power management. Continue with the test.
If bit 9 = 0, then the device does not support HIPM. In that case, put out a message saying “The device does not support HIPM.” Skip the remainder of this test.

- b) Verify correct PM-initiated IPM behavior on the selected device port.

Initialize the PM-Dev interface. Ensure the interface is in the Active state.
Issue PMREQ_P to the device using the SPM field of the device port SPM register.
Ensure that the PM-Dev interface goes to partial state.
Issue COMWAKE and ensure that the PM-Dev interface goes to active state.
If any of these conditions is not met, put out a message, “PM-Dev interface failed HIPM partial test”.

Initialize the PM-Dev interface. Ensure the interface is in the Active state.
Issue PMREQ_S to the device using the SPM field of the device port SPM register.
Verify that the PM-Dev interface goes to slumber state.
Issue COMWAKE and ensure that the PM-Dev interface goes to active state.
If any of these conditions is not met, put out a message, “PM-Dev interface failed HIPM slumber test”.

Pass/Fail Criteria

Test b) should be repeated 10 times.

- a) Verify that the device supports HIPM.

Informative only, not subject to pass/fail evaluation. May cause the rest of PM-07 to be skipped.

- b) Verify correct PM-initiated IPM behavior on the selected device port.

If the interface state is correct at each verification point in all 10 iterations of this test, then the result is PASS.
If the interface is in an incorrect state at any verification point during the 10 iterations of this test then the result is FAIL.

2.18.8. PM-08 : Interface Power Management, PM - Dev, Dev Initiated

2.18.8.1. Expected Behavior

See sections 16.3.3.6 of Serial ATA Revision 2.6.

Device initiated interface power management requests should affect the PM-Dev link on which they are issued but should not affect the interface power state of other device ports or the H-PM interface.

There is no standard method to force a device to issue an IPM request, although devices with DIPM enabled will generally do so within 10 seconds after receiving a STANDBY IMMEDIATE command.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

a) Verify that the device supports DIPM

Connect an HDD to a device port in the port multiplier. Initialize the PM-Dev interface for that port and verify that the interface is in active state.

Check that the drive supports DIPM (IDENTIFY DEVICE Word 78 Bit 3 = 1), enable the DIPM feature in the drive using the SET FEATURES command, then issue a STANDBY IMMEDIATE command to the attached HDD. Wait 10 seconds.

Check the state of the PM-DEV interface by reading the IPM field of the PM device port SStatus register. If the interface is in partial or slumber state, proceed with this test. If the interface is still active after 10 repetitions of this step, then bypass the rest of this test and generate the message, "Unable to generate DIPM request. PM-08 skipped".

b) DIPM requests do not affect other device ports or the PM host port.

Leaving the HDD in step a) connected, connect a second HDD to a different device port. Do not enable DIPM on the second HDD.

Initialize both device interfaces. Ensure that the host H-PM interface and both PM-Dev interfaces are active. Enable DIPM in the first HDD and issue a STANDBY IMMEDIATE command to the first drive. Wait 10 seconds.

Record the states of the H-PM interface and both PM-Dev interfaces.

c) PM device port partial/slumber state exit latency

There is no standard way to cause a device to issue COMWAKE. This test step is a placeholder until a mechanism is defined to allow testing.

Pass/Fail Criteria

Test b) should be repeated 10 times.

a) Verify that the device supports DIPM

Informative only, not subject to pass/fail evaluation.

b) For each iteration of the test, if the H-PM interface and the second PM-Dev interface are active, and the first PM-Dev interface is in partial or standby state, then the result for this iteration is PASS. If either the H-PM interface or the second PM-Dev interface is in partial or slumber state, then the result for this iteration is FAIL. If all three interfaces are in active state, the result for this iteration is N/A.

Repeat test step b) 10 times. If there is at least one PASS result and no FAIL results, then the test result is PASS. If there is one or more FAIL results, then the test result is FAIL. If all 10 results are N/A, then the test result is N/A.

c) N/A

2.18.9. PM-09 : Speed matching upon resume (H-PM interface)

2.18.9.1. Expected Behavior

See section 8.4.3.2 of Serial ATA Revision 2.6.

The quoted statement below refers to the situation in which a port has received COMWAKE after entering partial or slumber state:

“Calibration and speed negotiation is bypassed since it has already been performed at power-on and system performance depends on quick resume latency. The device, therefore, shall transmit ALIGN_P primitives at the speed determined at power-on.”

In this case, the device refers to the host port of the port multiplier.

Measurement Requirements

- a) Verify that the H-PM interface running at default speed resumes at the default speed.

Check that the port multiplier supports interface power management using the steps in PM-05.

If the above is true, then run the following test

Note the current interface rate – determination of the current interface rate is MOI specific.
Issue PMREQ_P or PMREQ_S and confirm that the H-PM interface enters the appropriate low power state.
Issue COMWAKE and wait for complete wake of device
Record the current interface rate – determination of the current interface rate is MOI specific. For example, it may be obtained by reading the value in the SPD field of the device port SStatus register, or it may be observed directly through a hardware interface monitoring device.

Repeat this test 10 times.

- b) Verify that the H-PM interface running at reduced speed resumes at the reduced speed.

If the test methodology permits access to the HBA SATA status and control registers and the default rate on the H-PM interface is 3 Gb/s, then set the IPM field of the HBA SControl register to limit the interface speed to Gen1 speed. A vendor specific method may be used instead, if available.

Issue COMRESET. Confirm that the H-PM interface speed is 1.5 Gb/s. If the speed is 3 Gb/s, then skip this test step and put out a message, “Unable to force Gen1 speed on Gen2 host to port multiplier interface.”

If the current speed is 1.5Gb/s, issue PMREQ_P or PMREQ_S and confirm that the interface enters partial or slumber state, as appropriate.

Clear the interface speed restriction in the IPM field or vendor specific mechanism and issue COMWAKE.

Confirm that the interface state is active and record the current interface speed.

Repeat this test 10 times.

Pass/Fail Criteria

- a) Verify that the interface rate does not change before and after the power management sequence.

If the interface speed before and after a power management sequence is the same, the result is PASS. If the H-PM interface did not enter a low power state when requested or resumed at a different speed, then the result is FAIL. There is no N/A result for this test step.

If all 10 results are PASS, then the test result is PASS. If there is a single FAIL result, then the result for this

test is FAIL.

- b) Verify that the H-PM interface running at reduced speed resumes at the reduced speed.

If the interface speed before and after a power management sequence is the 1.5 Gb/s, the result is PASS. If the H-PM interface did not enter a low power state when requested or resumed at a different speed, then the result is FAIL. There is no N/A result for this test step.

If all 10 results are PASS, then the test result is PASS. If there is a single FAIL result, then the result for this test is FAIL.

2.18.10. PM-10 : Speed matching upon resume (PM-Dev interface)

2.18.10.1. Expected Behavior

See section 8.4.3.2 of Serial ATA Revision 2.6.

The quoted statement below refers to the situation in which a port has received COMWAKE after entering partial or slumber state:

“Calibration and speed negotiation is bypassed since it has already been performed at power-on and system performance depends on quick resume latency. The device, therefore, shall transmit ALIGN_P primitives at the speed determined at power-on.”

Measurement Requirements

- a) Verify that the PM-Dev interface running at default speed resumes at the default speed.
Check that the port multiplier supports interface power management using the steps in PM-05.

Attach an HDD supporting HIPM to a device port on the PM. Initialize the selected device port interface and verify that the interface is active.

Record the current interface speed. Determination of the current interface speed is MOI specific. For example, it may be obtained by reading the value in the SPD field of the device port SStatus register, or it may be observed directly through a hardware interface monitoring device.

Issue PMREQ_P and confirm that the PM-DEV interface enters partial state. (Note: PMREQ_P can be issued on the H-PM interface and be propagated by the PM to the PM-DEV interface, as described in PM-05, or PMREQ_P can be issued directly by the PM if the test method has access to the device port registers of the PM.)

Issue COMWAKE and wait for the PM-Dev interface to become active.

Record the current interface speed.

Repeat this test 10 times.

Issue PMREQ_S and confirm that the PM-DEV interface enters partial state. (Note: PMREQ_S can be issued on the H-PM interface and be propagated by the PM to the PM-DEV interface, as described in PM-05, or PMREQ_S can be issued directly by the PM if the test methodology permits access to the PM PSCRs.) Issue COMWAKE and wait for the PM-Dev interface to become active.

Record the current interface speed.

Repeat this test 10 times.

- b) Verify that the H-PM interface running at reduced speed resumes at the reduced speed.

If the test methodology permits access to the PM PSCRs and the default rate on the PM-Dev interface is 3 Gb/s, then set the IPM field of the PM port SControl register to limit the interface speed to Gen1 speed. A vendor specific method may be used instead, if available.

Issue COMRESET. Confirm that the PM-Dev interface speed is 1.5 Gb/s. If the speed is 3 Gb/s, then skip this test step and put out a message, "Unable to force Gen1 speed on Gen2 port multiplier to device interface."

If the current speed is 1.5Gb/s, issue PMREQ_P and confirm that the PM-DEV interface enters partial state. (See note in equivalent step in section a, above).

Issue COMWAKE and wait for the PM-Dev interface to become active.

Record the current interface speed.

Repeat this test 10 times.

Issue COMRESET. Confirm that the PM-Dev interface speed is 1.5 Gb/s. If the speed is 3 Gb/s, then skip this test step and put out a message, "Unable to force Gen1 speed on Gen2 port multiplier to device interface."

If the current speed is 1.5Gb/s, issue PMREQ_S and confirm that the PM-DEV interface enters slumber state. (See note in equivalent step in section a, above).

Issue COMWAKE and wait for the PM-Dev interface to become active.

Record the current interface speed.

Repeat this test 10 times.

Clear the interface speed restriction in the IPM field or vendor specific mechanism and issue COMRESET.

Confirm that the interface state is active and record the current interface speed.

Repeat this test 10 times.

Pass/Fail Criteria

- a) Verify that the PM-Dev interface running at default speed resumes at the default speed.

If the interface speed before and after each power management sequence (20 total) is the same, the result of the test step is PASS. If the PM-Dev interface did not enter a low power state when requested or resumed at a different speed, then the result of the test step is FAIL. There is no N/A result for this test step.

If all 10 PMREQ_P results are PASS, then the PMREQ_P test result is PASS. If there is a single FAIL result, then the result for this test is FAIL. Put out a message indicating a rate matching failure for PMREQ_P/COMWAKE sequence.

If all 10 PMREQ_S results are PASS, then the PMREQ_S test result is PASS. If there is a single FAIL result, then the result for this test is FAIL. Put out a message indicating a rate matching failure for PMREQ_S/COMWAKE sequence.

- b) Verify that the H-PM interface running at reduced speed resumes at the reduced speed.

If the interface speed before and after each power management sequence is 1.5 Gb/s, the result is PASS. If the H-PM interface did not enter a low power state when requested or resumed at a different speed, then the result is FAIL. There is no N/A result for this test step.

If all 10 PMREQ_P results are PASS, then the PMREQ_P test result is PASS. If there is a single FAIL result, then the result for this test is FAIL. Put out a message indicating a rate matching failure for PMREQ_P/COMWAKE sequence.

If all 10 PMREQ_S results are PASS, then the PMREQ_S test result is PASS. If there is a single FAIL result, then the result for this test is FAIL. Put out a message indicating a rate matching failure for PMREQ_S/COMWAKE sequence.

2.18.11. PM-11 : Port Multiplier Reset Response

2.18.11.1. Expected Behavior

Three types of SATA device reset events can be presented by a host to a port multiplier.

COMRESET OOB sequence:

A host initiated COMRESET has the following effect:

(From SATA 2.6, section 13.13.2.1)

- “1. Clear any internal state and reset all parts of the Port Multiplier hardware.
2. Place the reset values in all Port Multiplier registers, including port specific registers. The reset values shall disable all device ports.”

Expected behavior following COMRESET is defined by the port multiplier hot plug state machine. See SATA 2.6, section 16.3.3.5. PM behavior follows one of two sequences depending on whether the host sends a FIS to the Control Port (PM-aware host) or does not send a FIS to the Control Port within ≥ 10 msec (non-PM-aware host).

Soft Reset from Host to Control Port of PM:

The only action taken by a port multiplier that receives a soft reset directed to its control port is to return the unique port multiplier signature FIS, described in SATA 2.6, section 13.13.2.2

DEVICE RESET command received from the host by the Control Port of the PM:

This ATAPI command is treated as an unsupported command by port multipliers. The PM response should be a FIS34h with ERR and ABRT bits = 1. See SATA 2.6 16.3.3.8.6.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

COMRESET:

- 1) With no devices attached, force an interface initialization sequence between the host and the port multiplier host port. Check the contents of the mandatory GSCRs and PSCRs to ensure that they are set to their default values (including all device ports disabled).
- 2) With two devices attached, one to device port 0 and the other attached to a higher numbered supported port, force an interface initialization sequence between the host and the port multiplier host port. Wait 500msec. Verify that the port 0 SStatus register IPM field shows the link to be Active and the higher numbered port shows the link to be Disabled.
- 3) With at least one device attached to the PM, with its interface in Active state, issue a soft reset to the PM Control Port. A FIS 34h should be returned. The SATA link on the device port should remain Active.
- 4) Issue a DEVICE RESET command to the PM Control Port.

Pass/Fail Criteria

- All mandatory registers contain their default values.
- All mandatory PM registers except those for device port 0 contain their default values.
- The port multiplier signature FIS has the correct contents. The device port remains in Active state.

- The port multiplier returns a FIS 34h with ERROR and ABRT bits = 1.

2.18.12. PM-12 : Device Port 0 Hot Plug with non-PM aware host software.

2.18.12.1. Expected Behavior

When host software has no port multiplier support, it will not send a FIS to the PM Control Port under any circumstances. If device port 0 receives a COMINIT signal from an attached device, as will happen if a device is hot plugged, port 0 will complete the OOB sequence. The device is required to send a signature FIS34h at that point. If the PM has not detected any FIS transmissions from the host to the Control Port, it assumes legacy mode operation and forwards the signature FIS to the host. From the host perspective, this is identical to a device being hot plugged directly into a host port.

Measurement Requirements

With the port multiplier connected to the host system and no devices attached to the port multiplier, apply power to the host system and port multiplier. Do not access Port F of the port multiplier. This should ensure that PM port 0 is operating in legacy mode.

Connect a drive to device port 0 (drive power can be applied concurrently or beforehand).

Pass/Fail Criteria

- Correct signature FIS for an ATA disk drive is received by the host system.

2.18.13. PM-13 : Hot Plug with PM aware host software.

See section 16.3.3.5 and 16.3.3.10 of Serial ATA Revision 2.6.

2.18.13.1. Expected Behavior

All device ports except 0 operate only with PM-aware host software. If the host system sends a FIS to the port multiplier Control Port before device port 0 completes a COMRESET sequence, then device port 0 operates in this mode as well. The significant difference for test purposes is that a device port in "PM-aware" mode will not have a signature FIS propagated to the host system after a COMRESET sequence. Instead, the X bit in the SError register of the affected port will be set = 1.

By default, if any installed device port has its X bit set, a bit will be set in GSCR(32) indicating that condition. There is one bit per port and a mask selecting which bits in the device port SError registers will turn on the GSCR(32) bit for that port.

The X-bit in a device port SError register can only be set when the port is Active. Hot plugging a device into a port that has been, and remains, Disabled does not result in the X-bit for that port being set.

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

With the port multiplier connected to the host system and no devices attached to the port multiplier, apply power to the host system and port multiplier.

1) Reset all bits in the SError registers of device port 0 and a selected device port numbered >0. Reset all bits in GSCR(32).

Connect a drive to device port 0 (drive power can be applied concurrently or beforehand) to the selected device port numbered >0. Initialize the interfaces on these ports to the Active state.

2) Reset all bits in the SError registers of device port 0 and a selected device port numbered >0. Reset all bits in GSCR(32).

Disable the SATA interface on these 2 ports by writing 0100b to the DET field of the respective SControl registers.

Connect a drive to device port 0 (drive power can be applied concurrently or beforehand) to the selected device port numbered >0. Do not initialize the interfaces of these two ports.

Pass/Fail Criteria

- 1) Read the SError register for device port 0 and verify that bit 26 = 1 (this is the X bit for device port 0). For the selected device port numbered >0, check that the corresponding bit number in GSCR(32) = 1. (E.g., if the selected device port is 5, then check bit 5). Verify that bit 26 in the SError register for the device port being tested = 1.
- 2) For test step 2, above, verify that the X-bit is cleared in the SError registers of both device ports and that the GSCR(32) bits corresponding to the two ports = 0.

2.18.14. PM-14 : FIS Sent To a Disabled Device Port.

See section 16.3.3.8.2 of Serial ATA Revision 2.6.

2.18.14.1. Expected Behavior

When a port multiplier receives a FIS from the host system directed to a device port that is disabled, it should not respond with either R_OK or R_ERR. Instead, it should send a SYNC primitive to the host system, terminating the FIS transfer.

There is no standard way for host software to know that the HBA has received SYNC from the PM. I expect the usual result will be a command timeout in host software. (Verify this on real hardware.)

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

Install a SATA analyzer on the link between HBA and port multiplier. Install a drive on one of the device ports and initialize the interface. Verify that the drive can execute an IDENTIFY DEVICE command correctly.

In addition to performing the tests below through a host system with a SATA HBA, the tests can also be performed by using a SATA emulator/analyzer in place of the host system and HBA.

- 1) Disable the interface to the attached drive by writing 4h to the DET field of the SControl register of the port where the drive is attached. Issue an IDENTIFY DEVICE command to the attached device. Observe whether the command completes successfully. Capture a trace of the interface activity when the command is issued.
- 2) Enable the device port to which the test drive is attached. Verify that the drive can execute an IDENTIFY DEVICE command correctly. Unplug and replugin drive power (simulated hot plug). This should set the X bit for this device port and block FIS transfers to and from the port until the X bit is cleared. Issue an IDENTIFY DEVICE command to the attached device. Observe whether the command completes successfully after the simulated hot plug. Capture a trace of the interface activity when the command is issued.

Pass/Fail Criteria

- 1) Verify that the command did not complete successfully. Verify by examining the interface trace from the analyzer that the PM responded to the command FIS with one or more SYNC primitives.
- 2) Verify that the command after the simulated hot plug did not complete successfully. Verify by examining the interface trace from the analyzer that the PM responded to the command FIS with one or more SYNC primitives. Read the SError register of the device port and verify that the X bit, bit 26, = 1.

2.18.15. PM-15 : FIS Sent To a Invalid Device Port Address.

See section 16.3.3.8.3 of Serial ATA Revision 2.6.

2.18.15.1. Expected Behavior

When a port multiplier receives a FIS from the host system directed to a device port that is beyond the range of supported port numbers, it shall not respond with either R_OK or R_ERR. Instead, it shall send a SYNC primitive to the host system, terminating the FIS transfer.

This test does not apply to a port multiplier that supports the full range of allowable device port numbers, 0-14.

There is no standard way for host software to know that the HBA has received SYNC from the PM. I expect the usual result will be a command timeout in host software. (Verify this on real hardware.)

Measurement Requirements

For setup consistency, issue Soft Reset to Port F of the port multiplier before starting the test sequence.

Install a SATA analyzer on the link between HBA and port multiplier. Install a drive on the highest numbered device port and initialize the interface. Verify that the drive can execute an IDENTIFY DEVICE command correctly.

Issue an IDENTIFY DEVICE command to a port address greater than the highest numbered port on the PM. Observe whether the command completes successfully. Capture a trace of the interface activity when the command is issued.

Pass/Fail Criteria

- Verify that the command did not complete successfully. Verify by examining the interface trace from the analyzer that the PM responded to the command FIS with one or more SYNC primitives.

2.18.16. PM-16 : Test For PM-aware Host

See section 13.13.3.1 of Serial ATA Revision 2.6.

Port Multiplier aware software checks the host's SStatus register to determine if a device is connected to the port. If a device is connected to the port, the host then issues a software reset to the control port. If the Port Multiplier signature is returned, then a Port Multiplier is attached to the port. Then the host proceeds with enumeration of devices on Port Multiplier ports as detailed in section 13.13.4.2.

2.18.16.1. Expected Behavior

Following system power on, a PM-aware host will issue Soft Reset to the control port address, Fh, and wait for the specific signature FIS of a port multiplier. This is in contrast to a non-PM-aware host, which is not aware of PM port address Fh and which waits for a signature FIS from a direct attached device.

After determining that a port multiplier is attached, the PM-aware host should enumerate the PM ports and discover any attached devices. The exact sequence of events on the host port after the PM signature FIS is implementation specific and is not detailed here.

Measurement Requirements.

With a SATA analyzer connected between the designated HBA port and the PM host port, program the analyzer to capture all FIS transfers. Start the analyzer.

Power up the host system and the port multiplier. If the port multiplier is powered by a separate power supply, then power up the port multiplier before turning on the host system being tested.

After the host OS is fully loaded and initialized, stop the analyzer.

Pass/Fail Criteria

- In order for the host to be designated PM-aware, the trace must show a soft reset addresses to the control port of the port multiplier.
- A soft reset consists of two consecutive Register Host -> Device FISes sent by the host. The first must have the C bit = 0 and Control register bit 2 = 1. The second must have the C bit = 0 and Control register bit 2 = 0. In both FIS's the PM Port field must = Fh.

- If the port multiplier is working properly, it should send a Register Device -> Host FIS containing the port multiplier signature as defined in SATA 2.6, 13.3.2.2 after the soft reset completes.

3. System Interoperability Tests

The system interoperability tests are required tests above and beyond the tests described in the preceding sections of the document. This testing is required for the Device product type. No System Interoperability testing is required for Cable products.

3.1. System Description

The test systems used for the system interoperability testing must be configured in such a way to confidently provide test capabilities to ensure interoperability of a Serial ATA product within that platform. The products and configuration information for the test platforms are defined in the following sections.

A total of 5 different system configurations will be defined for usage in the system interoperability testing. It is required that all 5 configurations are used in verification of all SATA products under test (PUT) (i.e. hosts, devices).

3.1.1. System Product Selection

An approved list of products suitable for system interoperability test use will be created by SATA-IO for use at Interop Workshops and independent test labs.

For the Interoperability Program, a system is defined as having the following components:

- Host
- Device
- Cable – not applicable for direct attached systems (e.g. mobile)

Only one PUT shall be tested in a system at a time.

Only the products approved by the SATA-IO may be used in the platform configurations for system interoperability testing.

The following sections define the non-PUT component requirements.

3.1.2. System Interoperability non-PUT Cable requirements

For all system interoperability tests the cables used must be selected from the Integrators List as already approved products and are limited to non-latching straight-straight solutions which are 1 meter in length.

3.1.3. System Interoperability Host Requirements for Device testing

The following platform configurations will be used for all device product testing with regards to system interoperability testing.

- Configuration 1 : Intel SATA Gen2 based system (E.g.: Intel ICH7):
 - Dell 9150 or HP DC7600 CMT – Internal graphics, no add-in cards
- Configuration 2 : Intel SATA Gen1 based system (E.g.: Intel ICH6):
 - HP DC5100 or DX6120 micro Tower
- Configuration 3 : AMD/ATI SATA Gen1 based system (E.g.: ATI SB400):
 - HP DX5150 micro tower or SFF (same system board), internal graphics, no add-in cards
- Configuration 4 : Nvidia SATA Gen2 based system (E.g.: nForce4)
 - HP xw9300 workstation
- Configuration 5 : SATA Gen2 HBA (E.g.: Silicon Image 3132-based PCIe SATA):
 - Host system with a PCIe slot and either a LyCOM PE-103R5 or Addonics AD2SA3GPX1 host controller

For device product testing, the host controllers used in the configurations must either be those identified above, or selected from the Integrators List as already approved products. A substitution of a host product from the Integrators List may only be a substitution of a product from the same SATA interface vendor (e.g. replacement in Configuration #3 with an approved ATI host product from the Integrators List, or replacement in Configuration #4 with an approved Nvidia host product from the Integrators List).

The configurations are based on requirements around SATA specific capabilities and combinations (e.g. 3Gb/s, 1.5Gb/s, different host controllers, etc...). It is also required that the motherboards or hosts considered for this testing support INT 13h mechanisms.

The SATA-IO will consider updating the approved platform configurations approximately every 12-18 months, depending on necessity.

3.1.4. System Interoperability Device Requirements for Host testing

The following configuration details will be used for all host product testing with regards to system interoperability testing.

- Configuration 1 : Gen2 hard disk drive (HDD) selected from Integrators List
- Configuration 2 : Gen2 hard disk drive (HDD) selected from Integrators List (must be different model from that selected in Configuration #1 above)
- Configuration 3 : Gen1 hard disk drive (HDD) selected from Integrators List (must be different model from those selected in Configuration #1 and #2 above)
- Configuration 4 : Gen1 optical disk drive (ODD) selected from Integrators List
- Configuration 5 : Gen1 optical disk drive (ODD) selected from Integrators List (must be different model from that selected in Configuration #4 above)

For host product testing, the devices used in the configurations must be selected from the Integrators List as already approved products.

The configurations are based on requirements around SATA specific capabilities and combinations (e.g. 3Gb/s, 1.5Gb/s, different devices, etc...). It is also required that the motherboards or hosts considered for this testing support INT 13h mechanisms.

If a host PUT does not support a device product type:

- 1) The non-supported device type shall be indicated on the Product Info sheet. Failure to indicate non-support with a failure on a non-supported device still results in a System Interop failure
- 2) Additional devices from the support device types shall be substituted for the non-support product type to maintain the required number of configurations
- 3) Non-supported device types shall be indicated if the product is added to the Integrators List.

The SATA-IO will consider updating the approved platform configurations approximately every 12-18 months, depending on necessity.

3.2. System Interoperability Test Description

There are several key concerns when working to understand the interoperability of a product in a specified system, including data transfer and error rates. The system interoperability tests are defined in a way such that the products are validated in a repeatable and consistent manner.

3.2.1. Resource requirements

The following tools will be needed to validate the System Interoperability test tool:

- 1) SATA bus analyzer capable of acquiring traces for all supported product types and capturing both data level and command level traces
- 2) SATA bus error injector capable of causing a data corruption error in a DATA FIS

3.2.2. SYS-01: System Interoperability Test Requirements

3.2.2.1. Data Pattern

The data pattern used by System Interoperability test shall exactly reproduce the Long COMP pattern on the SATA interface. The host typically scrambles and encodes the data before it is transmitted on the SATA interface. The source data pattern shall be designed to take this into consideration such that the Long COMP pattern is still presented on the SATA interface.

3.2.2.2. FIS Alignment and size

The System Interoperability test shall present (for writes) or request (for reads) the first byte of each data pattern be the first byte of a data FIS. Subsequent data FIS alignment is highly suggested but not required. Usage of 8KB data FISs is highly suggested but not required. The reason is the Long COMP data pattern is 8KB and 8KB FIS usage keeps the designed pre-disparity pre-scrambling intact.

3.2.2.3. Serror and Sstatus host registers

The System Interoperability test should monitor, if possible, the host Serror and Sstatus registers.

- SERROR: If any bit in the Serror register (Bit W shall be excluded), it shall be counted as an error and cleared.
- SSTATUS: Any change on the Sstatus:SPD bits shall be counted as an error.

3.2.2.4. Data Pattern sizes

The data pattern shall use all of the following pattern sizes in the prescribed combination. The 8 KB (Kilo Bytes) data pattern is one complete Long COMP data pattern as defined above. Each additional pattern size is defined as exact repeating multiples of the 8 KB data pattern. Each size represents a binary value NOT a decimal value (i.e. 8 KB = 8 * 1024 = 8192 Bytes, 1 MB = 1 * 1024 * 1024 = 1048576 Bytes)

- 8 KB
- 64 KB
- 256 KB
- 1 MB
- 16 MB

The purpose of using multiple size files is to strike a balance between guaranteed being 8 KB FIS aligned and increased data throughput that is gained with larger file sizes. In addition, the smaller file sizes have a high likelihood of being cached on many products, and thus achieving higher burst transfer rates, whereas the larger files increase the devices media access interactions

3.2.2.5. Host caching and retries

The System Interoperability test must be configured such that:

- 1) No host caching of data is performed. All transfer requests shall be presented on the SATA interface.
- 2) The host is only allowed to retry non-data FIS's without notification to the test tool
- 3) The host shall NOT retry data without notification to the test tool

3.2.2.6. Data file signatures

Each data file shall have a stored industry standard 128-bit MD5 signature that shall be used for data validity verification. The test tool shall use MD5 signatures supplied by the SATA-IO.

3.2.2.7. HDD Data Pattern set

For a HDD PUT a single data pattern set is defined as follows:

1. 8 KB file - 40 generational copies, last file signature verified
2. 64 KB file – 40 generational copies, last file signature verified
3. 256 KB file – 40 generational copies, last file signature verified
4. 1 MB file – 40 generational copies, last file signature verified
5. 16 MB file – 40 generational copies, last file signature verified

A generational copy is defined as follows:

1. First read of the copy, comes from the original data source, not the PUT
2. The first write, using the data from the first read is written to the PUT
3. The second read comes from the first write data on the PUT
4. The second write comes from the second read, but writes to a 2nd file location on the PUT
5.
6. The 39th read comes from the 38th write data on the PUT
7. The 40th write comes from the 39th read on the PUT, but writes to the 40th file location on the PUT.
8. The 40th read comes from reading the file on the PUT to generate the MD5 signature for comparison.

3.2.2.8. ATAPI Data Pattern set

For a ATAPI PUT a single data pattern set is defined as follows:

1. 8 KB file – read and signature verified 40 times
2. 64 BK file – read and signature verified 40 times
3. 256 KB file – read and signature verified 40 times
4. 1 MB file – read and signature verified 40 times
5. 16 MB file – read and signature verified 40 times

3.2.2.9. Test duration

The System Interoperability test shall repeat the data pattern set until a minimum of 9 minutes of execution time has been reached for each of the required configurations with error checking continuously enabled.

3.2.2.10. Stop on Error

The System Interoperability test may stop on first error or count/indicate error and continue to complete the test duration.

3.2.3. System Interop Pass / Fail Criteria

- The test tool shall count and report each data error (retried or not)
- One or more data errors fails that that configuration and no time or transfer size shall be reported
- A product under test must pass a minimum of 4 of the 5 configurations

Table 15 – System Interop Test Name matrix

	Loops or errors	# MBi (1024 * 1024 bytes)	Time (sec)
Config 1	SYS-01a	SYS-01b	SYS-01c
Config 2	SYS-01a	SYS-01b	SYS-01c
Config 3	SYS-01a	SYS-01b	SYS-01c
Config 4	SYS-01a	SYS-01b	SYS-01c
Config 5	SYS-01a	SYS-01b	SYS-01c

3.3. System Interoperability Test Tool Validation requirements

A certified System Interoperability test tool (test tool) shall be validated on all applicable hosts (maximum of 3 different hosts is required, more is allowed), using a minimum of 3 device products from each supported device type.

See section 3.2.2.4 for data pattern size definitions

3.3.1. SYT-01 – Data pattern validation

3.3.1.1. Device Expected Behavior

The test tool shall present the 8KB Long COMP data pattern on the SATA interface.

Measurement Requirements

- While reading a single 8KB Long COMP data pattern file:
 - With a SATA bus analyzer validate Long COMP data pattern is correct and complete
 - Generate a MD5 checksum while the data file is being read

Pass/Fail Criteria

- PASS if all of the following are true, otherwise FAIL:
 - The 8 KB Long COMP data pattern is verified to be correct and complete.
 - The MD5 signature must match the SATA-IO Logo published MD5 signature

3.3.2. SYT-02 – Data pattern alignment

3.3.2.1. Device Expected Behavior

The test tool shall present the first DWord of the Long COMP data pattern as the first Dword of a DATA FIS on the SATA interface.

Measurement Requirements

- Using the 8 KB Long COMP data pattern, with a SATA bus analyzer, with complete data capture, validate the first DWord of the Long COMP data pattern is the first Dword of a DATA FIS on the SATA interface for a minimum of 3 consecutive data patterns

Pass/Fail Criteria

PASS if the first Dword of the DATA FIS matches and aligns with the first Dword of the 8KB Long COMP data pattern, otherwise FAIL.

3.3.3. SYT-03 – 8 KB Data FIS usage

3.3.3.1. Device Expected Behavior

The test tool should present the 8 KB data pattern as a single 8 KB DATA FIS on the SATA interface. Only applicable if test tool supports HDD Device type.

Measurement Requirements

- Using the 8 KB data pattern on a HDD, with a SATA bus analyzer validate the 8 KB data pattern is completely contained in a 8 KB DATA FIS on the SATA interface a minimum of 3 consecutive data patterns

Pass/Fail Criteria

PASS if for 3 consecutive DATA FIS all of the following are true, otherwise FAIL:

- Each data FIS contains exactly 8KB of data
- Each data FIS matches the Long COMP data pattern

3.3.4. SYT-04 – Data error detection

3.3.4.1. Device Expected Behavior

The test tool shall detect any SATA DATA error.

TBD: Add retries section

Measurement Requirements

- Using an error injection tool, change the data in the data FIS to cause a CRC error in the DATA FIS

Pass/Fail Criteria

- The test tool shall detect, report, and indicate failure upon the receipt of a single error even if the transfer is retried.

3.3.5. SYT-05 – Complete Data set, including Host caching and retries

The test tool shall demonstrate that a complete (no missing or additional data) and proper data set is transferred, including no host caching is being performed

Measurement Requirements

- With a bus analyzer demonstrate a complete (no missing or additional) data pattern set for each device type is transferred on the SATA bus for each test tool request. Traces that filter the user data, but still indicate the FIS structure are acceptable. Reads of non-data set (file system reads) are allowed, but should be minimized

Pass/Fail Criteria

- A complete data pattern set for each device type is transferred on the SATA bus for each test tool request.
- Any additional data files will indicate a fail (i.e. reading the data for the copy and reading the same data for signature generation is a tool failure).

3.3.6. SYT-06 - Data file signatures

The test tool shall provide documentation (signature file or code snippet with MD5 signatures) showing only the SATA-IO Logo MD5 data file signatures are used for data integrity validation.

Pass/Fail Criteria

- All MD5 signatures used must match the SATA-IO Logo MD5 signatures

3.3.7. SYT-07 - Data Pattern set

The test tool shall provide documentation showing the proper data pattern set is used for all supported device types.

Pass/Fail Criteria

- Provide log files or test code showing the proper data pattern set is used for each supported device type

3.3.8. SYT-08 - Test duration

The test tool shall demonstrate on one supported device type and provide documentation for all other supported device types showing the tests executed for a minimum of 9 minutes for all supported device types.

Pass/Fail Criteria

- For each of the supported device types, provide time stamped log files (with embedded starting and end times) showing a minimum of 9 minute execution time.

3.3.9. SYT-09 – System Configuration

The test tool must support all possible system configurations and only the test tool generated traffic shall be sent/received to/from the PUT.

The OS can NOT access the PUT once the test has begun (i.e. the swap file can not be on the PUT).

Test tool code may be located on the PUT as long as it is completely loaded from the PUT before the test is started and all accesses to the PUT are the previously defined System Interop Framed COMP pattern until the test is complete.

All log files shall be written to a non-PUT media or stored in RAM until all tests are complete.

Pass/Fail Criteria

- Command level bus traces showing only Framed COMP pattern transfers for the complete test period.

3.3.10. SYT-10 – OS Install

All test tool validation shall be performed after the OS has been installed. If the OS is installed on the PUT, then the validation shall be done on every PUT (i.e. the OS and driver combination used during test tool validation shall be the same as that used during the PUT validation). If any OS or driver updates are made, the test tool is required to be re-validated. No OS or driver updates are allowed between tool validation and PUT validation.

Pass/Fail Criteria

- Directory of PUT showing no operating system files or

Logs from test tool validation and the PUT validation showing the OS/drivers are identical (MD5 signatures of critical files are one such way)

4. Framed COMP Pattern

See SATA Standard 2.6, ECN 009 “Long FRAMED COMP Pattern”

This section defines the framed version of the COMP pattern, for use in RSG and Interoperability testing. The pattern has been specifically created to satisfy all of the following design criteria:

- Properly framed version of the COMP pattern. (SOF/HEADER/CRC/EOF)
- Contains leading X_RDY and trailing WTRM/SYNC/CONT primitives to maintain framing protocol consistency.
- Maintains running disparity. (Pattern begins and ends with the same running disparity, so that when it is transmitted continuously, the Monitoring Tool does not detect the leading SOF as a Running Disparity error.)
- Maintains desired ALIGN count and spacing. (First 2 Dwords are ALIGN out of every group of 256 Dwords.)
- Maintains ALIGN spacing upon wrapping. (Requires total pattern length to be an even multiple of $40 \times 256 = 10240$ bits. $92160 = 9 \times 10240$.)
- Overall pattern length is even multiple of 128/256/512 bits, for broad compatibility with known pattern generators.

Note that this pattern has been specifically designed for SATA-IO test purposes. **Any deletion/insertion of data, or other modification to the exact bit sequence will render the pattern invalid for the purposes of r1.3 SATA-IO RSG testing.**

Also note that the raw bit pattern is provided in an external .txt file, which may be downloaded from the SATA-IO website.)

4.1. SATA 2.6 ECN 009 Long FRAMED COMP Pattern

```
1: +K28.5- BC 1100000101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D27.3+ 7B 1101100011 ALIGN
    (Repeat previous Dword until)
3: +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101
    (Repeat previous Dword until)
10: +K28.3- 7C 1100001100 -D21.5- B5 1010101010 -D23.2+ 57 1110100101 +D23.2- 57 0001010101 X_RDY
11: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D23.2- 57 0001010101 -D23.2+ 57 1110100101 X_RDY
12: +K28.3- 7C 1100001100 -D21.5- B5 1010101010 -D23.2+ 57 1110100101 +D23.2- 57 0001010101 X_RDY
13: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D23.2- 57 0001010101 -D23.2+ 57 1110100101 X_RDY
14: +K28.3- 7C 1100001100 -D21.5- B5 1010101010 -D23.2+ 57 1110100101 +D23.2- 57 0001010101 X_RDY
15: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D23.1- 37 0001011001 -D23.1+ 37 1110101001 SOF
16: +D11.6+ CB 1101000110 +D22.3+ 76 0110100011 +D18.6+ D2 0100110110 + D2.6- C2 0100100110
17: -D31.3+ 7F 1010110011 +D31.3- 7F 0101001100 -D31.3+ 7F 1010110011 +D31.3- 7F 0101001100
    (Repeat previous Dword until)
257: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
    (Repeat previous Dword until)
259: -D31.3+ 7F 1010110011 +D31.3- 7F 0101001100 -D31.3+ 7F 1010110011 +D31.3- 7F 0101001100
    (Repeat previous Dword until)
275: -D21.5- B5 1010101010 -D21.5- B5 1010101010 -D21.5- B5 1010101010 -D21.5- B5 1010101010
    (Repeat previous Dword until)
339: -D24.3+ 78 1100110011 +D24.3- 78 0011001100 -D24.3+ 78 1100110011 +D24.3- 78 0011001100
    (Repeat previous Dword until)
403: -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101
    (Repeat previous Dword until)
467: -D25.6- D9 1001100110 - D6.1- 26 0110011001 -D25.6- D9 1001100110 - D6.1- 26 0110011001
    (Repeat previous Dword until)
513: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
    (Repeat previous Dword until)
515: -D25.6- D9 1001100110 - D6.1- 26 0110011001 -D25.6- D9 1001100110 - D6.1- 26 0110011001
    (Repeat previous Dword until)
533: -D17.7+ F1 1000110111 +D30.7+ FE 1000011110 + D7.1+ 27 0001111001 +D14.7- EE 0111001000
534: -D30.7- FE 0111100001 - D7.6- C7 1110000110 -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100
```

```

535: -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100 -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100
      (Repeat previous Dword until)
769: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
      (Repeat previous Dword until)
771: -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100 -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100
      (Repeat previous Dword until)
1025: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
      (Repeat previous Dword until)
1027: -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100 -D30.3+ 7E 0111100011 +D30.3- 7E 1000011100
      (Repeat previous Dword until)
1048: - D3.7+ E3 1100011110 +D28.7- FC 0011100001 - D3.7+ E3 1100011110 +D28.7- FC 0011100001
1049: -D12.0+ 0C 0011011011 +D11.4- 8B 1101000010 -D12.0+ 0C 0011011011 +D11.3+ 6B 1101000011 LBPharvey
1050: +D12.0- 0C 0011010100 -D11.4+ 8B 1101001101 +D12.0- 0C 0011010100 -D11.3- 6B 1101001100 LBPharvey
      (Repeat previous ***2 Dwords*** until)
1281: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
      (Repeat previous Dword until)
1283: -D12.0+ 0C 0011011011 +D11.4- 8B 1101000010 -D12.0+ 0C 0011011011 +D11.3+ 6B 1101000011 LBPharvey
1284: +D12.0- 0C 0011010100 -D11.4+ 8B 1101001101 +D12.0- 0C 0011010100 -D11.3- 6B 1101001100 LBPharvey
      (Repeat previous ***2 Dwords*** until)
1307: -D20.2- 54 0010110101 -D20.2- 54 0010110101 -D20.2- 54 0010110101 -D20.2- 54 0010110101
      (Repeat previous Dword until)
1537: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
      (Repeat previous Dword until)
1539: -D20.2- 54 0010110101 -D20.2- 54 0010110101 -D20.2- 54 0010110101 -D20.2- 54 0010110101
      (Repeat previous Dword until)
1564: -D20.2- 54 0010110101 -D20.7+ F4 0010110111 +D11.5+ AB 1101001010 +D11.5+ AB 1101001010
1565: +D11.5+ AB 1101001010 +D11.5+ AB 1101001010 +D11.5+ AB 1101001010 +D11.5+ AB 1101001010
      (Repeat previous Dword until)
1793: +K28.5- BC 1100000101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D27.3+ 7B 1101100011 ALIGN
      (Repeat previous Dword until)
1795: +D11.5+ AB 1101001010 +D11.5+ AB 1101001010 +D11.5+ AB 1101001010 +D11.5+ AB 1101001010
      (Repeat previous Dword until)
1822: +D11.5+ AB 1101001010 +D11.7- EB 1101001000 -D20.2- 54 0010110101 -D20.2- 54 0010110101
1823: -D21.5- B5 1010101010 -D21.5- B5 1010101010 -D21.5- B5 1010101010 -D21.5- B5 1010101010
      (Repeat previous Dword until)
1887: -D24.3+ 78 1100110011 +D24.3- 78 0011001100 -D24.3+ 78 1100110011 +D24.3- 78 0011001100
      (Repeat previous Dword until)
1951: -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101 -D10.2- 4A 0101010101
      (Repeat previous Dword until)
2015: -D25.6- D9 1001100110 - D6.1- 26 0110011001 -D25.6- D9 1001100110 - D6.1- 26 0110011001
      (Repeat previous Dword until)
2049: -K28.5+ BC 0011111010 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D27.3- 7B 0010011100 ALIGN
      (Repeat previous Dword until)
2051: -D25.6- D9 1001100110 - D6.1- 26 0110011001 -D25.6- D9 1001100110 - D6.1- 26 0110011001
      (Repeat previous Dword until)
2081: -D11.6- CB 1101000110 -D18.6- D2 0100110110 -D29.6+ DD 1011100110 + D6.4- 86 0110010010
2082: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D21.6+ D5 1010100110 +D21.6+ D5 1010100110 EOF
2083: +K28.3- 7C 1100001100 -D21.5- B5 1010101010 -D24.2+ 58 1100110101 +D24.2- 58 0011000101 WTRM
2084: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D24.2- 58 0011000101 -D24.2+ 58 1100110101 WTRM
2085: +K28.3- 7C 1100001100 -D21.5- B5 1010101010 -D24.2+ 58 1100110101 +D24.2- 58 0011000101 WTRM
2086: -K28.3+ 7C 0011110011 +D21.5+ B5 1010101010 +D24.2- 58 0011000101 -D24.2+ 58 1100110101 WTRM
2087: +K28.3- 7C 1100001100 -D21.4+ 95 1010101101 +D21.5+ B5 1010101010 +D21.5+ B5 1010101010 SYNC
      (Repeat previous Dword until)
2089: +K28.3- 7C 1100001100 -D10.5- AA 0101011010 -D25.4+ 99 1001101101 +D25.4- 99 1001100010 CONT
2090: -K28.3+ 7C 0011110011 +D10.5+ AA 0101011010 +D25.4- 99 1001100010 -D25.4+ 99 1001101101 CONT
2091: +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101
      (Repeat previous Dword until)
2304: +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101 +D10.2+ 4A 0101010101

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